



ANSI C63.19

TEST REPORT

Product Name	HSUPA/HSDPA/UMTS triband/GSM quadband mobile phone
Model Name	Megane 1SIM AWS TMO
Marketing Name	ONE TOUCH 5020T
FCC ID	RAD393
Client	TCT Mobile Limited
Manufacturer	TCT Mobile Limited
Date of issue	August 22, 2013

TA Technology (Shanghai) Co., Ltd.

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GENERAL SUMMARY

Reference Standard(s)	ANSI C63.19-2007: American National Standard Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.
Conclusion	This portable wireless equipment has been measured in all cases requested by the relevant standards. General Judgment: M3 (RF Emission)
Comment	The test result only responds to the measured sample.

Approved by 杨伟中
Director

Revised by 凌敏定
HAC Manager

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1. General Information

1.1. Notes of the Test Report

TA Technology (Shanghai) Co., Ltd. has obtained the accreditation of China National Accreditation Service for Conformity Assessment (CNAS), and accreditation number: L2264.

TA Technology (Shanghai) Co., Ltd. guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

TA Technology (Shanghai) Co., Ltd. is liable to the client for the maintenance by its personnel of the confidentiality of all information related to the items under test and the results of the test. This report only refers to the item that has undergone the test.

This report standalone dose not constitute or imply by its own an approval of the product by the certification Bodies or competent Authorities. This report cannot be used partially or in full for publicity and/or promotional purposes without previous written approval of **TA Technology (Shanghai) Co., Ltd.** and the Accreditation Bodies, if it applies.

If the electrical report is inconsistent with the printed one, it should be subject to the latter.

1.2. Testing Laboratory

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1.3. Applicant Information

Company: TCT Mobile Limited
Address: 12F/B, TCL Tower, Gaoxin Nanyi Road, Nanshan District, Shenzhen, Guangdong,
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City: Shenzhen
Postal Code: 518057
Country: P.R. China

1.4. Manufacturer Information

Company: TCT Mobile Limited
Address: 12F/B, TCL Tower, Gaoxin Nanyi Road, Nanshan District, Shenzhen, Guangdong,
P.R. China. 518057
City: Shenzhen
Postal Code: 518057
Country: P.R. China

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1.5. Information of EUT

General Information

Device Type:	Portable Device		
Exposure Category:	Uncontrolled Environment / General Population		
State of Sample:	Prototype Unit		
Product IMEI:	013778000001756		
Hardware Version:	PIO4		
Software Version:	SWL27		
Antenna Type:	Internal Antenna		
Device Operating Configurations :			
Supporting Mode(s):	GSM 850/GSM 1900; (tested) UMTS Band II/UMTS Band IV/ UMTS Band V; (tested) GSM 900/GSM 1800; (untested) Bluetooth; (untested) WiFi (802.11b/g/n HT20/ n HT40); (untested)		
Test Modulation:	(GSM)GMSK; (UMTS)QPSK		
Device Class:	B		
HSDPA UE Category:	8		
HSUPA UE Category:	6		
GPRS Multislot Class(12):	Max Number of Timeslots in Uplink	4	
	Max Number of Timeslots in Downlink	4	
	Max Total Timeslot	5	
EGPRS Multislot Class(12):	Max Number of Timeslots in Uplink	4	
	Max Number of Timeslots in Downlink	4	
	Max Total Timeslot	5	
Operating Frequency Range(s):	Mode	Tx (MHz)	Rx (MHz)
	GSM 850	824.2 ~ 848.8	869.2 ~ 893.8
	GSM 1900	1850.2 ~ 1909.8	1930.2 ~ 1989.8
	UMTS Band II	1852.4 ~ 1907.6	1932.4 ~ 1987.6
	UMTS Band IV	1712.4 ~ 1752.6	2112.4 ~ 2152.6
	UMTS Band V	826.4 ~ 846.6	871.4 ~ 891.6
Power Class:	GSM 850: 4		
	GSM 1900: 1		
	UMTS Band II: 3		
	UMTS Band IV: 3		

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	UMTS Band V: 3		
Power Level	GSM 850: tested with power level 5		
	GSM 1900: tested with power level 0		
	UMTS Band II: tested with power control all up bits		
	UMTS Band IV: tested with power control all up bits		
	UMTS Band V: tested with power control all up bits		
Test Channel: (Low - Middle - High)	128 - 190 - 251	(GSM 850)	(tested)
	512 - 661 - 810	(GSM 1900)	(tested)
	9262 - 9400 - 9538	(UMTS Band II)	(tested)
	1312 - 1413 - 1513	(UMTS Band IV)	(tested)
	4132 - 4183 - 4233	(UMTS Band V)	(tested)

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Auxiliary Equipment Details

AE1:Battery 1

Model: TLiB60B
Manufacturer: SCUD
SN: CAB60BA000C1

AE1:Battery 2

Model: TLi014A1
Manufacturer: BYD
SN: CAB1400002C1

Equipment under Test (EUT) has an internal antenna for GSM/WCDMA Tx/Rx, and the other is BT/WiFi antenna that is used for Tx/Rx. HAC is tested for GSM 850, GSM 1900, WCDMA Band II, WCDMA Band IV and WCDMA Band V. The detail about EUT and Lithium Battery is in chapter 1.5 in this report.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

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Air-Interface	Band (MHz)	Type	C63.19/ tested	Simultaneous Transmissions Note: Not to be tested	Concurrent single transmission	Reduced power 20.19(c)(1)	Voice Over Digital Transport (Data)
GSM	850	VO	Yes	Yes BT or wifi	Yes: GPRS/EDGE, BT,WIFI Not rated	NA	NA
	1900	VO	Yes			NA	NA
	GPRS/EDGE	DT	NA	Yes BT or wifi	Yes: *see note	NA	NA
WCDMA	850	VO	Yes	Yes BT or wifi	Yes: HSDPA/HSUPA,BT, WIFI Not rated	NA	NA
	1750	VO	Yes				
	1900	VO	Yes				
	HSDPA/HSUPA	DT	NA	Yes BT or wifi	Yes: *see note	NA	NA
Bluetooth (BT)	2400	DT	NA	Yes GSM or WCDMA	NA	NA	NA
WIFI	2400	DT	NA	Yes GSM or WCDMA	NA	NA	YES

VO Voice CMRS/PSTN Service only
V/D Voice CMRS/PSTN and Data Service
DT Digital Transport

*HAC Rating was based on concurrent voice and data modes, Non current mode was found to represent worst case rating for both M and T rating

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1.6. The Ambient Conditions during Test

Temperature	Min. = 18°C, Max. = 28 °C
Relative humidity	Min. = 0%, Max. = 80%
Ground system resistance	< 0.5 Ω
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

1.7. The Total M-rating of each tested band

Battery 1

Mode	Rating
GSM 850	M4
GSM 1900	M3
WCDMA Band II	M4
WCDMA Band IV	M4
WCDMA Band V	M4

Battery 2

Mode	Rating
GSM 850	M4
GSM 1900	M3
WCDMA Band II	M4
WCDMA Band IV	M4
WCDMA Band V	M4

1.8. Test Date

The test performed from August 20, 2013 to August 21, 2013.

2. Test Information

2.1. Operational Conditions during Test

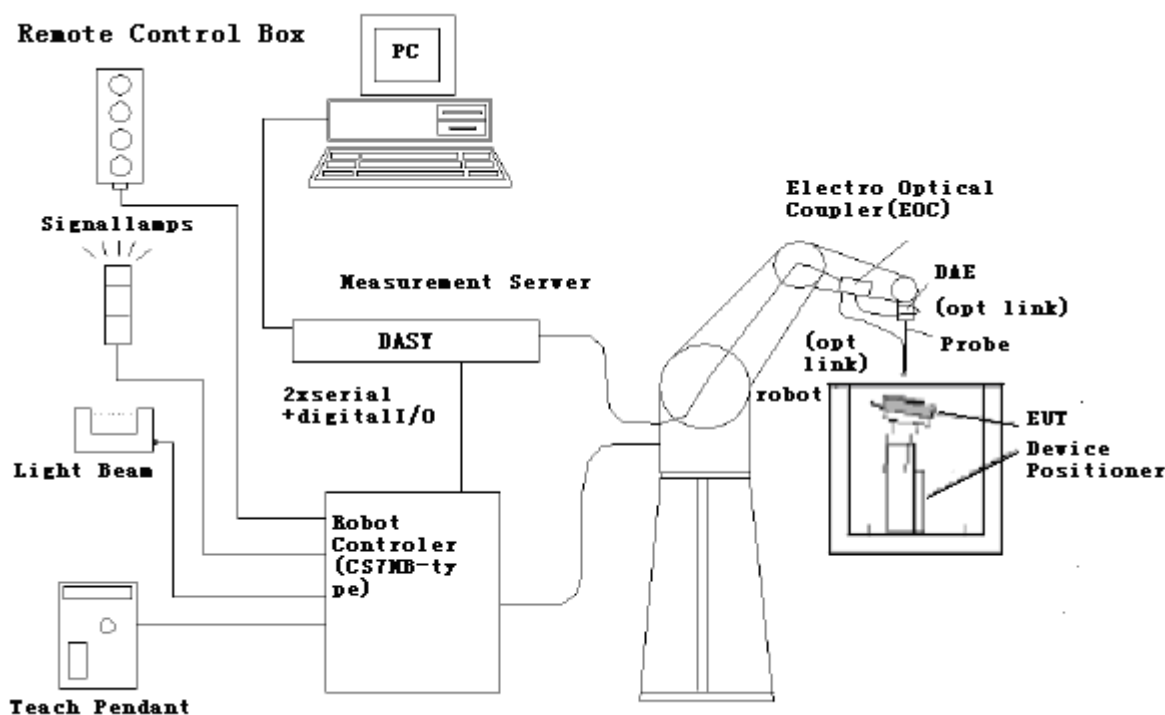
2.1.1. General Description of Test Procedures

The phone was tested in all normal configurations for the ear use. The EUT is mounted in the device holder equivalent as for classic dosimeter measurements. The acoustic output of the EUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame. The EUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete. The EUT holder is on the yellow base plate of the Test Arch phantom. These test configurations are tested at the high, middle and low frequency channels of each applicable operating mode; for example, GSM, WCDMA (UMTS), CDMA and TDMA.

2.1.2. GSM/WCDMA Test Configuration

A communication link is set up with a System Simulator (SS) by air link, and a call is established. The EUT is commanded to operate at maximum transmitting power. Using E5515C the power lever is set to "5" for GSM 850, set to "0" for GSM 1900. Set to all up bits for WCDMA. The test in the bands of GSM 850/GSM 1900 and WCDMA Band II / WCDMA Band IV /WCDMA Band V are performed in the mode of speech transfer function.

These measurements are performed using the DASY5 automated dosimetric assessment system. It is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland. It consists of high precision robotics system (Stäubli), robot controller, Intel Core2 computer, near-field probe, probe alignment sensor. The robot is a six-axis industrial robot performing precise movements. Cell controller systems contain the power supply, robot controller, teach pendant (Joystick) and remote control, and are used to drive the robot motors. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification; signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.



The DAE4 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

2.2.2. Probe System

The HAC measurements were conducted with the E-Field Probe ER3DV6 and the H-Field Probe H3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation.

E-Field Probe Description

Construction	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges PEEK enclosure material
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy $\pm 6.0\%$, $k=2$)
Frequency	40 MHz to > 6 GHz (can be extended to < 20 MHz) Linearity: ± 0.2 dB (100 MHz to 3 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m; Linearity: ± 0.2 dB
Dimensions	Overall length: 330 mm (Tip: 16 mm) Tip diameter: 8 mm (Body: 12 mm) Distance from probe tip to dipole centers: 2.5 mm
Application	General near-field measurements up to 6 GHz Field component measurements Fast automatic scanning in phantoms



Figure 2 ER3DV6 E-field Probe

H-Field Probe Description

Construction	Three concentric loop sensors with 3.8 mm loop diameters Resistively loaded detector diodes for linear response Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., glycolether)
Frequency	200 MHz to 3 GHz (absolute accuracy $\pm 6.0\%$, $k=2$); Output linearized
Directivity	± 0.2 dB (spherical isotropy error)
Dynamic Range	10 mA/m to 2 A/m at 1 GHz
E-Field Interference	< 10% at 3 GHz (for plane wave)
Dimensions	Overall length: 330 mm (Tip: 40 mm) Tip diameter: 6 mm (Body: 12 mm) Distance from probe tip to dipole centers: 3 mm



Figure 3 H3DV6 H-field Probe

Application	General magnetic near-field measurements up to 3 GHz (in air or liquids) Field component measurements Surface current measurements Low interaction with the measured field
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2.2.3. Test Arch Phantom & Phone Positioner

The Test Arch phantom should be positioned horizontally on a stable surface. Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot. It enables easy and well defined positioning of the phone and validation dipoles as well as simple teaching of the robot (Dimensions: 370 x 370 x 370 mm).

The Device reference point is set for the EUT at 6.3 mm, the Grid reference point is on the upper surface at the origin of the coordinates, and the “user point \Height Check 0.5 mm” is 0.5mm above the center, allowing verification of the gap of 0.5mm while the probe is positioned there.

The Phone Positioner supports accurate and reliable positioning of any phone with effect on near field $<\pm 0.5$ dB.

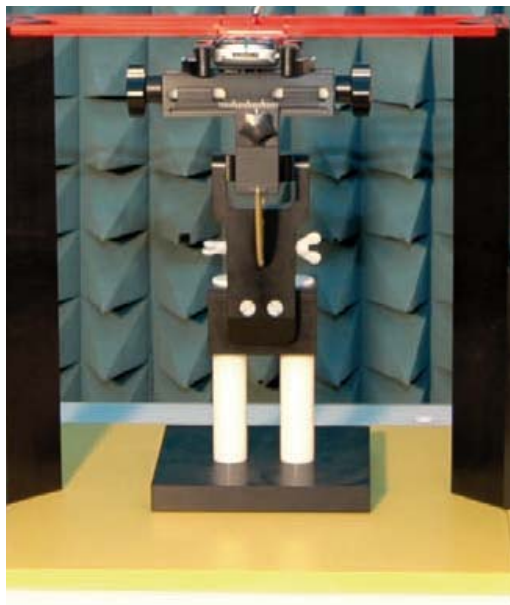


Figure 4 HAC Phantom & Device Holder

2.3. RF Test Procedures

The evaluation was performed with the following procedure:

1. Confirm proper operation of the field probe, probe measurement system and other instrumentation and the positioning system.
2. Position the WD in its intended test position. The gauge block can simplify this positioning. Note that a separate E-field and H-field gauge block will be needed if the center of the probe sensor elements is at different distances from the tip of the probe.
3. Configure the WD normal operation for maximum rated RF output power, at the desired channel and other operating parameters (e.g., test mode), as intended for the test.
4. The center sub-grid shall center on the center of the axial measurement point or the acoustic output, as appropriate. Locate the field probe at the initial test position in the 50 mm by 50 mm grid, which is contained in the measurement plane. If the field alignment method is used, align the probe for maximum field reception.
5. Record the reading.
6. Scan the entire 50 mm by 50 mm region in equally spaced increments and record the reading at each measurement point. The grid is 5 cm by 5 cm area that is divided into 9 evenly sized blocks or sub-grids. The distance between measurement points shall be sufficient to assure the identification of the maximum reading.
7. Identify the five contiguous sub-grids around the center sub-grid with the lowest maximum field strength readings. Thus the six areas to be used to determine the WD's highest emissions are identified and outlined for the final manual scan. Please note that a maximum of five blocks can be excluded for both E-field and H-field measurements for the WD output being measured. Stated another way, the center sub-grid and three others must be common to both the E-field and H-field measurements.
8. Identify the maximum field reading within the non-excluded sub-grids identified in Step 7.
9. Convert the maximum field strength reading identified in Step 8 to V/m or A/m, as appropriate. For probes which require a probe modulation factor, this conversion shall be done using the appropriate probe modulation factor and the calibration.
10. Repeat Step 1 through Step 10 for both the E-field and H-field measurements.
11. Compare this reading to the categories in ANSI C63.19 Clause 7 and record the resulting category. The lowest category number listed in 7.2, Table 7.4, or Table 7.5 obtained in Step 10 for either E- or H-field determines the M category for the audio coupling mode assessment. Record the WD category rating.

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Figure 5 WD reference and plane for RF emission measurements

2.4. System Check

Validation Procedure

Place a dipole antenna meeting the requirements given in ANSI C63.19 D.5 in the position normally occupied by the WD. The dipole antenna serves as a known source for an electrical and magnetic output. Position the E-field and H-field probes so that:

The probes and their cables are parallel to the coaxial feed of the dipole antenna.

The probe cables and the coaxial feed of the dipole antenna approach the measurement area from opposite directions.

The center point of the probe element(s) are 10 mm from the closest surface of the dipole elements. Validation was performed to verify that measured E-field and H-field values are within +/-25% from the target reference values provided by the manufacturer. "Values within +/-25% are acceptable. Of which 12% is deviation and 13% is measurement uncertainty."

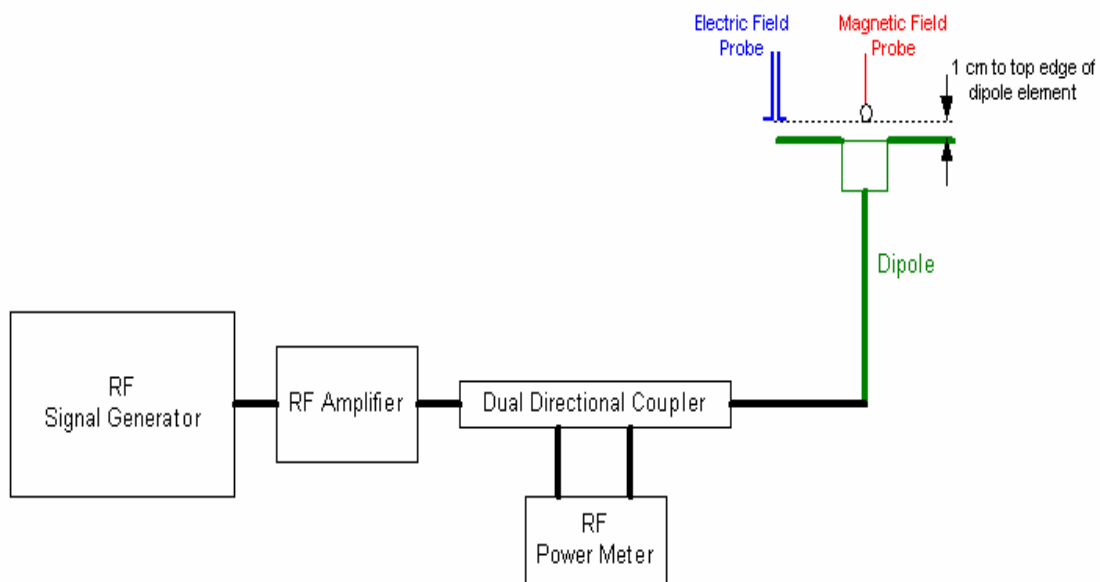


Figure 6 Dipole Validation Setup

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Dipole Measurement Summary

E-Field Scan					
Mode	Frequency (MHz)	Input Power (mW)	Value		Test Date
CW	835	100	Target ¹ Value(V/m)	161.8	August 30,2012
			Measured ² Value(V/m)	170.3	August 20, 2013
			Deviation ³ (%)	5.25	/
CW	1880	100	Target ¹ Value(V/m)	139.0	August 30,2012
			Measured ² Value(V/m)	148.1	August 21, 2013
			Deviation ³ (%)	6.55	/
H-Field Scan					
Mode	Frequency (MHz)	Input Power (mW)	Value		Test Date
CW	835	100	Target ¹ Value(A/m)	0.460	August 30,2012
			Measured ² Value(A/m)	0.471	August 20, 2013
			Deviation ³ (%)	2.39	/
CW	1880	100	Target ¹ Value(A/m)	0.460	August 30,2012
			Measured ² Value(A/m)	0.457	August 21, 2013
			Deviation ³ (%)	-0.65	/
Notes: 1. Target value is provided by SPEAD in the calibration certificate of specific dipoles.					
2. Please refer to the attachment for detailed measurement data and plot.					
3. Deviation (%) = 100 * (Measured value minus Target value) divided by Target value.					

2.5. Probe Modulation Factor

The Probe Modulation Factor (PMF) is defined as the ratio of the field readings for a CW and a modulated signal with the equivalent Field Envelope Peak as defined in ANSI C63.19 (Chapter C.3.1). Calibration shall be made of the modulation response of the probe and its instrumentation chain. This Calibration shall be performed with the field probe, attached to the instrumentation that is to be used with it during the measurement. The response of the probe system to a CW field at the frequency(s) of interest is compared to its response to a modulated signal with equal peak amplitude. The field level of the test signals shall be more than 10dB above the ambient level and the noise floor of the instrumentation being used. The ratio of the CW reading to that taken with a modulated field shall be applied to the readings taken of modulated fields of the specified type.

Modulation Factor Test Procedure

This may be done using the following procedure:

1. Fix the field probe in a set location relative to a field generating device, such as the reference dipole antenna.
2. Illuminate the probe using the wireless device connected to the reference dipole with a test signal at the intended measurement frequency, Ensure there is sufficient field coupling between the probe and the antenna so the resulting reading is greater than 10 dB above the probe system noise floor but within the systems operating range.
3. Record the amplitude applied to the antenna during transmission and the field strength measured by the E-field probe located near the tip of the dipole antenna
4. Replace the wireless device with an RF signal generator producing an unmodulated CW signal and set to the wireless device operating frequency.
5. Set the amplitude of the unmodulated signal to equal that recorded from the wireless device.
6. Record the reading of the probe measurement system of the unmodulated signal.
7. The ratio, in linear units, of the probe reading in Step 6 to the reading in Step 3 is the E-field modulation factor. $PMF_E = E_{CW} / E_{mod}$ ($PMF_H = H_{CW} / H_{mod}$)
8. Repeat the previous steps using the H-field probe, except locate the probe at the center of the dipole.

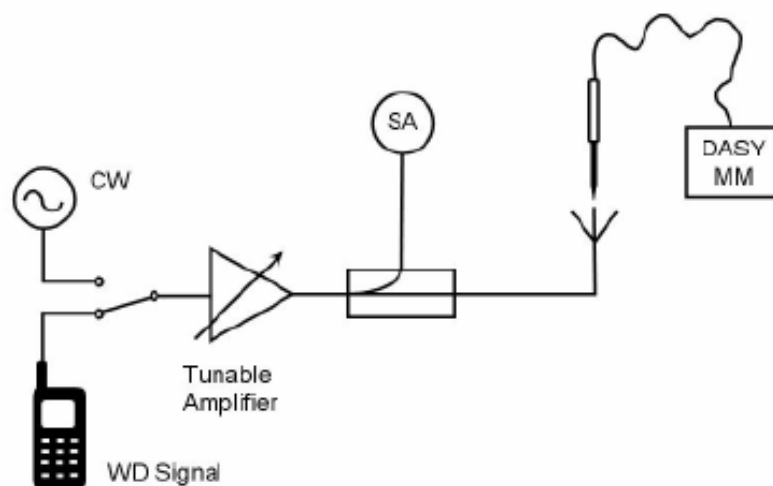


Figure 7 Probe Modulation Factor Test Setup

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PMF

Band	E-Field Probe Modulation Factor	H-Field Probe Modulation Factor
GSM 850	2.81	2.75
GSM 1900	2.84	2.84
WCDMA Band II	1.03	1.01
WCDMA Band IV	1.03	1.01
WCDMA Band V	1.03	1.01

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2.6. Conducted Output Power Measurement

Summary

The EUT is tested using an E5515C communications tester as controller unit to set test channels and maximum output power to the DUT, as well as for measuring the conducted power. Conducted output power was measured using an integrated RF connector and attached RF cable. This result contains conducted output power for the EUT.

Conducted Power Results

GSM 850	Conducted Power(dBm)		
	Channel 128	Channel 190	Channel 251
Test Results	31.59	31.51	31.47
GSM 1900	Conducted Power(dBm)		
	Channel 512	Channel 661	Channel 810
Test Results	28.86	28.88	28.87
WCDMA Band II	Conducted Power(dBm)		
	Channel 9262	Channel 9400	Channel 9538
12.2kbps RMC	22.38	22.5	22.48
WCDMA Band IV	Conducted Power(dBm)		
	Channel 1312	Channel 1413	Channel 1513
12.2kbps RMC	22.32	22.33	22.32
WCDMA Band V	Conducted Power(dBm)		
	Channel 4132	Channel 4183	Channel 4233
12.2kbps RMC	22.23	22.35	22.26

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3. Test Results

3.1. ANSI C63.19-2007 Limits

Category		Telephone RF parameters < 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m
	-5	473.2 to 841.4	V/m	1.43 to 2.54	A/m
Category M2	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m
	-5	266.1 to 473.2	V/m	0.80 to 1.43	A/m
Category M3	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M4	0	< 199.5	V/m	< 0.60	A/m
	-5	< 149.6	V/m	< 0.45	A/m
Category		Telephone RF parameters > 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Category M1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m
	-5	84.1 to 149.6	V/m	0.25 to 0.45	A/m
Category M3	0	63.1 to 112.2	V/m	0.19 to 0.34	A/m
	-5	47.3 to 84.1	V/m	0.14 to 0.25	A/m
Category M4	0	< 63.1	V/m	< 0.19	A/m
	-5	< 47.3	V/m	< 0.14	A/m

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3.2. Summary Test Results

GSM 850 Results

Battery 1

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/251	848.8	27.2	0.039	M4	Figure 12
Middle/190	836.6	27.7	-0.016	M4	Figure 13
Low/128	824.2	25.2	-0.084	M4	Figure 14
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/251	848.8	0.046	0.124	M4	Figure 15
Middle/190	836.6	0.041	-0.082	M4	Figure 16
Low/128	824.2	0.048	-0.110	M4	Figure 17

Battery 2

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/251	848.8	29.9	-0.035	M4	Figure 18
Middle/190	836.6	31.9	0.027	M4	Figure 19
Low/128	824.2	30.7	0.017	M4	Figure 20
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/251	848.8	0.12	-0.018	M4	Figure 21
Middle/190	836.6	0.13	-0.082	M4	Figure 22
Low/128	824.2	0.12	-0.030	M4	Figure 23

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GSM 1900 Results

Battery 1

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/810	1909.8	80.9	0.028	M3	Figure 24
Middle/661	1880	80.7	-0.047	M3	Figure 25
Low/512	1850.2	80.6	0.011	M3	Figure 26
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/810	1909.8	0.226	0.027	M3	Figure 27
Middle/661	1880	0.232	-0.142	M3	Figure 28
Low/512	1850.2	0.219	0.002	M3	Figure 29

Battery 2

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/810	1909.8	75.8	-0.071	M3	Figure 30
Middle/661	1880	80.4	-0.055	M3	Figure 31
Low/512	1850.2	83	0.063	M3	Figure 32
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/810	1909.8	0.244	-0.074	M3	Figure 33
Middle/661	1880	0.234	-0.124	M3	Figure 34
Low/512	1850.2	0.247	-0.090	M3	Figure 35

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WCDMA Band II Results

Battery 1

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/9538	1907.6	36.7	0.012	M4	Figure 36
Middle/9400	1880	36.3	-0.100	M4	Figure 37
Low/9262	1852.4	35.7	0.009	M4	Figure 38
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/9538	1907.6	0.100	0.045	M4	Figure 39
Middle/9400	1880	0.101	-0.024	M4	Figure 40
Low/9262	1852.4	0.096	0.003	M4	Figure 41

Battery 2

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/9538	1907.6	37.2	-0.117	M4	Figure 42
Middle/9400	1880	36.2	-0.061	M4	Figure 43
Low/9262	1852.4	35.9	-0.136	M4	Figure 44
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/9538	1907.6	0.117	-0.038	M4	Figure 45
Middle/9400	1880	0.114	0.019	M4	Figure 46
Low/9262	1852.4	0.115	-0.030	M4	Figure 47

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WCDMA Band IV Results

Battery 1

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/1513	1752.6	31.9	-0.039	M4	Figure 48
Middle/1413	1732.6	35	-0.087	M4	Figure 49
Low/1312	1712.4	38.2	-0.037	M4	Figure 50
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/1513	1752.6	0.106	-0.035	M4	Figure 51
Middle/1413	1732.6	0.108	-0.024	M4	Figure 52
Low/1312	1712.4	0.106	0.021	M4	Figure 53

Battery 2

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/1513	1752.6	44.5	-0.131	M4	Figure 54
Middle/1413	1732.6	44.8	-0.142	M4	Figure 55
Low/1312	1712.4	45.4	-0.147	M4	Figure 56
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/1513	1752.6	0.137	-0.054	M4	Figure 57
Middle/1413	1732.6	0.144	-0.049	M4	Figure 58
Low/1312	1712.4	0.148	-0.030	M4	Figure 59

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WCDMA Band V Results

Battery 1

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/4233	846.6	10.7	-0.028	M4	Figure 60
Middle/4183	836.6	9.13	0.062	M4	Figure 61
Low/4132	826.4	9.39	-0.034	M4	Figure 62
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/4233	846.6	0.016	0.004	M4	Figure 63
Middle/4183	836.6	0.018	0.034	M4	Figure 64
Low/4132	826.4	0.015	0.099	M4	Figure 65

Battery 2

E-Field					
Channel	Frequency (MHz)	Peak Field (V/m)	Power Drift (dB)	Rating	Graph Results
High/4233	846.6	7.55	0.010	M4	Figure 66
Middle/4183	836.6	7.78	-0.066	M4	Figure 67
Low/4132	826.4	7.85	0.021	M4	Figure 68
H-Field					
Channel	Frequency (MHz)	Peak Field (A/m)	Power Drift (dB)	Rating	Graph Results
High/4233	846.6	0.046	-0.088	M4	Figure 69
Middle/4183	836.6	0.044	-0.093	M4	Figure 70
Low/4132	826.4	0.046	-0.090	M4	Figure 71

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4. Measurement Uncertainty

No.	Error source	Type	Uncertainty Value (%)	Prob. Dist.	k	c_{iE}	c_{iH}	Standard Uncertainty (%) u_i (%) E	Standard Uncertainty (%) u_i (%) H	Degree of freedom V_{eff} or v_i
Measurement System										
1	Probe Calibration	B	5.1	N	1	1	1	5.1	5.1	∞
2	Axial Isotropy	B	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
3	Sensor Displacement	B	16.5	R	$\sqrt{3}$	1	0.145	9.5	1.4	∞
4	Boundary Effects	B	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	∞
5	Test Arch	B	7.2	R	$\sqrt{3}$	1	0	4.1	0	∞
6	Linearity	B	4.7	R	$\sqrt{3}$	1	1	2.7	2.7	∞
7	Scaling to Peak Envelope Power	B	2.0	R	$\sqrt{3}$	1	1	1.2	1.2	∞
8	System Detection Limit	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
9	Readout Electronics	B	0.3	N	1	1	1	0.3	0.3	∞
10	Response Time	B	0.8	R	$\sqrt{3}$	1	1	0.5	0.5	∞
11	Integration Time	B	2.6	R	$\sqrt{3}$	1	1	1.5	1.5	∞
12	RF Ambient Conditions	B	3.0	R	$\sqrt{3}$	1	1	1.7	1.7	∞
13	RF Reflections	B	12.0	R	$\sqrt{3}$	1	1	6.9	6.9	∞
14	Probe Positioner	B	1.2	R	$\sqrt{3}$	1	0.67	0.7	0.5	∞
15	Probe Positioning	A	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	∞
16	Extra. And Interpolation	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞
Test Sample Related										
17	Device Positioning Vertical	B	4.7	R	$\sqrt{3}$	1	0.67	2.7	1.8	∞
18	Device Positioning Lateral	B	1.0	R	$\sqrt{3}$	1	1	0.6	0.6	∞

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19	Device Holder and Phantom	B	2.4	R	$\sqrt{3}$	1	1	1.4	1.4	∞
20	Power Drift	B	5.0	R	$\sqrt{3}$	1	1	2.9	2.9	∞
Phantom and Setup related										
21	Phantom Thickness	B	2.4	R	$\sqrt{3}$	1	0.67	1.4	0.9	∞
Combined standard uncertainty (%)								15.19	10.82	
Expanded Std. uncertainty on power (K=2)								30.38	21.64	
Expanded Std. uncertainty on field (K=2)								15.19	10.82	

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5. Main Test Instruments

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Power meter	Agilent E4417A	GB41291714	March 10, 2013	One year
02	Power sensor	Agilent N8481H	MY50350004	September 24, 2012	One year
03	Signal Generator	HP 8341B	2730A00804	September 11, 2012	One year
04	Amplifier	IXA-020	0401	No Calibration Requested	
05	BTS	E5515C	MY48360988	December 1, 2012	One year
06	E-Field Probe	ER3DV6	2428	August 30, 2012	One year
07	H-Field Probe	H3DV6	6260	August 30, 2012	One year
08	DAE	DAE4	1317	January 25, 2013	One year
09	Validation Kit 835MHz	CD835V3	1023	August 30, 2012	One year
10	Validation Kit 1880MHz	CD1880V3	1018	August 30, 2012	One year
11	Hygrothermograph	WS-1	64591	September 27, 2012	One year

*****END OF REPORT *****

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ANNEX A: System Check Results

HAC_System Performance Check at 835MHz_E

DUT: Dipole 835 MHz; Type: CD835V3; SN:1023

Date/Time: 8/20/2013 9:00:52 AM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

E Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm

2/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 170.3 V/m

Probe Modulation Factor = 1.00

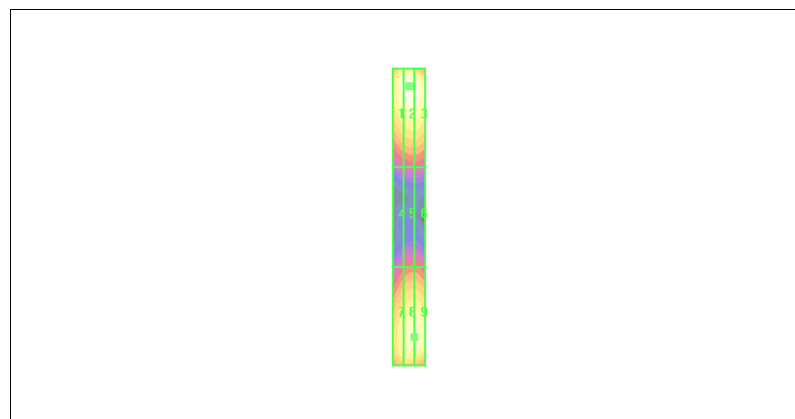
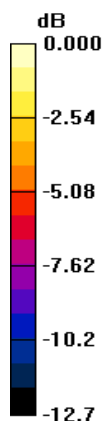
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 118.7 V/m; Power Drift = 0.003 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 161.9 M4	Grid 2 170.3 M4	Grid 3 166.1 M4
Grid 4 81.2 M4	Grid 5 88.2 M4	Grid 6 87.9 M4
Grid 7 144.5 M4	Grid 8 157.6 M4	Grid 9 157.6 M4



0 dB = 170.3V/m

Figure 8 System Performance Check 835MHz_E

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HAC_System Performance Check at 835MHz_H

DUT: Dipole 835 MHz; Type: CD835V3; SN: 1023

Date/Time: 8/20/2013 4:41:52 PM

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

H Scan - measurement distance from the probe sensor center to CD835 Dipole = 10mm/Hearing Aid Compatibility Test (41x381x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.471 A/m

Probe Modulation Factor = 1.00

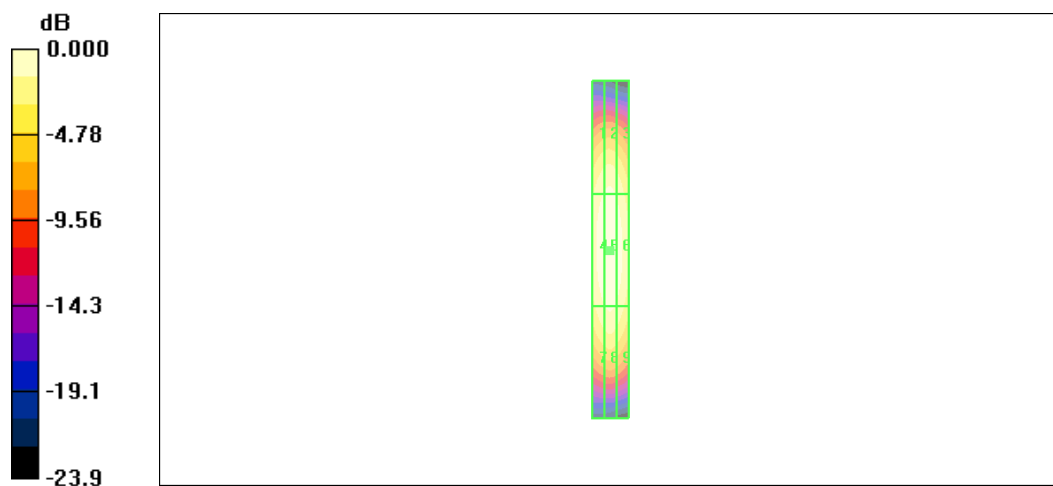
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.503 A/m; Power Drift = -0.012 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.397 M4	0.411 M4	0.382 M4
Grid 4	Grid 5	Grid 6
0.453 M4	0.471 M4	0.440 M4
Grid 7	Grid 8	Grid 9
0.388 M4	0.405 M4	0.380 M4



0 dB = 0.471 A/m

Figure 9 System Performance Check 835MHz_H

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HAC_System Performance Check at 1880MHz_E

DUT: Dipole 1880 MHz; Type: CD1880V3; SN: 1018

Date/Time: 8/21/2013 2:15:52 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

E Scan - measurement distance from the probe sensor center to CD1880 Dipole = 10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 148.1 V/m

Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 146.4 V/m; Power Drift = 0.002 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m

Grid 1 140.5 M2	Grid 2 148.1 M2	Grid 3 143.0 M2
Grid 4 86.9 M3	Grid 5 93.9 M3	Grid 6 93.7 M3
Grid 7 136.0 M2	Grid 8 143.9 M2	Grid 9 143.2 M2

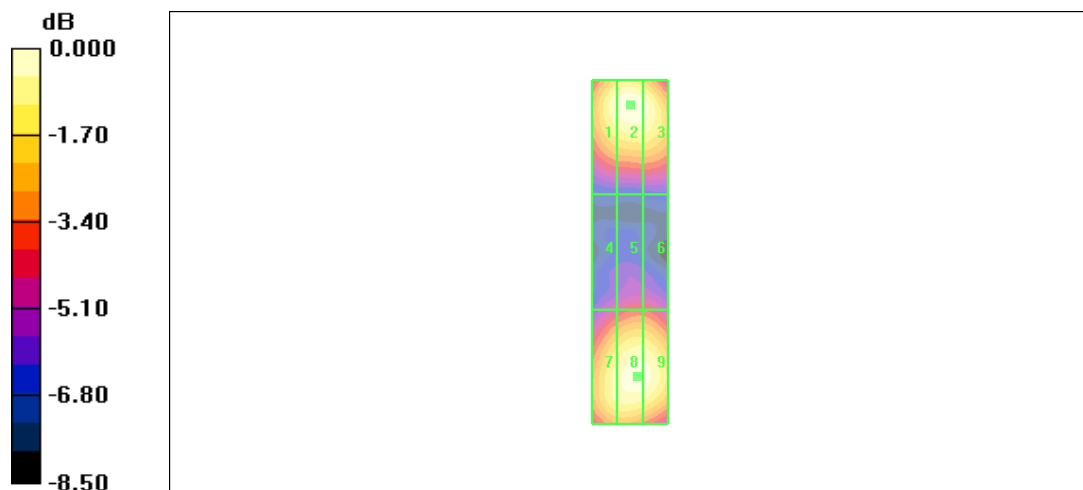


Figure 10 System Performance Check 1880MHz_E

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HAC_System Performance Check at 1880MHz_H

DUT: Dipole 1880 MHz; Type: CD1880V3; SN: 1018

Date/Time: 8/21/2013 9:46:52 AM

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

H Scan - measurement distance from the probe sensor center to Dipole = 10mm/Hearing Aid

Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.457 A/m

Probe Modulation Factor = 1.00

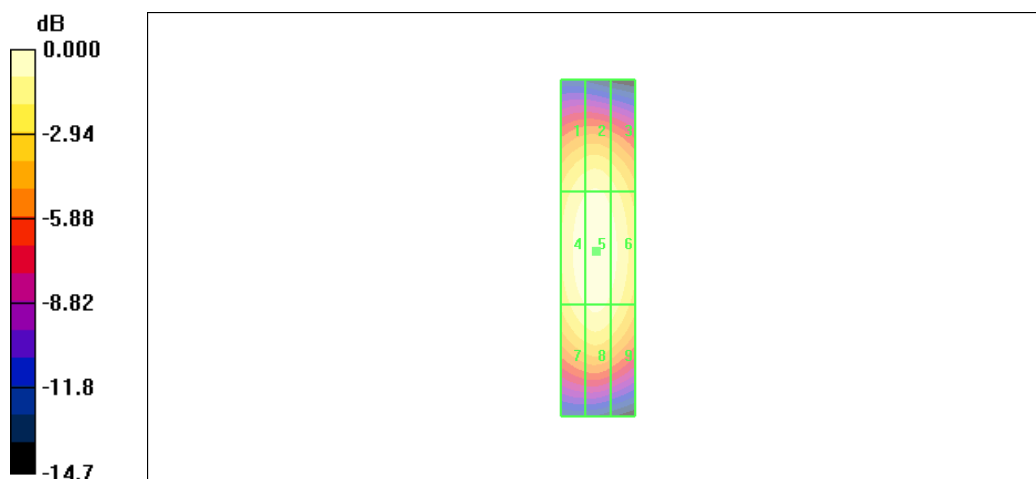
Device Reference Point: 0.000, 0.000, -6.30 mm

Reference Value = 0.483 A/m; Power Drift = 0.003 dB

Hearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.403 M2	Grid 2 0.415 M2	Grid 3 0.387 M2
Grid 4 0.443 M2	Grid 5 0.457 M2	Grid 6 0.428 M2
Grid 7 0.408 M2	Grid 8 0.423 M2	Grid 9 0.393 M2



0 dB = 0.457A/m

Figure 11 System Performance Check 1880MHz_H

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ANNEX B: Graph Results

HAC RF E-Field GSM 850 High(Battery 1)

Date/Time: 8/20/2013 10:49:50 AM

Communication System: GSM; Frequency: 848.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 27.2 V/m

Probe Modulation Factor = 2.81

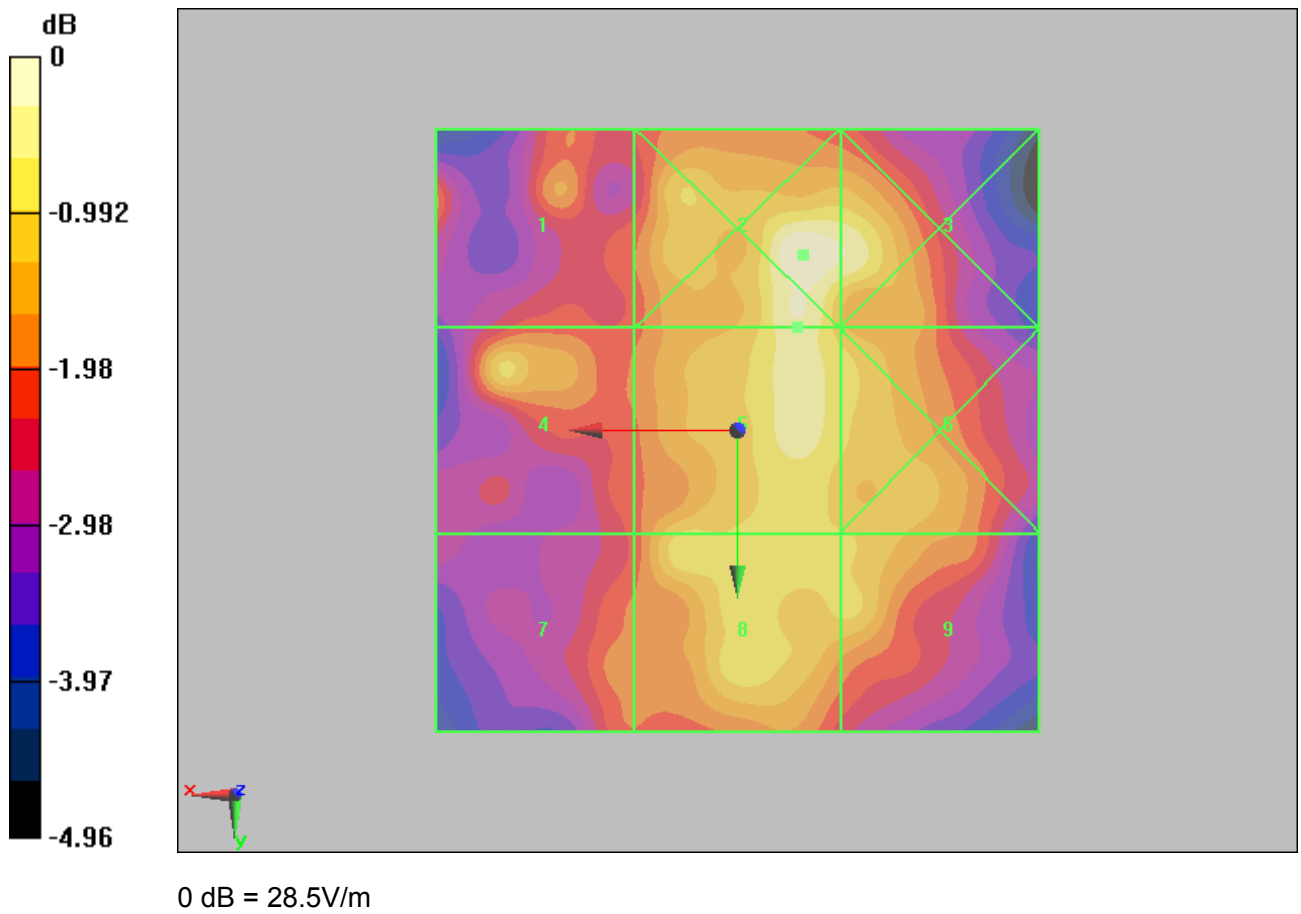
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 11.3 V/m; Power Drift = 0.039 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
23.7 M4	28.5 M4	27.6 M4
Grid 4	Grid 5	Grid 6
25.8 M4	27.2 M4	26 M4
Grid 7	Grid 8	Grid 9
23.5 M4	26.3 M4	25.8 M4



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HAC RF E-Field GSM 850 Middle(Battery 1)

Date/Time: 8/20/2013 10:43:08 AM

Communication System: GSM; Frequency: 836.6 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**GSM850 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 27.7 V/m

Probe Modulation Factor = 2.81

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 11.5 V/m; Power Drift = -0.016 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak E-field in V/m

Grid 1 27.3 M4	Grid 2 27.7 M4	Grid 3 24.3 M4
Grid 4 26.2 M4	Grid 5 27.2 M4	Grid 6 25.6 M4
Grid 7 28.4 M4	Grid 8 27 M4	Grid 9 24.7 M4

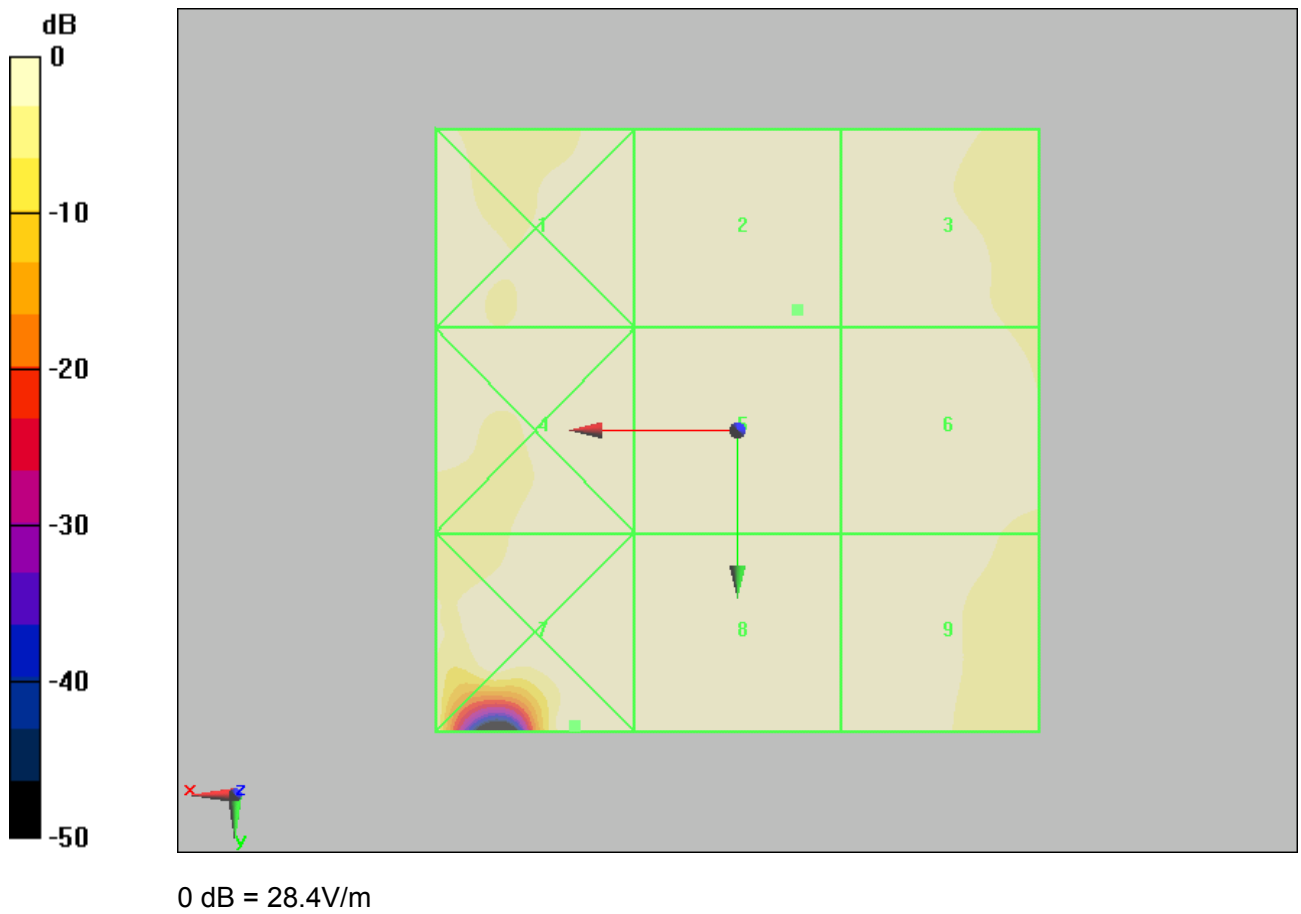


Figure 13 HAC RF E-Field GSM 850 Channel 190

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HAC RF E-Field GSM 850 Low(Battery 1)

Date/Time: 8/20/2013 10:56:02 AM

Communication System: GSM; Frequency: 824.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 25.2 V/m

Probe Modulation Factor = 2.81

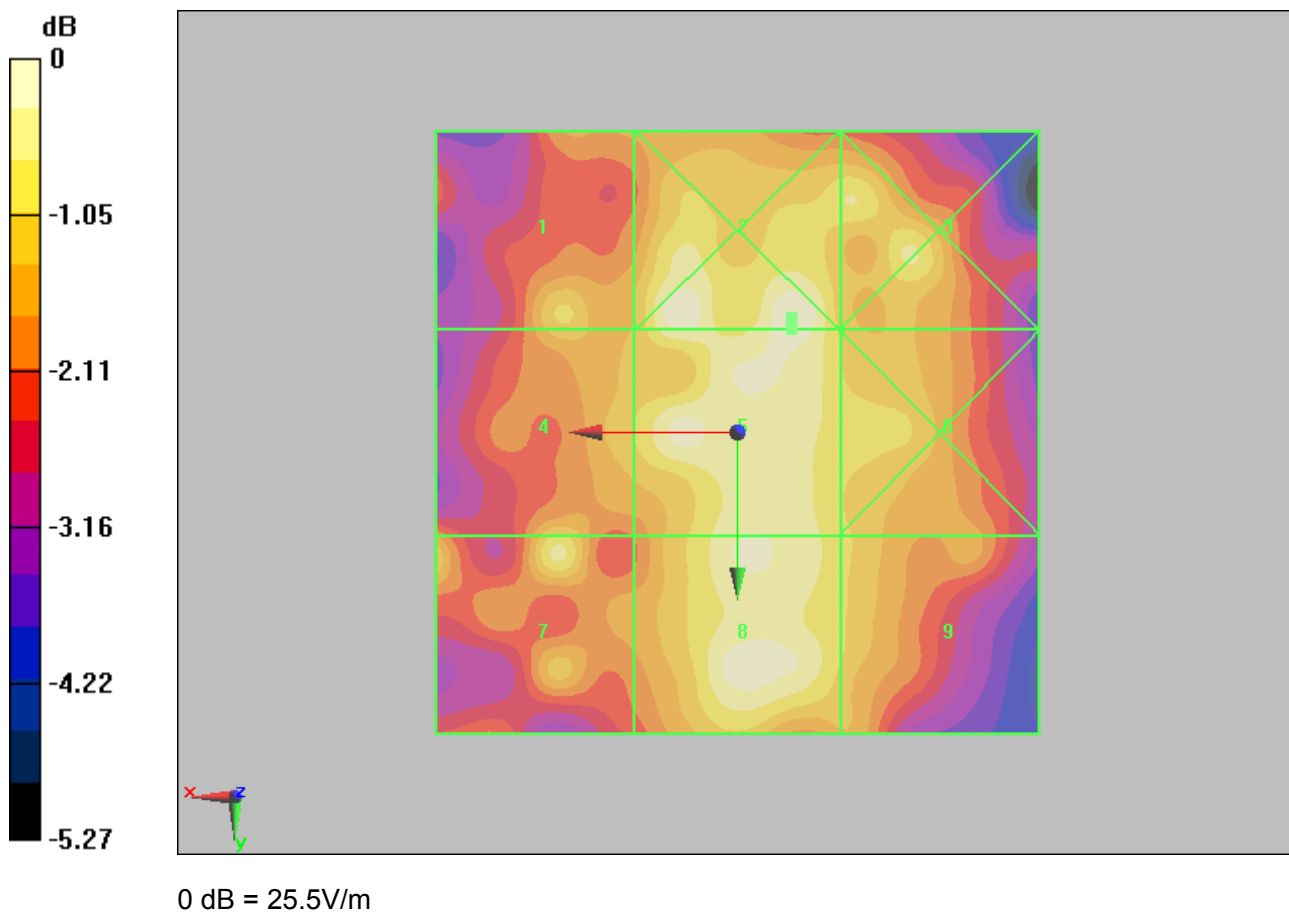
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 10.7 V/m; Power Drift = -0.084 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
22.8 M4	25.5 M4	23.7 M4
Grid 4	Grid 5	Grid 6
22.7 M4	25.2 M4	23.4 M4
Grid 7	Grid 8	Grid 9
23.8 M4	25.2 M4	22.9 M4



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HAC RF H-Field GSM 850 High(Battery 1)

Date/Time: 8/20/2013 5:50:31 PM

Communication System: GSM; Frequency: 848.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.046 A/m

Probe Modulation Factor = 2.75

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.00963 A/m; Power Drift = 0.124 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.052 M4	Grid 2 0.046 M4	Grid 3 0.030 M4
Grid 4 0.050 M4	Grid 5 0.043 M4	Grid 6 0.030 M4
Grid 7 0.053 M4	Grid 8 0.042 M4	Grid 9 0.029 M4

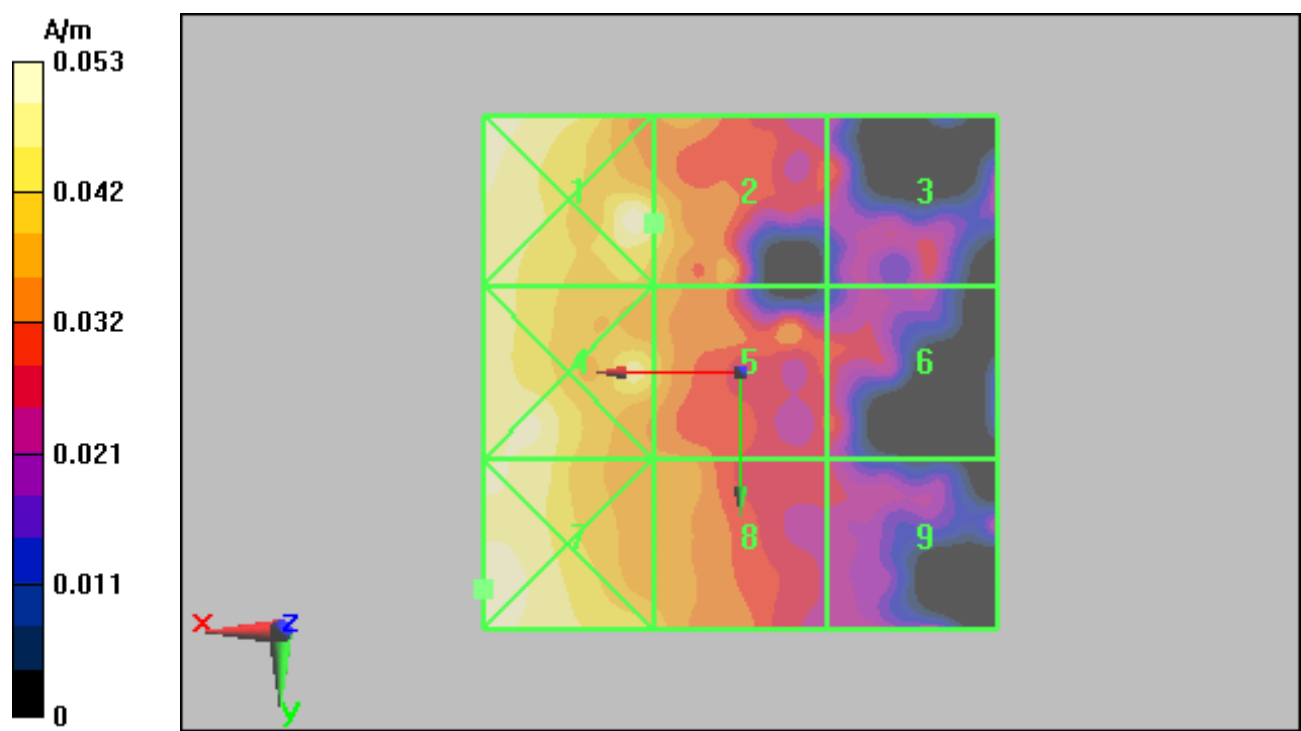


Figure 15 HAC RF H-Field GSM 850Channel 251

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HAC RF H-Field GSM 850 Middle(Battery 1)

Date/Time: 8/20/2013 6:24:43 PM

Communication System: GSM; Frequency: 836.6 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**GSM850 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.041 A/m

Probe Modulation Factor = 2.75

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.00993 A/m; Power Drift = -0.082 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.051 M4	Grid 2 0.041 M4	Grid 3 0.041 M4
Grid 4 0.049 M4	Grid 5 0.037 M4	Grid 6 0.027 M4
Grid 7 0.053 M4	Grid 8 0.039 M4	Grid 9 0.028 M4

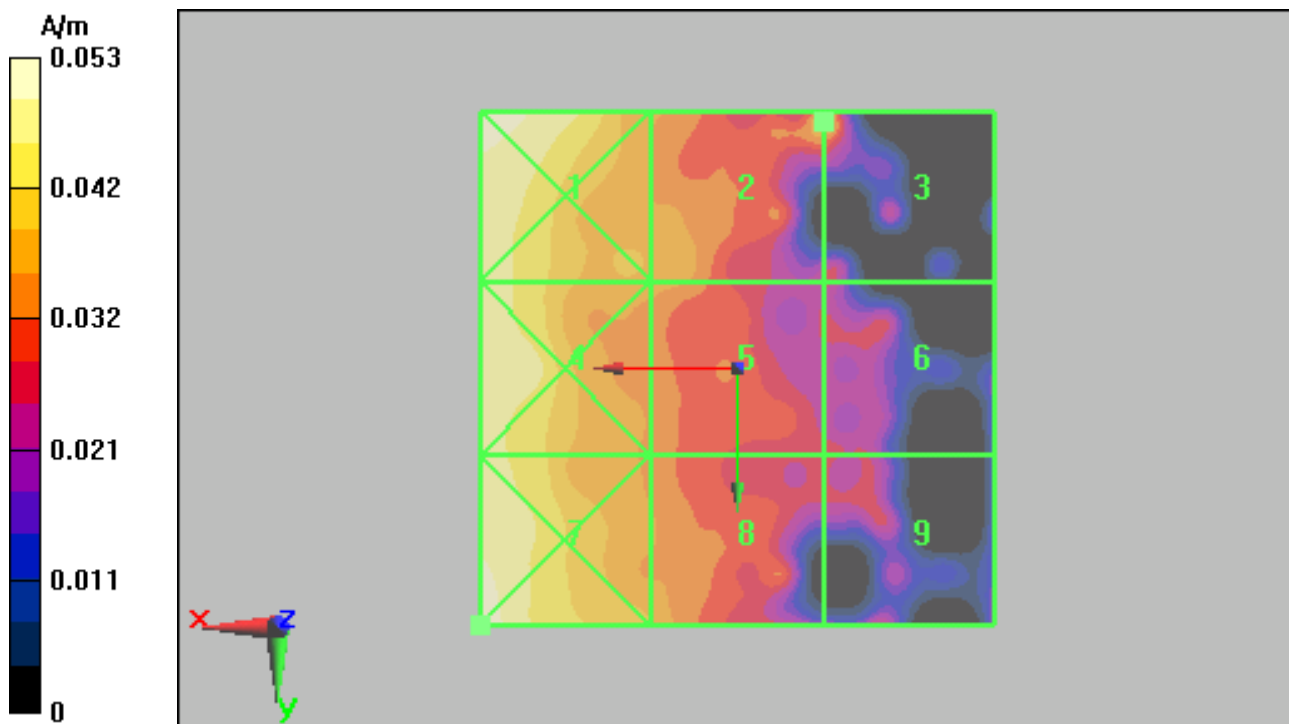


Figure 16 HAC RF H-Field GSM 850 Channel 190

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HAC RF H-Field GSM 850 Low(Battery 1)

Date/Time: 8/20/2013 6:56:13 PM

Communication System: GSM; Frequency: 824.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.048 A/m

Probe Modulation Factor = 2.75

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.00906 A/m; Power Drift = -0.110 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.047 M4	Grid 2 0.048 M4	Grid 3 0.034 M4
Grid 4 0.045 M4	Grid 5 0.043 M4	Grid 6 0.023 M4
Grid 7 0.049 M4	Grid 8 0.043 M4	Grid 9 0.024 M4

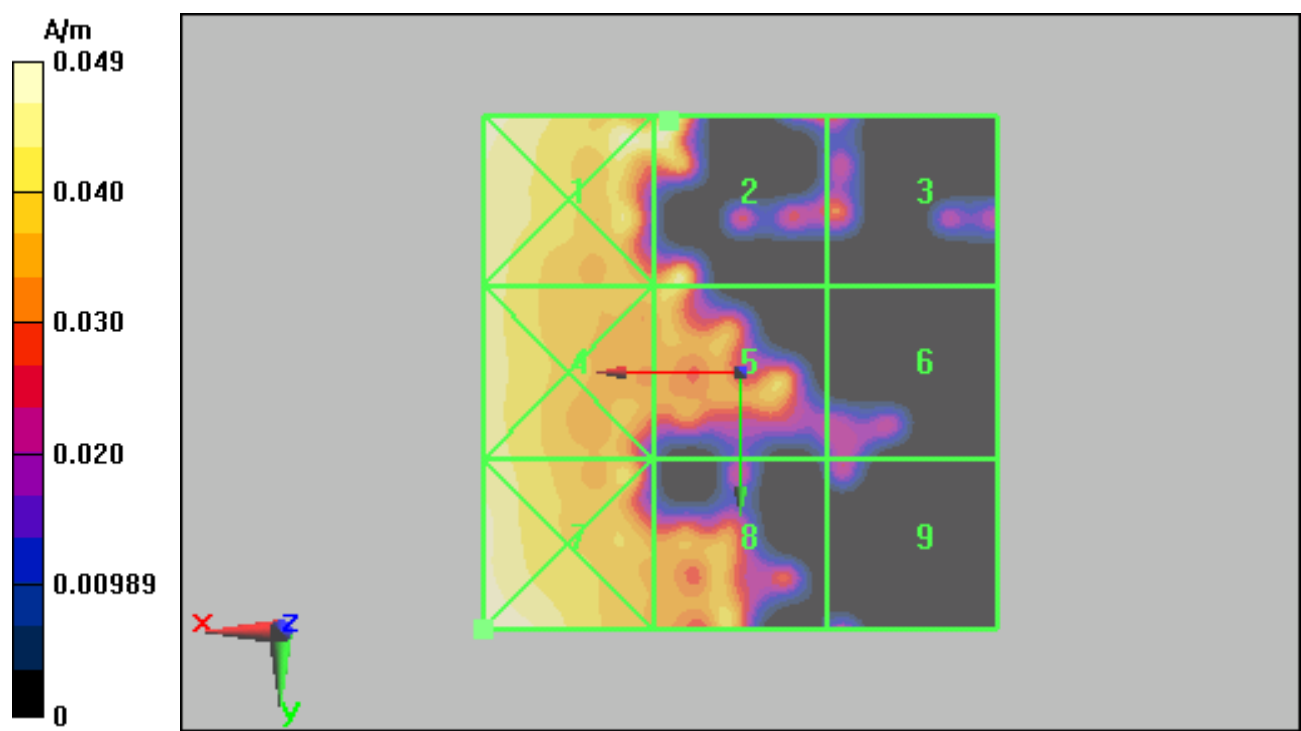


Figure 17 HAC RF H-Field GSM 850 Channel 128

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HAC RF E-Field GSM 850 High(Battery 2)

Date/Time: 8/20/2013 1:30:15 PM

Communication System: GSM; Frequency: 848.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 29.9 V/m

Probe Modulation Factor = 2.81

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 8.67 V/m; Power Drift = -0.035 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
24.1 M4	26.3 M4	26.4 M4
Grid 4	Grid 5	Grid 6
23.6 M4	25.6 M4	29.9 M4
Grid 7	Grid 8	Grid 9
30.3 M4	23.5 M4	24.6 M4

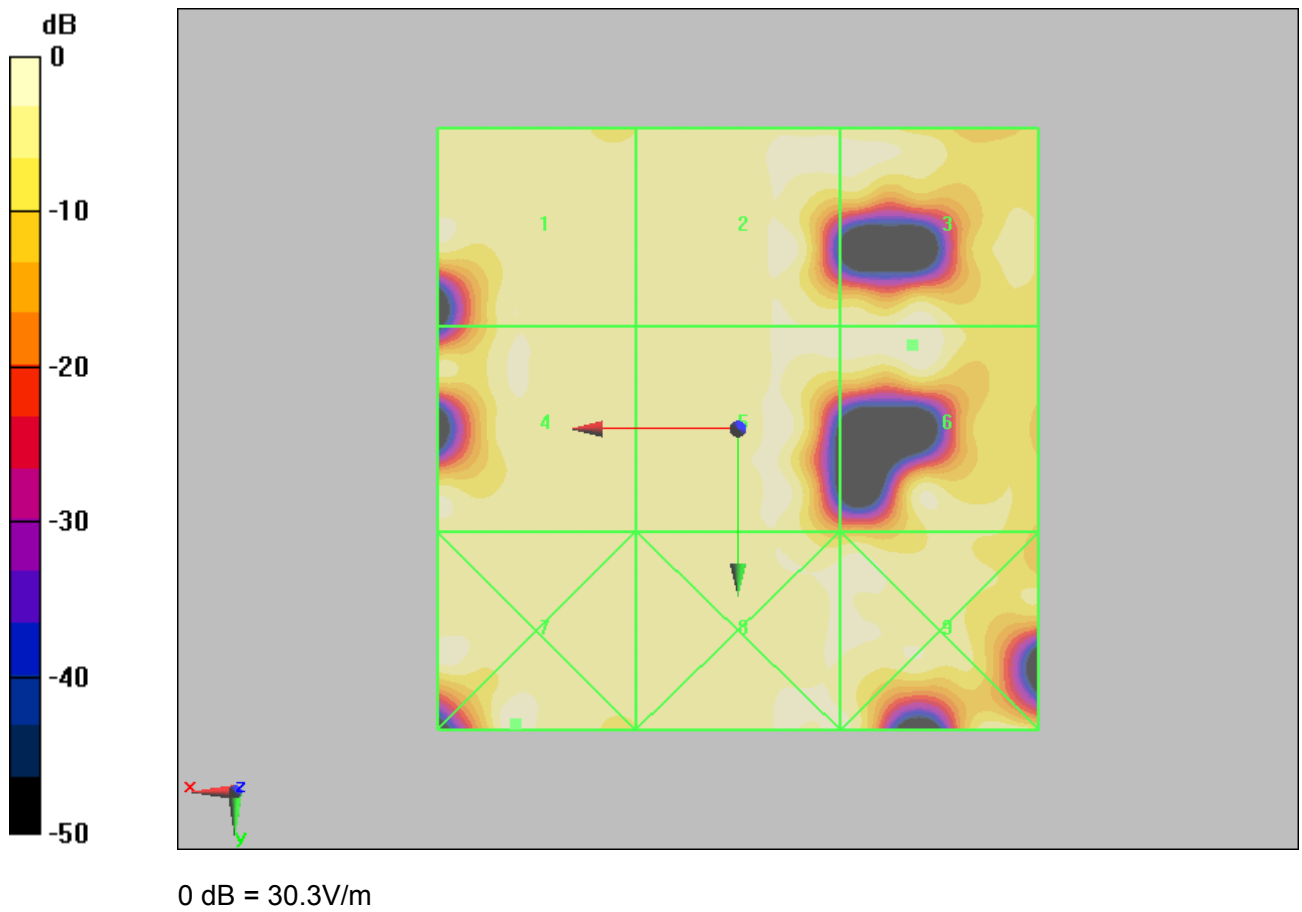


Figure 18 HAC RF E-Field GSM 850 Channel 251

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HAC RF E-Field GSM 850 Middle(Battery 2)

Date/Time: 8/20/2013 1:16:13 PM

Communication System: GSM; Frequency: 836.6 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**GSM850 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 31.9 V/m

Probe Modulation Factor = 2.81

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 8.24 V/m; Power Drift = 0.027 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
29.7 M4	31.9 M4	17.9 M4
Grid 4	Grid 5	Grid 6
30.4 M4	23 M4	21.1 M4
Grid 7	Grid 8	Grid 9
32.3 M4	32.3 M4	19.2 M4

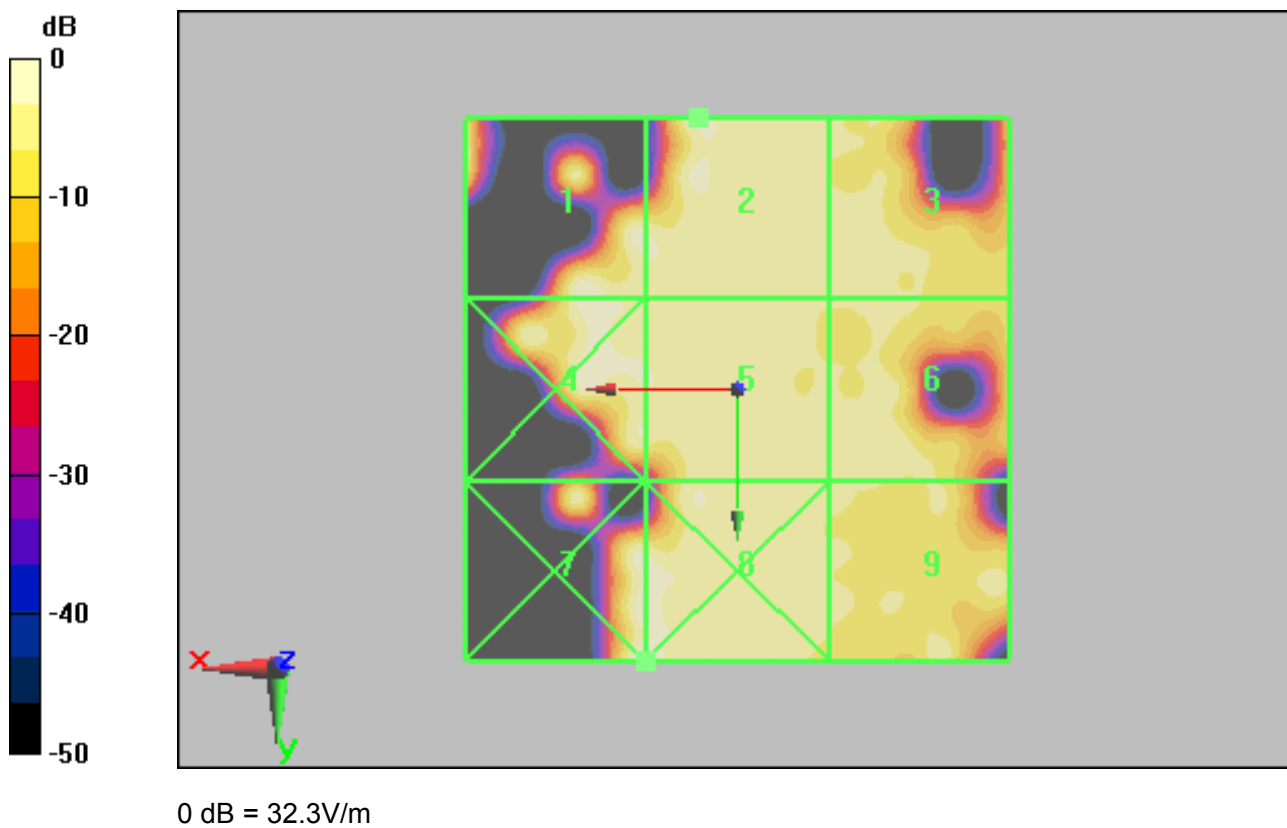


Figure 19 HAC RF E-Field GSM 850 Channel 190

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HAC RF E-Field GSM 850 Low(Battery 2)

Date/Time: 8/20/2013 1:36:26 PM

Communication System: GSM; Frequency: 824.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 30.7 V/m

Probe Modulation Factor = 2.81

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 8.72 V/m; Power Drift = 0.017 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
20.2 M4	22.8 M4	30.9 M4
Grid 4	Grid 5	Grid 6
18.4 M4	25.9 M4	33.1 M4
Grid 7	Grid 8	Grid 9
19.1 M4	30.7 M4	30.7 M4

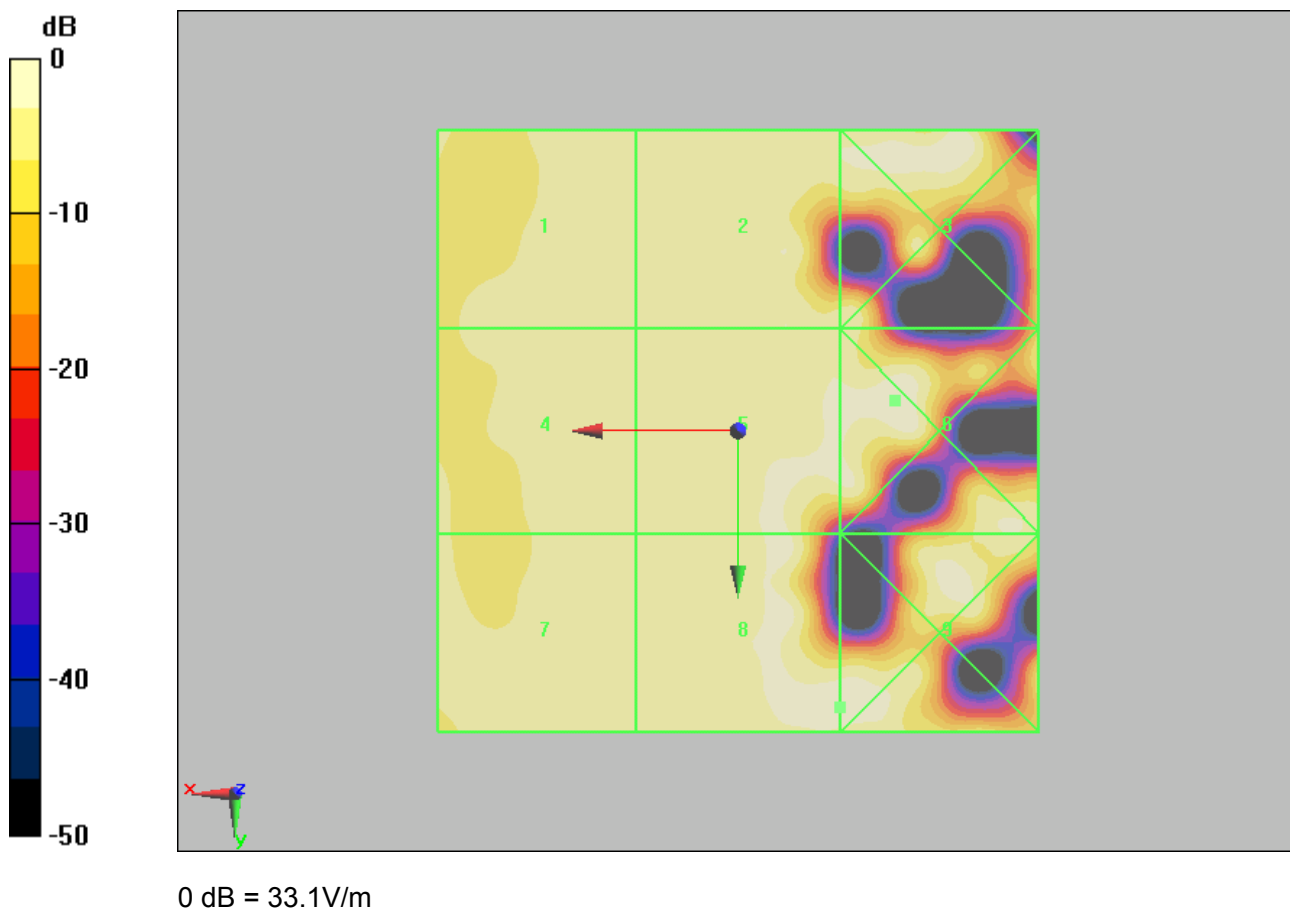


Figure 20 HAC RF E-Field GSM 850 Channel 128

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HAC RF H-Field GSM 850 High(Battery 2)

Date/Time: 8/20/2013 7:29:54 PM

Communication System: GSM; Frequency: 848.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.120 A/m

Probe Modulation Factor = 2.75

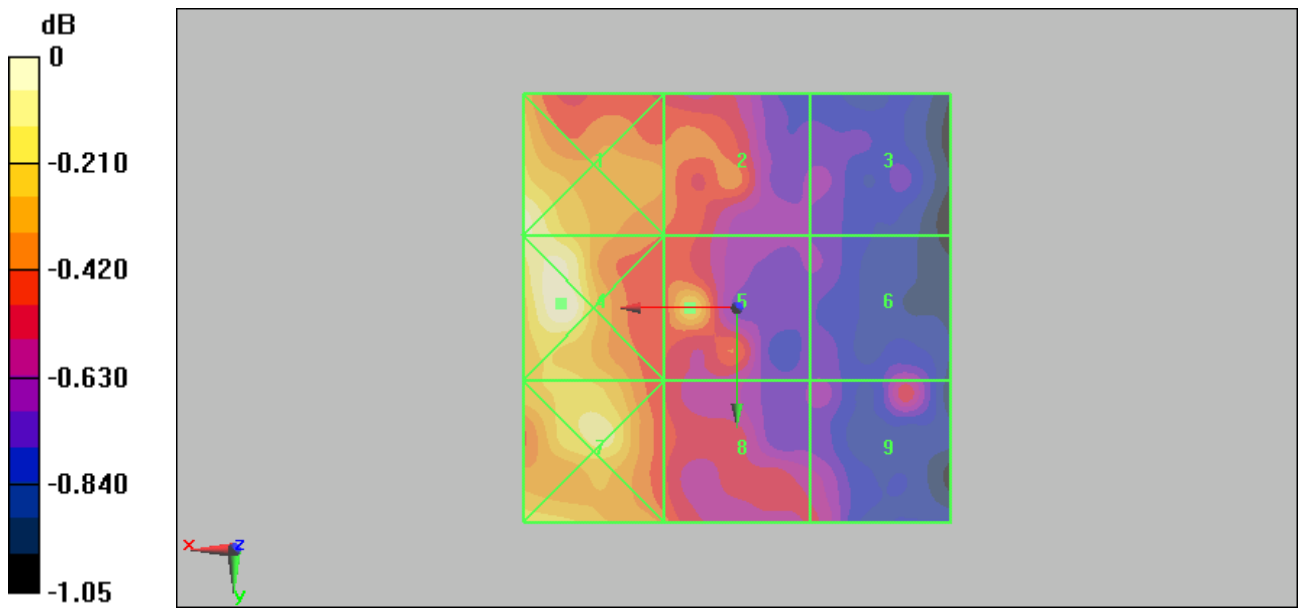
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.043 A/m; Power Drift = -0.018 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.123 M4	Grid 2 0.118 M4	Grid 3 0.114 M4
Grid 4 0.123 M4	Grid 5 0.120 M4	Grid 6 0.115 M4
Grid 7 0.122 M4	Grid 8 0.118 M4	Grid 9 0.116 M4



0 dB = 0.123A/m

Figure 21 HAC RF H-Field GSM 850Channel 251

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HAC RF H-Field GSM 850 Middle(Battery 2)

Date/Time: 8/20/2013 7:45:15 PM

Communication System: GSM; Frequency: 836.6 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.130 A/m

Probe Modulation Factor = 2.75

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.048 A/m; Power Drift = -0.082 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.136 M4	Grid 2 0.128 M4	Grid 3 0.123 M4
Grid 4 0.136 M4	Grid 5 0.128 M4	Grid 6 0.123 M4
Grid 7 0.134 M4	Grid 8 0.130 M4	Grid 9 0.123 M4

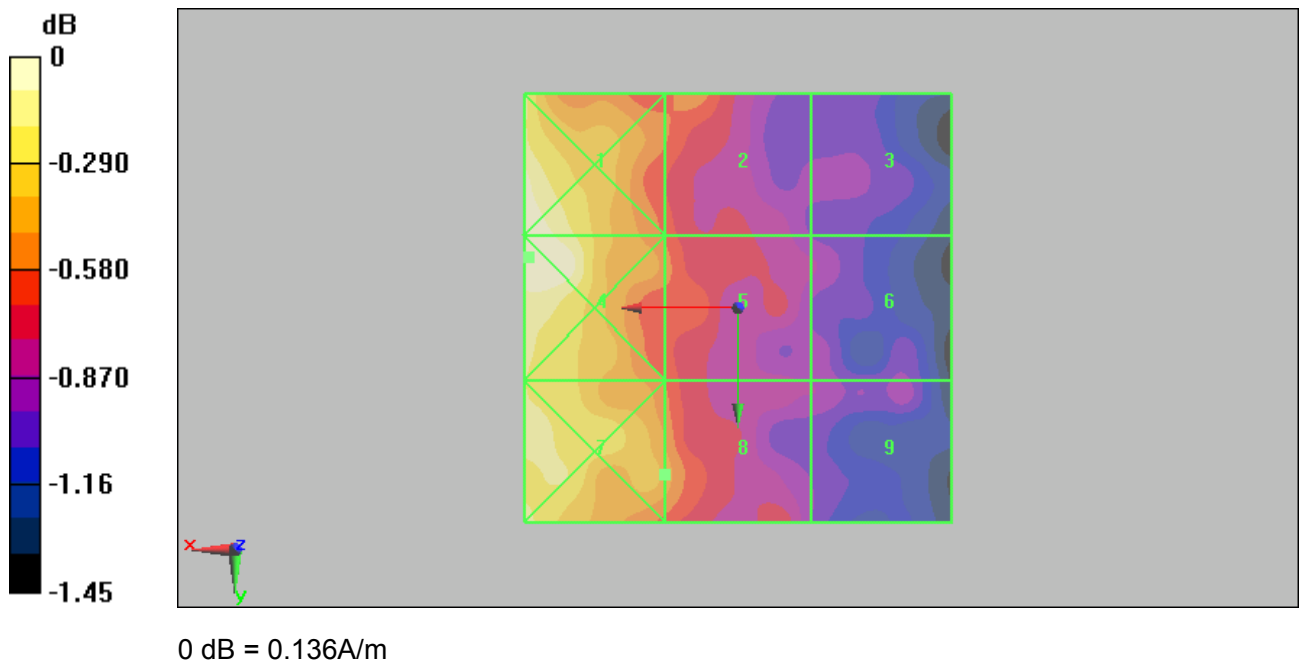


Figure 22 HAC RF H-Field GSM 850 Channel 190

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HAC RF H-Field GSM 850 Low(Battery 2)

Date/Time: 8/20/2013 8:07:35 PM

Communication System: GSM; Frequency: 824.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C Liquid Temperature: 21.5 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM850 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.120 A/m

Probe Modulation Factor = 2.75

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.043 A/m; Power Drift = -0.030 dB

Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.123 M4	Grid 2 0.120 M4	Grid 3 0.115 M4
Grid 4 0.122 M4	Grid 5 0.119 M4	Grid 6 0.116 M4
Grid 7 0.121 M4	Grid 8 0.119 M4	Grid 9 0.116 M4

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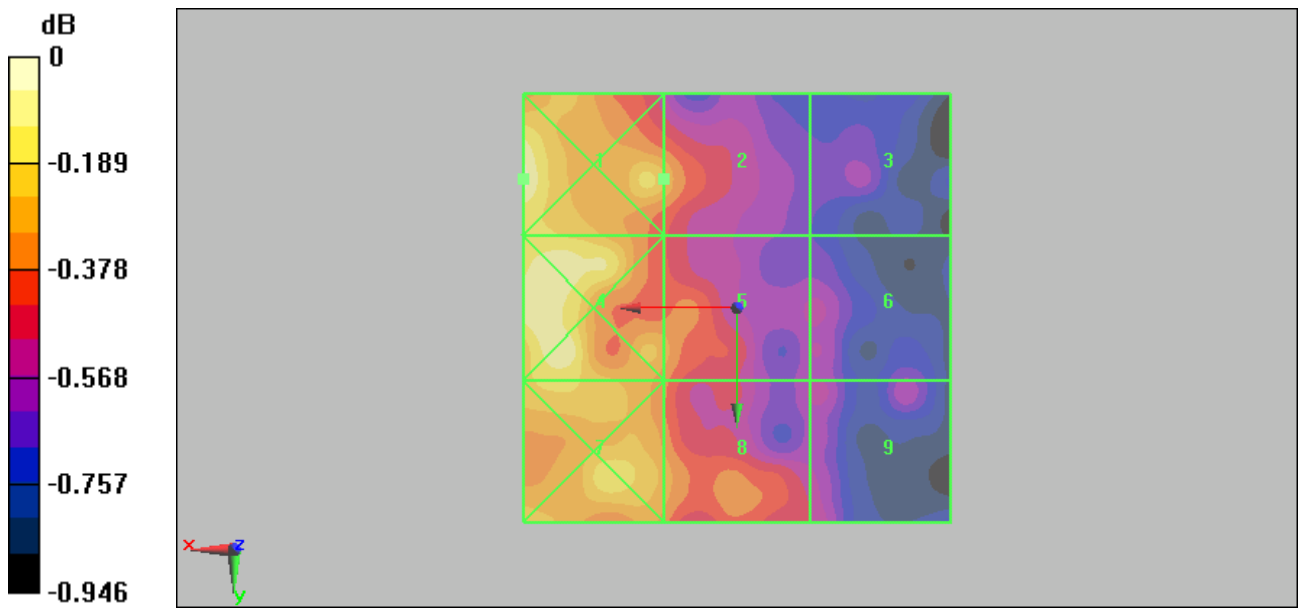


Figure 23 HAC RF H-Field GSM 850 Channel 128

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HAC RF E-Field GSM 1900 High(Battery 1)

Date/Time: 8/21/2013 3:40:15 AM

Communication System: GSM; Frequency: 1909.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High /Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 80.9 V/m

Probe Modulation Factor = 2.84

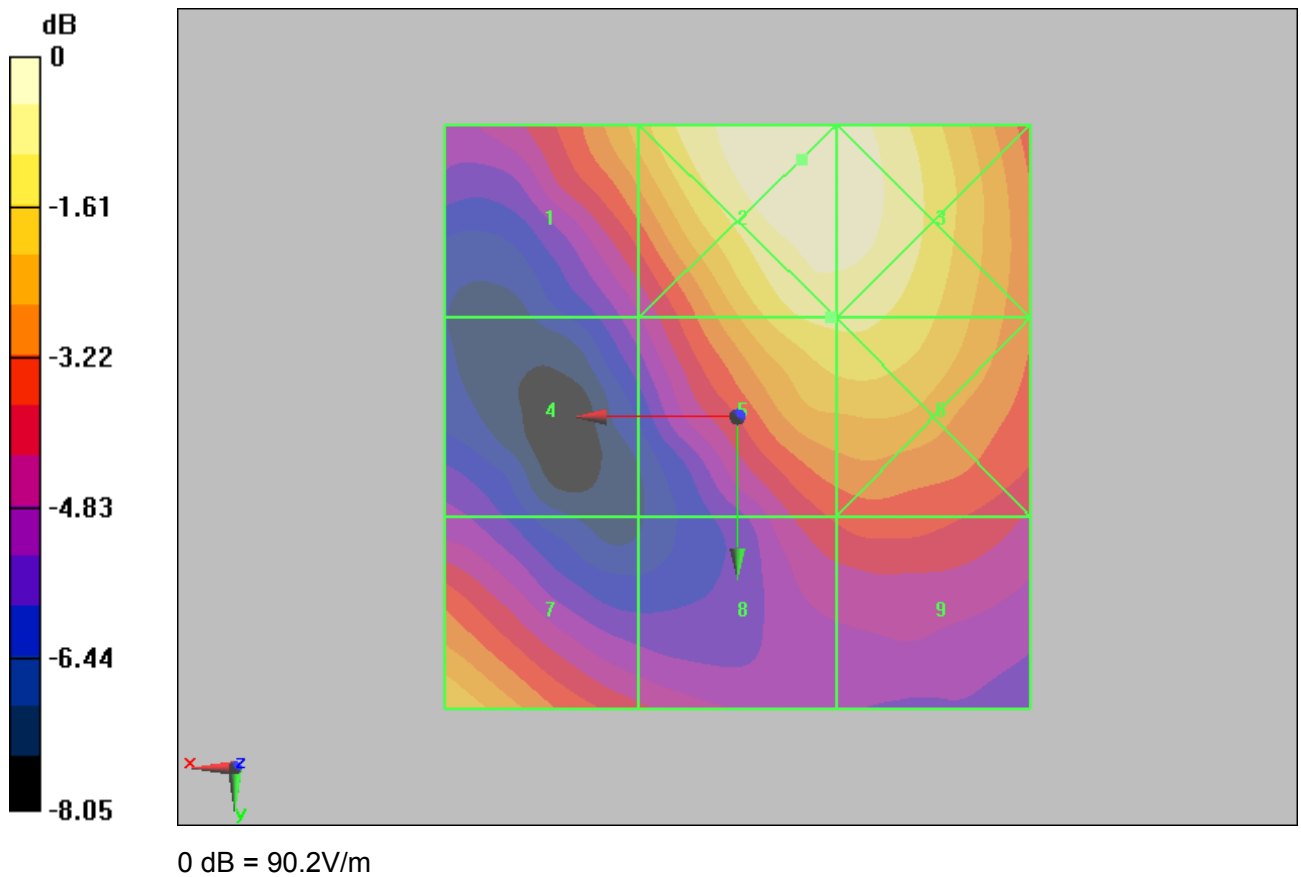
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.1 V/m; Power Drift = 0.028 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
72.5 M3	90.2 M2	88.9 M2
Grid 4	Grid 5	Grid 6
51.4 M3	80.9 M3	80.9 M3
Grid 7	Grid 8	Grid 9
75.4 M3	59.3 M3	60.7 M3



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HAC RF E-Field GSM 1900 Middle(Battery 1)

Date/Time: 8/21/2013 4:10:05 AM

Communication System: GSM; Frequency: 1880 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**GSM1900 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle /Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 80.7 V/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 26.6 V/m; Power Drift = -0.047 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
72.9 M3	86.5 M2	85.3 M2
Grid 4	Grid 5	Grid 6
54.6 M3	80.7 M3	80.7 M3
Grid 7	Grid 8	Grid 9
70.5 M3	62.3 M3	63.4 M3

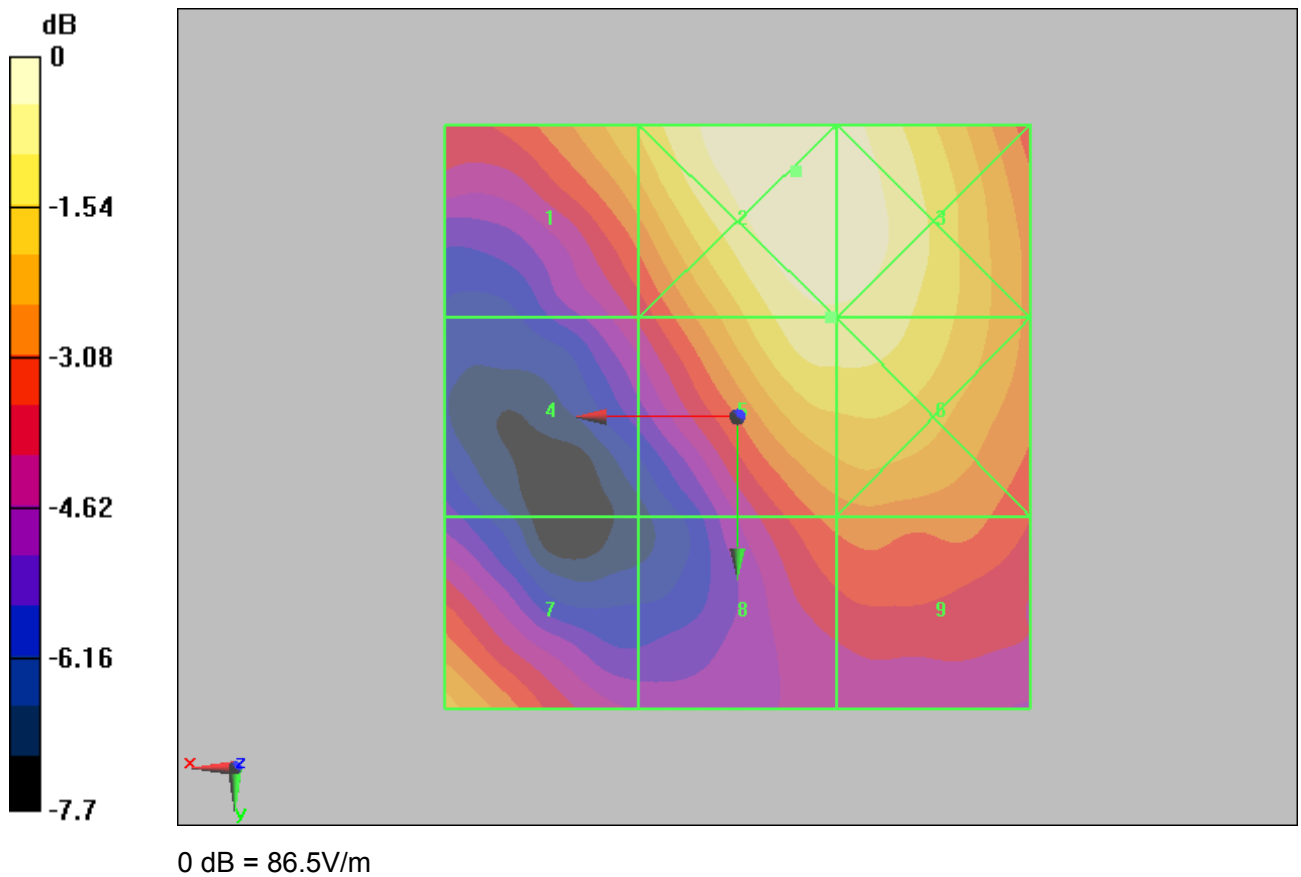


Figure 25 HAC RF E-Field GSM 1900 Channel 661

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HAC RF E-Field GSM 1900 Low(Battery 1)

Date/Time: 4/21/2013 4:33:49 AM

Communication System: GSM; Frequency: 1850.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 80.6 V/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 28.4 V/m; Power Drift = 0.011 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
75.7 M3	86.8 M2	85.2 M2
Grid 4	Grid 5	Grid 6
60.1 M3	80.6 M3	80.2 M3
Grid 7	Grid 8	Grid 9
67 M3	64.5 M3	64.6 M3

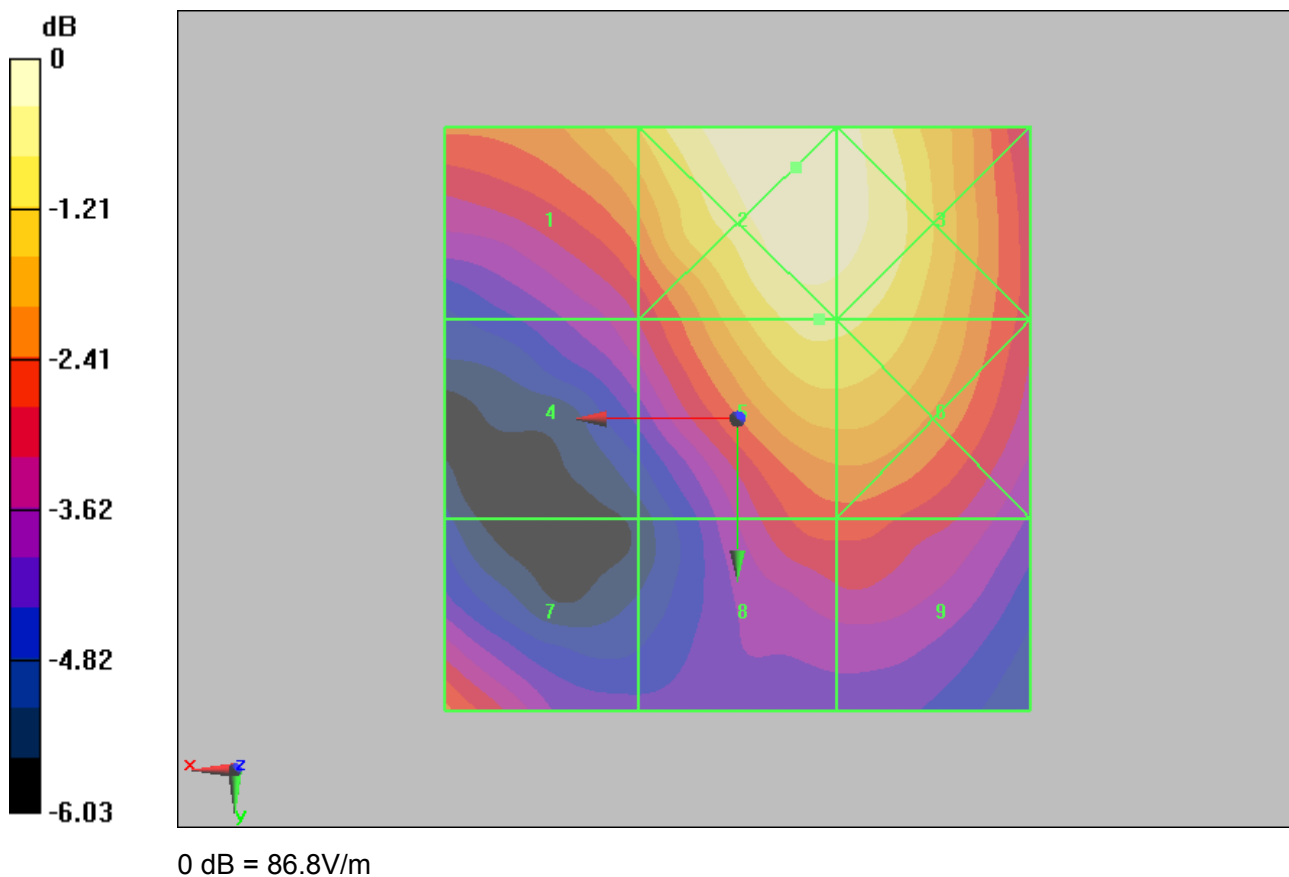


Figure 26 HAC RF E-Field GSM 1900 Channel 512

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HAC RF H-Field GSM 1900 High(Battery 1)

Date/Time: 8/21/2013 11:02:58 AM

Communication System: GSM; Frequency: 1909.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.226 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.078 A/m; Power Drift = 0.027 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.269 M2	Grid 2 0.219 M3	Grid 3 0.169 M3
Grid 4 0.226 M3	Grid 5 0.221 M3	Grid 6 0.205 M3
Grid 7 0.225 M3	Grid 8 0.226 M3	Grid 9 0.210 M3

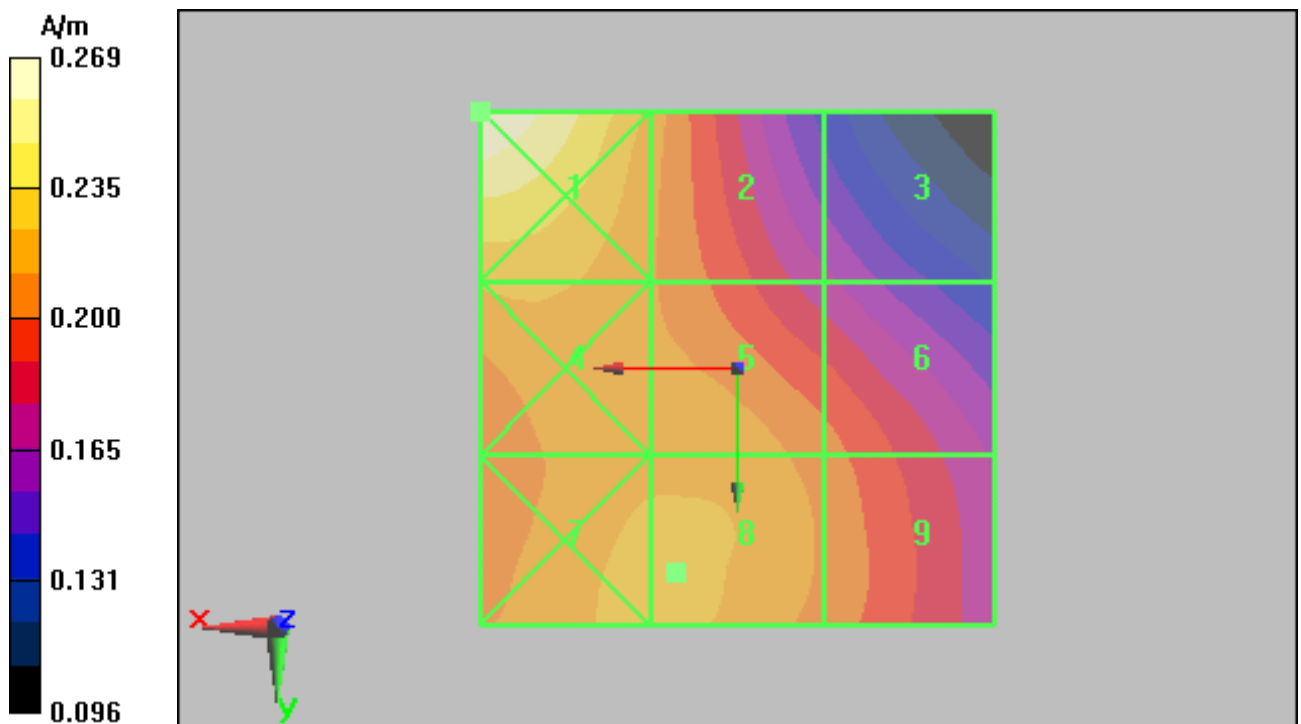


Figure 27 HAC RF H-Field GSM 1900 Channel 810

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HAC RF H-Field GSM 1900 Middle(Battery 1)

Date/Time: 8/21/2013 11:25:09 AM

Communication System: GSM; Frequency: 1880 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**GSM1900 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.232 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.075 A/m; Power Drift = -0.142 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.262 M2	Grid 2 0.207 M3	Grid 3 0.156 M3
Grid 4 0.224 M3	Grid 5 0.217 M3	Grid 6 0.196 M3
Grid 7 0.231 M3	Grid 8 0.232 M3	Grid 9 0.208 M3

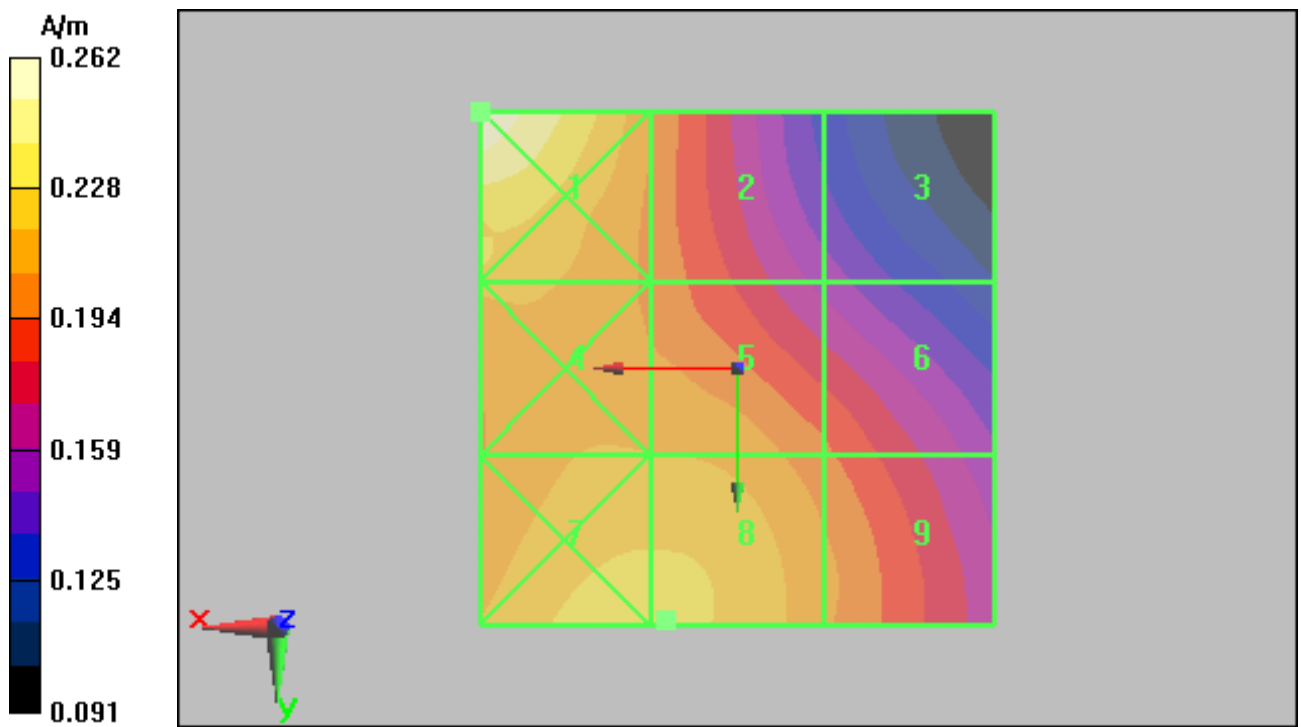


Figure 28 HAC RF H-Field GSM 1900 Channel 661

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HAC RF H-Field GSM 1900 Low(Battery 1)

Date/Time: 8/21/2013 11:47:49 AM

Communication System: GSM; Frequency: 1850.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.219 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.066 A/m; Power Drift = 0.002 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.250 M2	Grid 2 0.199 M3	Grid 3 0.139 M4
Grid 4 0.215 M3	Grid 5 0.204 M3	Grid 6 0.176 M3
Grid 7 0.224 M3	Grid 8 0.219 M3	Grid 9 0.188 M3

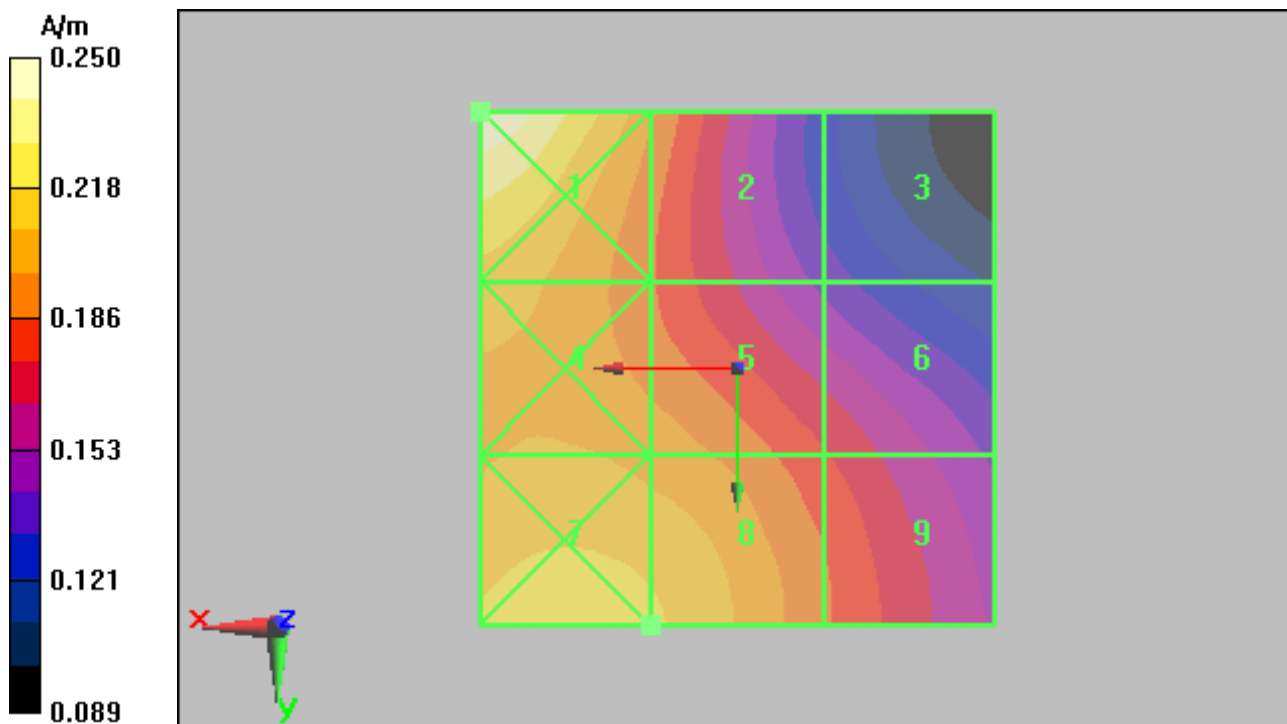


Figure 29 HAC RF H-Field GSM 1900 Channel 512

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HAC RF E-Field GSM 1900 High(Battery 2)

Date/Time: 8/21/2013 4:53:47 AM

Communication System: GSM; Frequency: 1909.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 75.8 V/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 18.2 V/m; Power Drift = -0.071 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
75.8 M3	75.6 M3	85.1 M2
Grid 4	Grid 5	Grid 6
71.9 M3	65.3 M3	84 M3
Grid 7	Grid 8	Grid 9
65.3 M3	59.4 M3	68.1 M3

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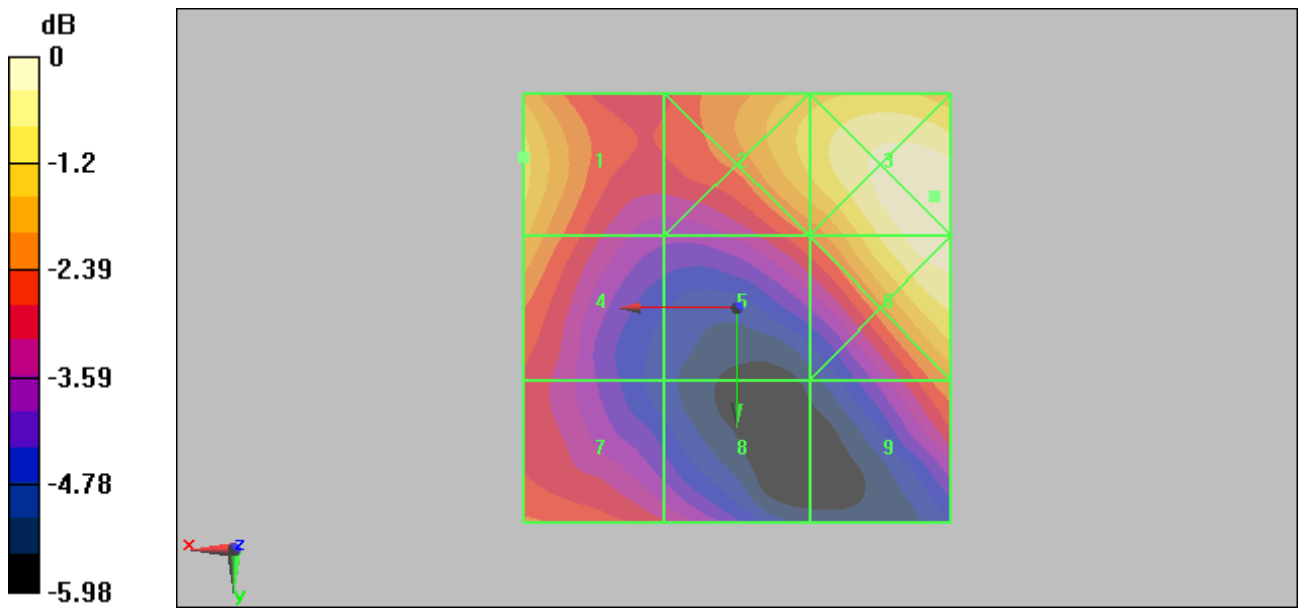


Figure 30 HAC RF E-Field GSM 1900 Channel 810

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HAC RF E-Field GSM 1900 Middle(Battery 2)

Date/Time: 8/21/2013 5:17:06 AM

Communication System: GSM; Frequency: 1880 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**GSM1900 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 80.4 V/m

Probe Modulation Factor = 2.84

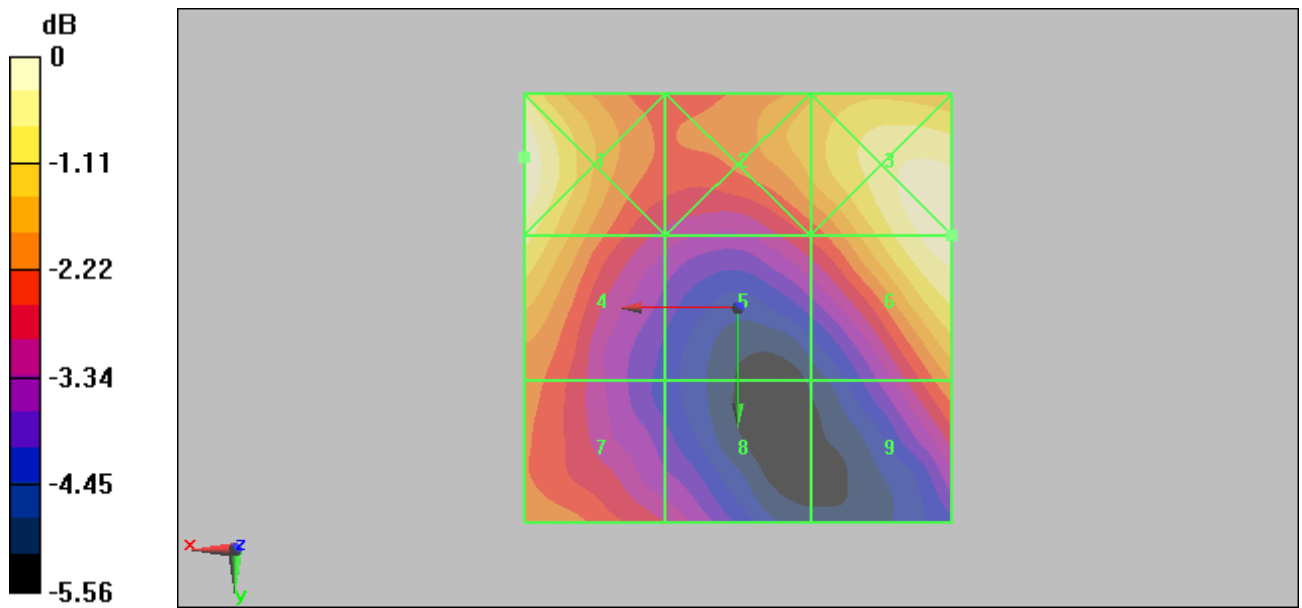
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 18 V/m; Power Drift = -0.055 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1 81.8 M3	Grid 2 70.7 M3	Grid 3 80.7 M3
Grid 4 76.8 M3	Grid 5 61.5 M3	Grid 6 80.4 M3
Grid 7 65.8 M3	Grid 8 58.2 M3	Grid 9 66.5 M3



0 dB = 81.8V/m

Figure 31 HAC RF E-Field GSM 1900 Channel 661

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HAC RF E-Field GSM 1900 Low(Battery 2)

Date/Time: 8/21/2013 5:40:55 AM

Communication System: GSM; Frequency: 1850.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 83 V/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 18.4 V/m; Power Drift = 0.063 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m

Grid 1 86.3 M2	Grid 2 71.7 M3	Grid 3 83.9 M3
Grid 4 82.6 M3	Grid 5 61.6 M3	Grid 6 83 M3
Grid 7 70.4 M3	Grid 8 62.5 M3	Grid 9 68.1 M3

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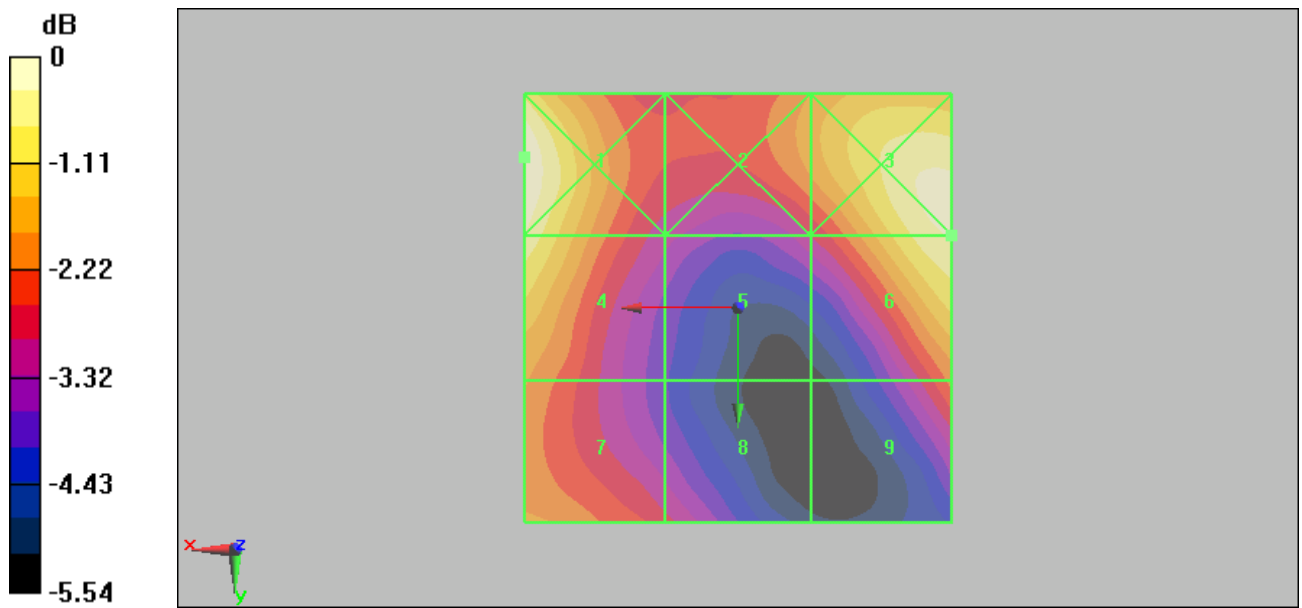


Figure 32 HAC RF E-Field GSM 1900 Channel 512

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HAC RF H-Field GSM 1900 High(Battery 2)

Date/Time: 8/21/2013 12:49:43 PM

Communication System: GSM; Frequency: 1909.8 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.244 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.083 A/m; Power Drift = -0.074 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.255 M2	0.254 M2	0.216 M3
Grid 4	Grid 5	Grid 6
0.244 M3	0.244 M3	0.215 M3
Grid 7	Grid 8	Grid 9
0.193 M3	0.203 M3	0.208 M3

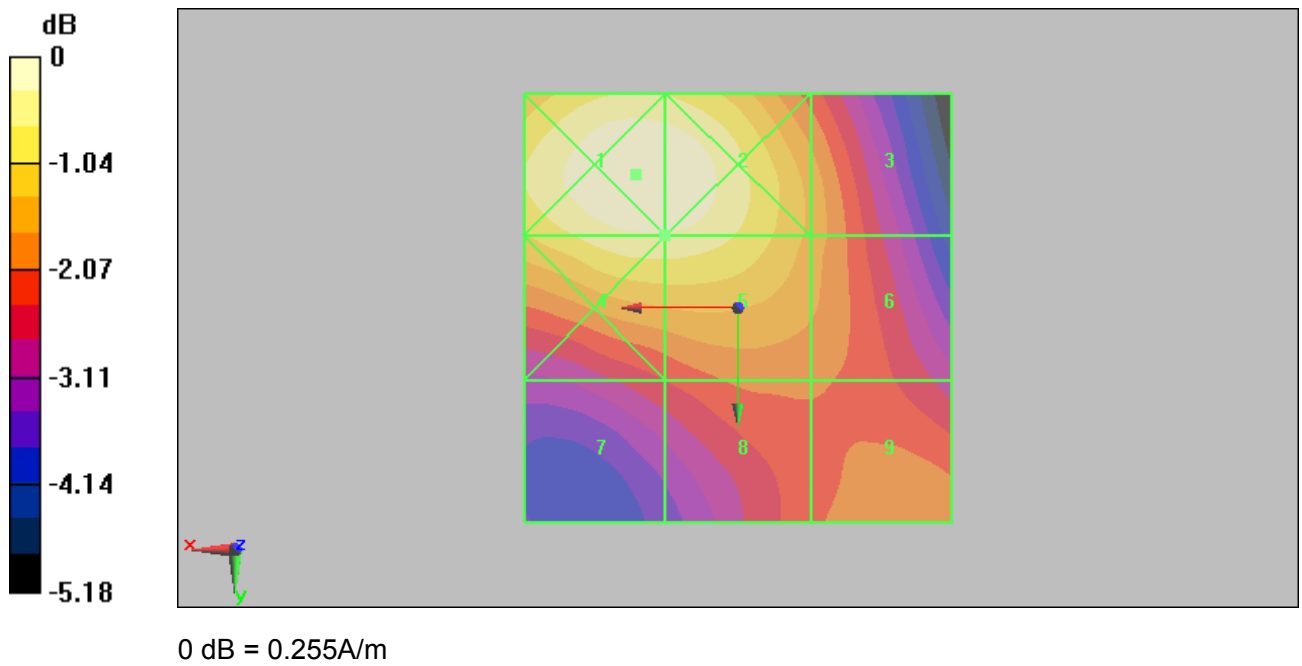


Figure 33 HAC RF H-Field GSM 1900 Channel 810

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HAC RF H-Field GSM 1900 Middle(Battery 2)

Date/Time: 8/21/2013 1:18:42 PM

Communication System: GSM; Frequency: 1880 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.234 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.080 A/m; Power Drift = -0.124 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.245 M3	0.245 M3	0.216 M3
Grid 4	Grid 5	Grid 6
0.234 M3	0.234 M3	0.214 M3
Grid 7	Grid 8	Grid 9
0.184 M3	0.197 M3	0.200 M3

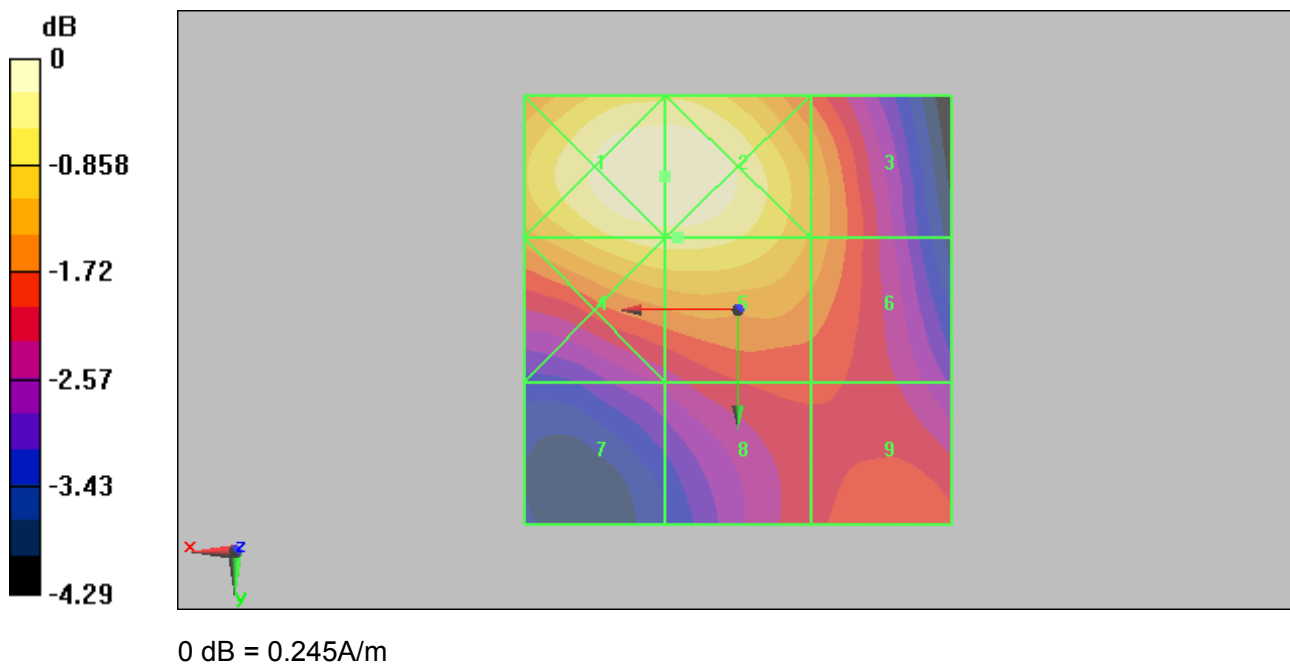


Figure 34 HAC RF H-Field GSM 1900 Channel 661

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HAC RF H-Field GSM 1900 Low(Battery 2)

Date/Time: 8/21/2013 1:31:32 PM

Communication System: GSM; Frequency: 1850.2 MHz; Duty Cycle: 1:8.30042

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature: 22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

GSM1900 HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.247 A/m

Probe Modulation Factor = 2.84

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.084 A/m; Power Drift = -0.090 dB

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1	Grid 2	Grid 3
0.257 M2	0.258 M2	0.232 M3
Grid 4	Grid 5	Grid 6
0.245 M3	0.247 M3	0.229 M3
Grid 7	Grid 8	Grid 9
0.188 M3	0.202 M3	0.201 M3

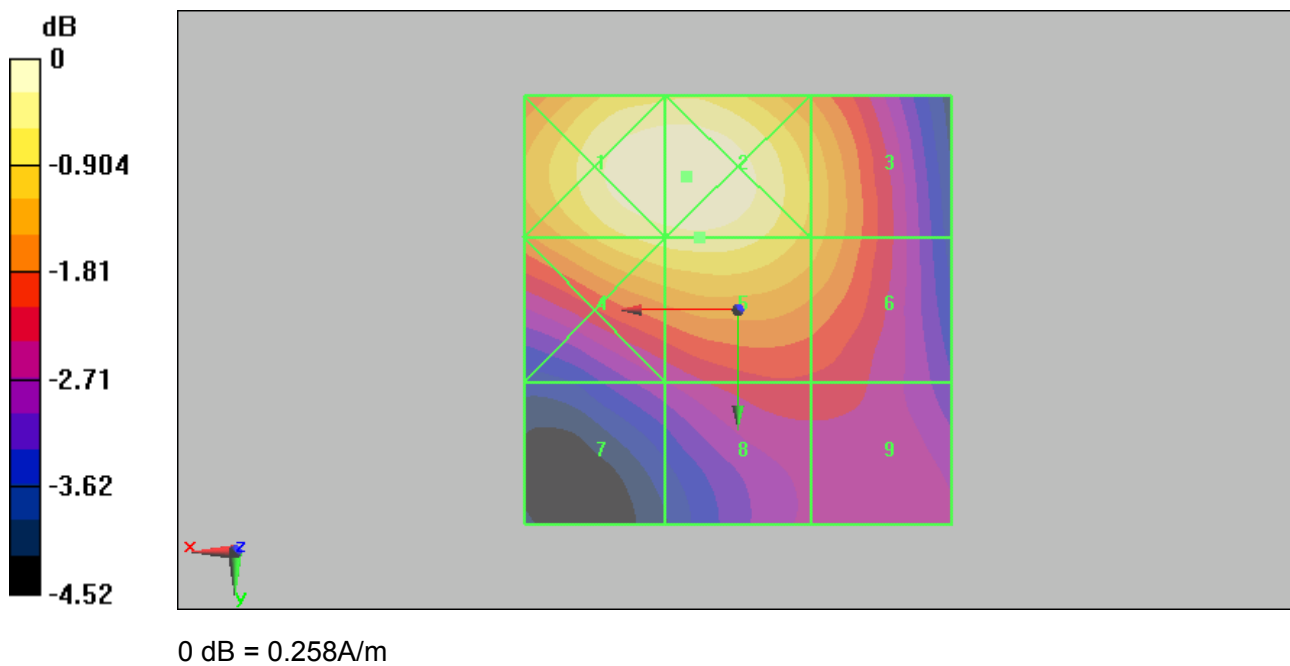


Figure 35 HAC RF H-Field GSM 1900 Channel 512

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HAC RF E-Field WCDMA Band II High(Battery 1)

Date/Time: 8/21/2013 5:51:27 AM

Communication System: WCDMA ; Frequency: 1907.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 36.7 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 31.7 V/m; Power Drift = 0.012 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
33.1 M4	40.8 M4	40.3 M4
Grid 4	Grid 5	Grid 6
23.5 M4	36.7 M4	36.7 M4
Grid 7	Grid 8	Grid 9
34.1 M4	27.1 M4	27.8 M4

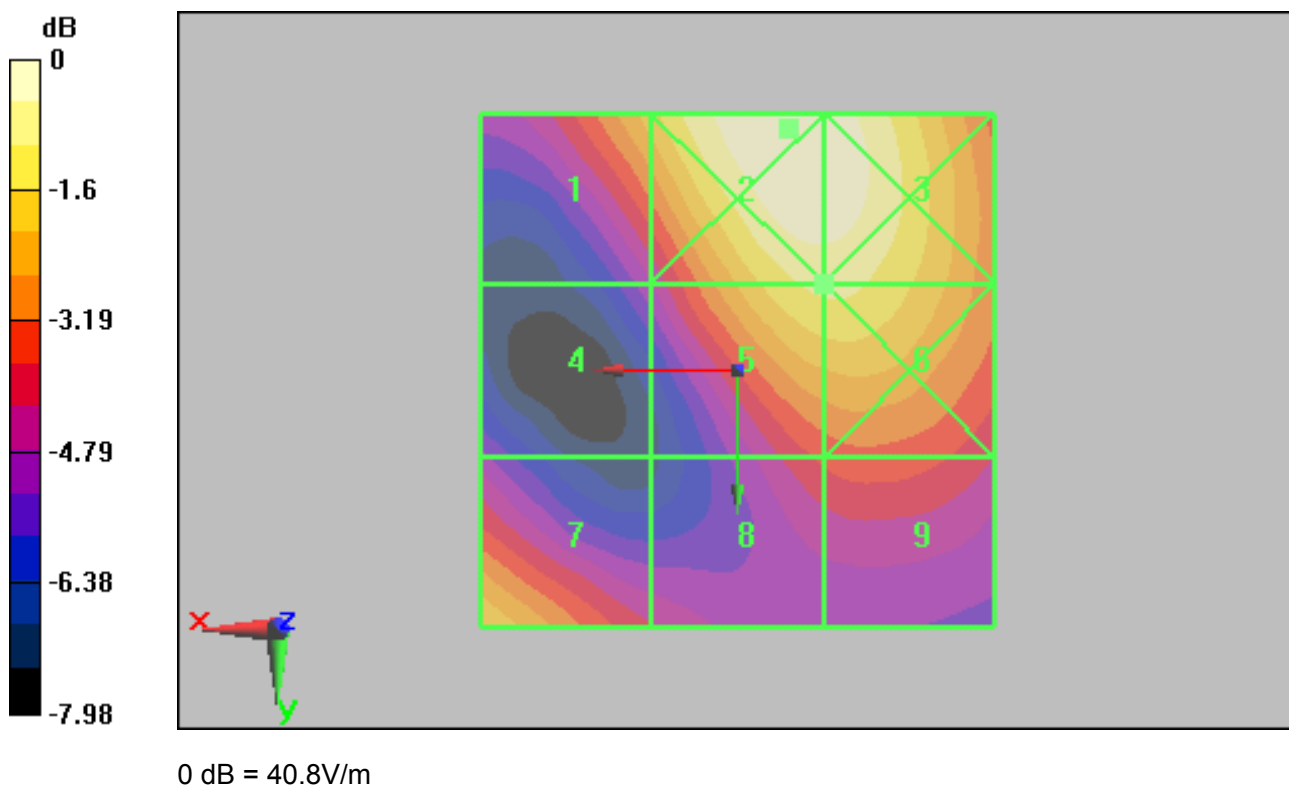


Figure 36 HAC RF E-Field WCDMA Band II Channel 9538

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HAC RF E-Field WCDMA Band II Middle(Battery 1)

Date/Time: 8/21/2013 6:19:08 AM

Communication System: WCDMA ; Frequency: 1880 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**WCDMA II HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 36.3 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 33.2 V/m; Power Drift = -0.100 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
32.8 M4	39.1 M4	38.7 M4
Grid 4	Grid 5	Grid 6
24.1 M4	36.3 M4	36.3 M4
Grid 7	Grid 8	Grid 9
31.4 M4	27.8 M4	28.6 M4

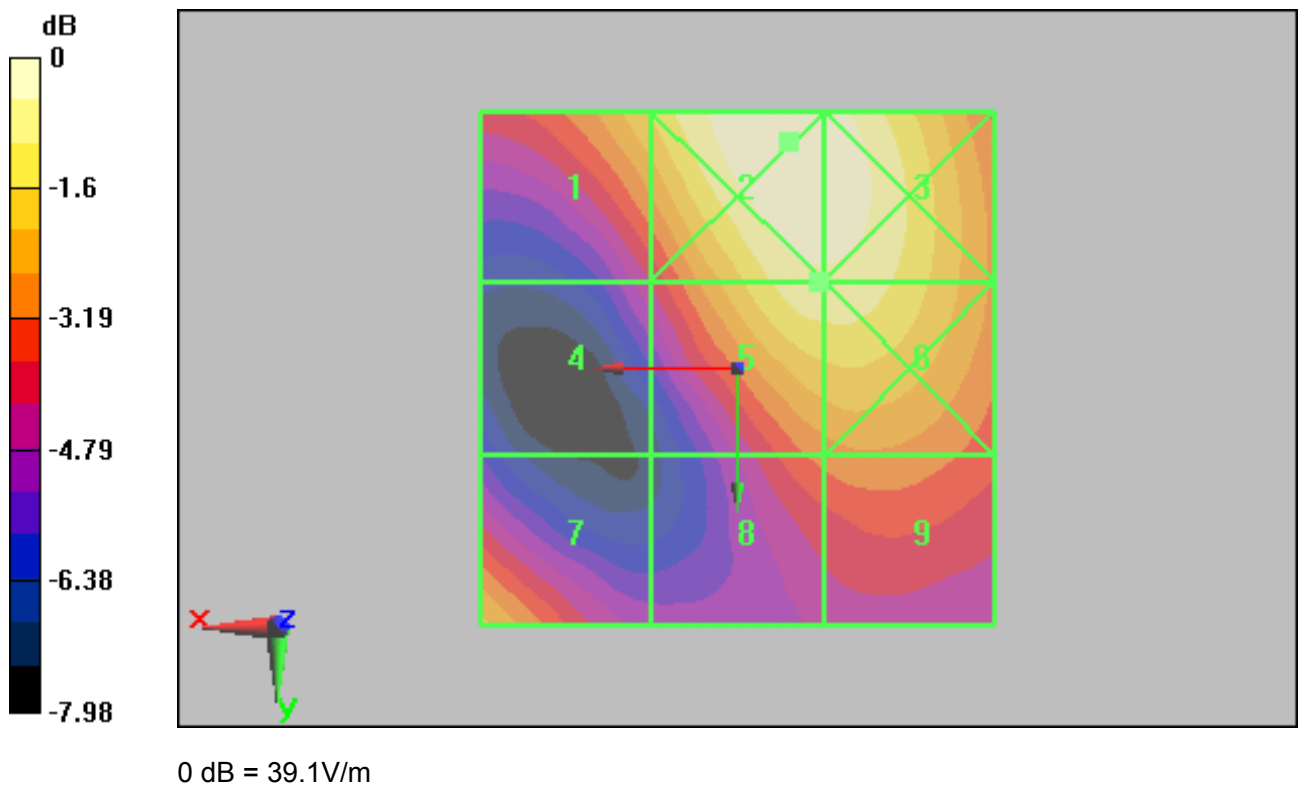


Figure 37 HAC RF E-Field WCDMA Band II Channel 9400

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HAC RF E-Field WCDMA Band II Low(Battery 1)

Date/Time: 8/21/2013 6:30:13 AM

Communication System: WCDMA ; Frequency: 1852.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low 2/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 35.7 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 34.7 V/m; Power Drift = 0.009 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
33.7 M4	38.5 M4	37.8 M4
Grid 4	Grid 5	Grid 6
27 M4	35.7 M4	35.7 M4
Grid 7	Grid 8	Grid 9
30.4 M4	28.4 M4	28.5 M4

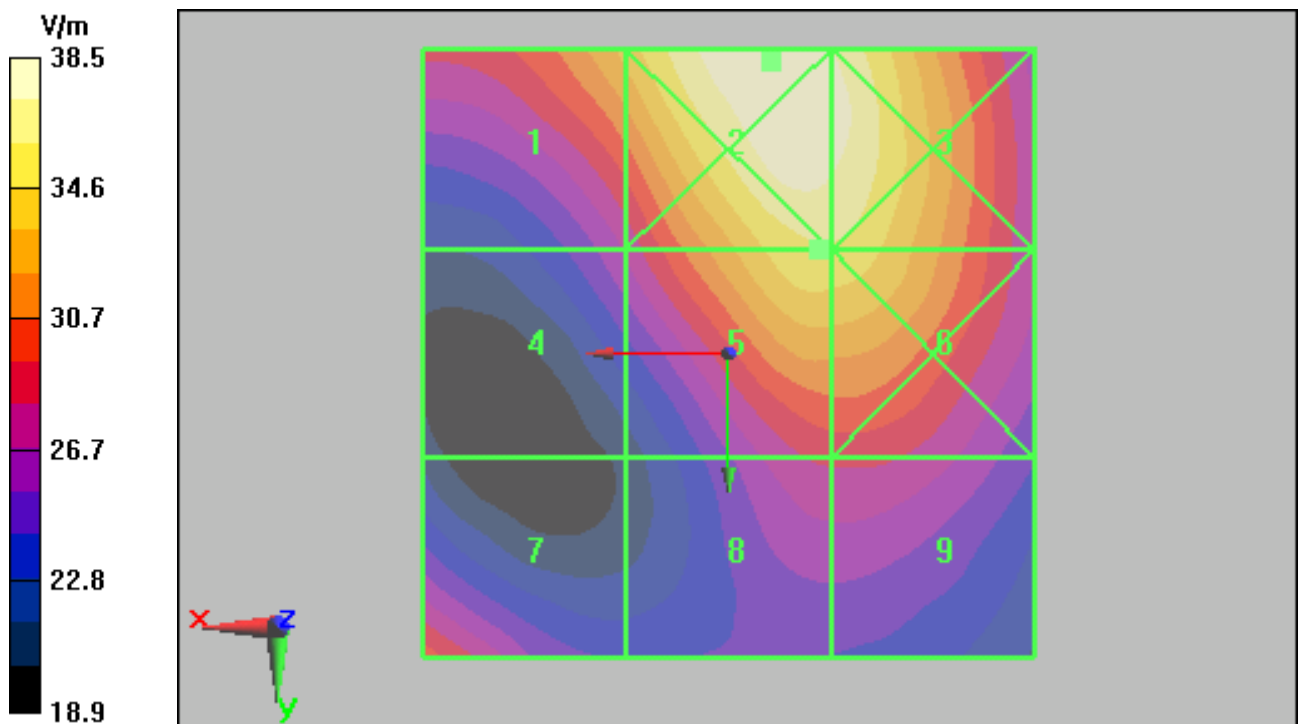


Figure 38 HAC RF E-Field WCDMA Band II Channel 9262

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HAC RF H-Field WCDMA Band II High(Battery 1)

Date/Time: 8/21/2013 1:49:43 PM

Communication System: WCDMA ; Frequency: 1907.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.100 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.097 A/m; Power Drift = 0.045 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.116 M4	Grid 2 0.096 M4	Grid 3 0.075 M4
Grid 4 0.099 M4	Grid 5 0.098 M4	Grid 6 0.091 M4
Grid 7 0.100 M4	Grid 8 0.100 M4	Grid 9 0.093 M4

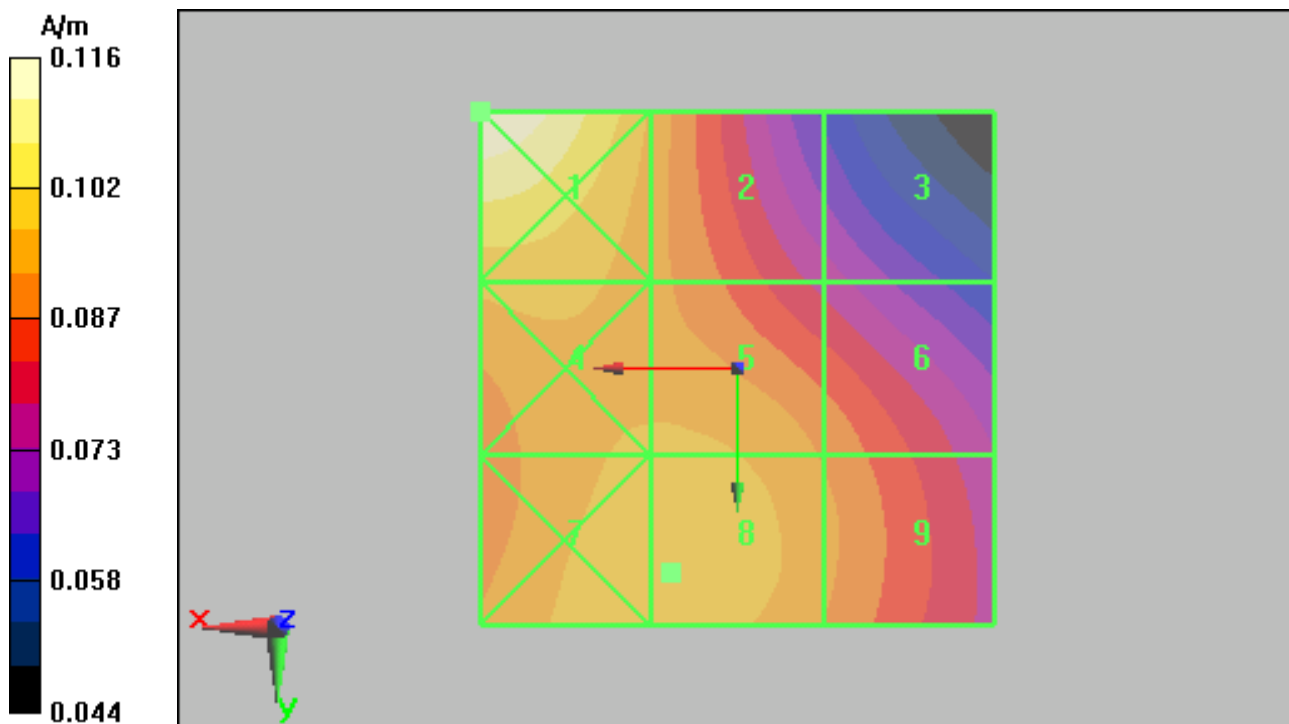


Figure 39 HAC RF H-Field WCDMA Band II Channel 9538

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HAC RF H-Field WCDMA Band II Middle(Battery 1)

Date/Time: 8/21/2013 2:15:36 PM

Communication System: WCDMA ; Frequency: 1880 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.101 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.091 A/m; Power Drift = -0.024 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.110 M4	Grid 2 0.090 M4	Grid 3 0.068 M4
Grid 4 0.095 M4	Grid 5 0.095 M4	Grid 6 0.086 M4
Grid 7 0.101 M4	Grid 8 0.101 M4	Grid 9 0.090 M4

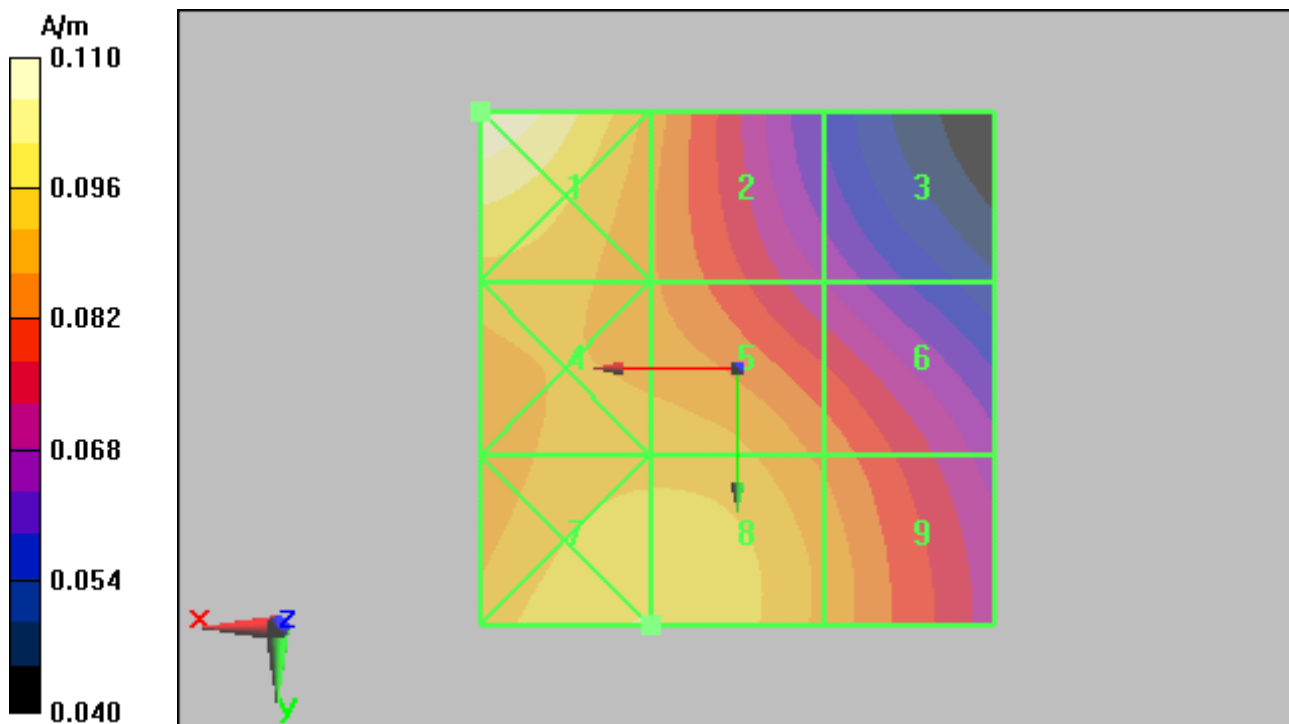


Figure 40 HAC RF H-Field WCDMA Band II Channel 9400

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HAC RF H-Field WCDMA Band II Low(Battery 1)

Date/Time: 8/21/2013 2:42:30 PM

Communication System: WCDMA ; Frequency: 1852.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.096 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.082 A/m; Power Drift = 0.003 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.108 M4	Grid 2 0.087 M4	Grid 3 0.062 M4
Grid 4 0.093 M4	Grid 5 0.089 M4	Grid 6 0.078 M4
Grid 7 0.099 M4	Grid 8 0.096 M4	Grid 9 0.083 M4

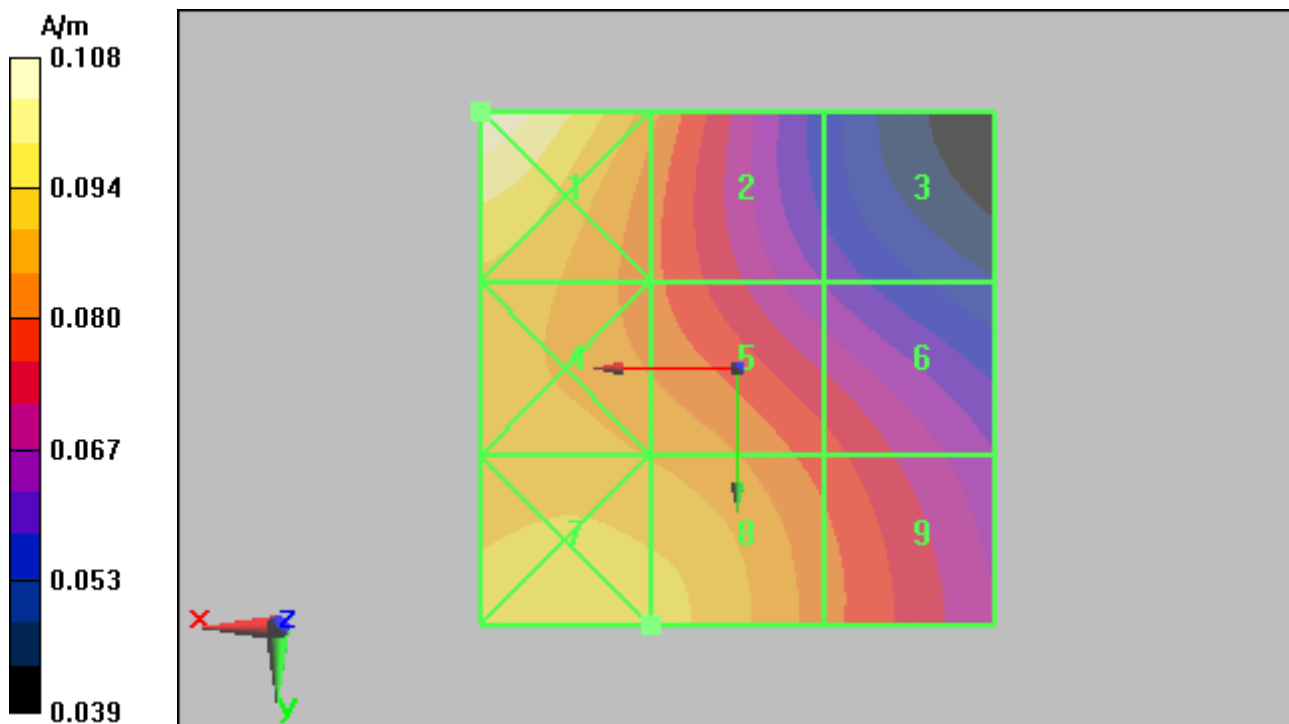


Figure 41 HAC RF H-Field WCDMA Band II Channel 9262

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HAC RF E-Field WCDMA Band II High(Battery 2)

Date/Time: 8/21/2013 6:49:03 AM

Communication System: WCDMA ; Frequency: 1907.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

5020T WCDMA II HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 37.2 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 29.5 V/m; Power Drift = -0.117 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
32.5 M4	41.6 M4	41.2 M4
Grid 4	Grid 5	Grid 6
23.9 M4	34.9 M4	34.9 M4
Grid 7	Grid 8	Grid 9
37.2 M4	27.5 M4	26 M4

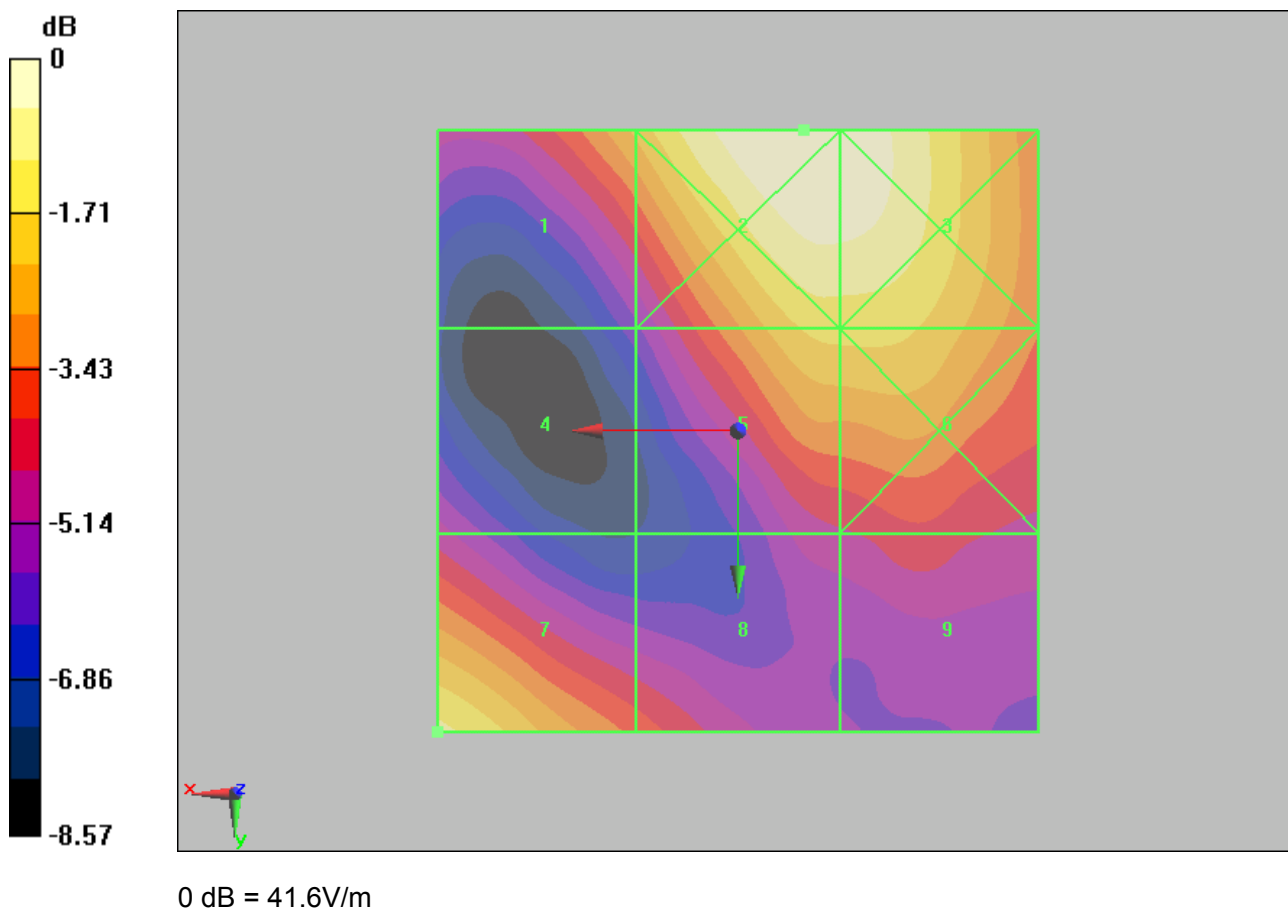


Figure 42 HAC RF E-Field WCDMA Band II Channel 9538

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HAC RF E-Field WCDMA Band II Middle(Battery 2)

Date/Time: 8/21/2013 7:01:49 AM

Communication System: WCDMA ; Frequency: 1880 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 36.2 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 28.3 V/m; Power Drift = -0.061 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

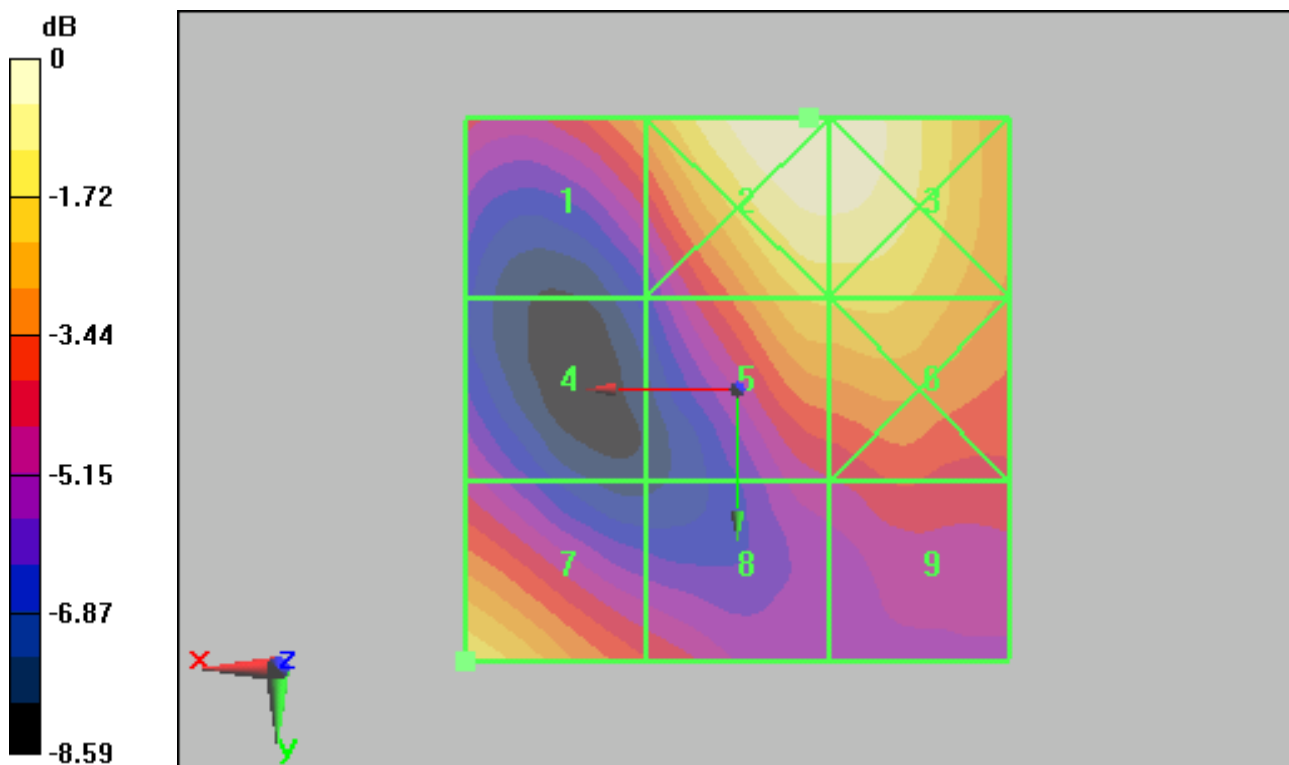
Peak E-field in V/m

Grid 1	Grid 2	Grid 3
31.5 M4	41.7 M4	41.6 M4
Grid 4	Grid 5	Grid 6
24.1 M4	34.6 M4	34.9 M4
Grid 7	Grid 8	Grid 9
36.2 M4	26.6 M4	26.5 M4

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0 dB = 41.7V/m

Figure 43 HAC RF E-Field WCDMA Band II Channel 9400

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HAC RF E-Field WCDMA Band II Low(Battery 2)

Date/Time: 8/21/2013 7:20:53 AM

Communication System: WCDMA ; Frequency: 1852.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low 2/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 35.9 V/m

Probe Modulation Factor = 1.03

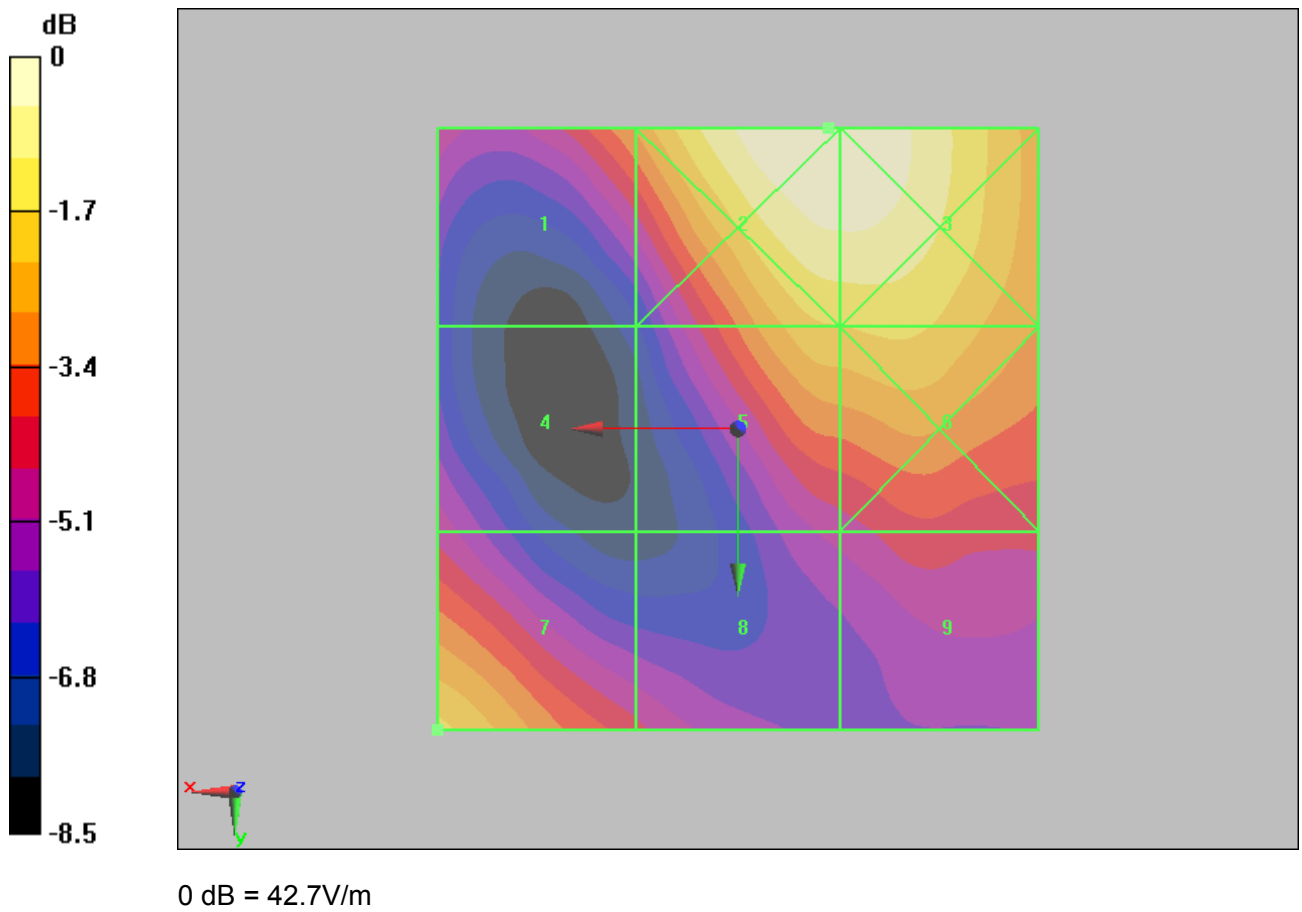
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 27.9 V/m; Power Drift = -0.136 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 31.1 M4	Grid 2 42.7 M4	Grid 3 42.6 M4
Grid 4 24.9 M4	Grid 5 35.1 M4	Grid 6 35.6 M4
Grid 7 35.9 M4	Grid 8 26 M4	Grid 9 26.7 M4



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HAC RF H-Field WCDMA Band II High(Battery 2)

Date/Time: 8/21/2013 3:11:28 PM

Communication System: WCDMA ; Frequency: 1907.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.117 A/m

Probe Modulation Factor = 1.01

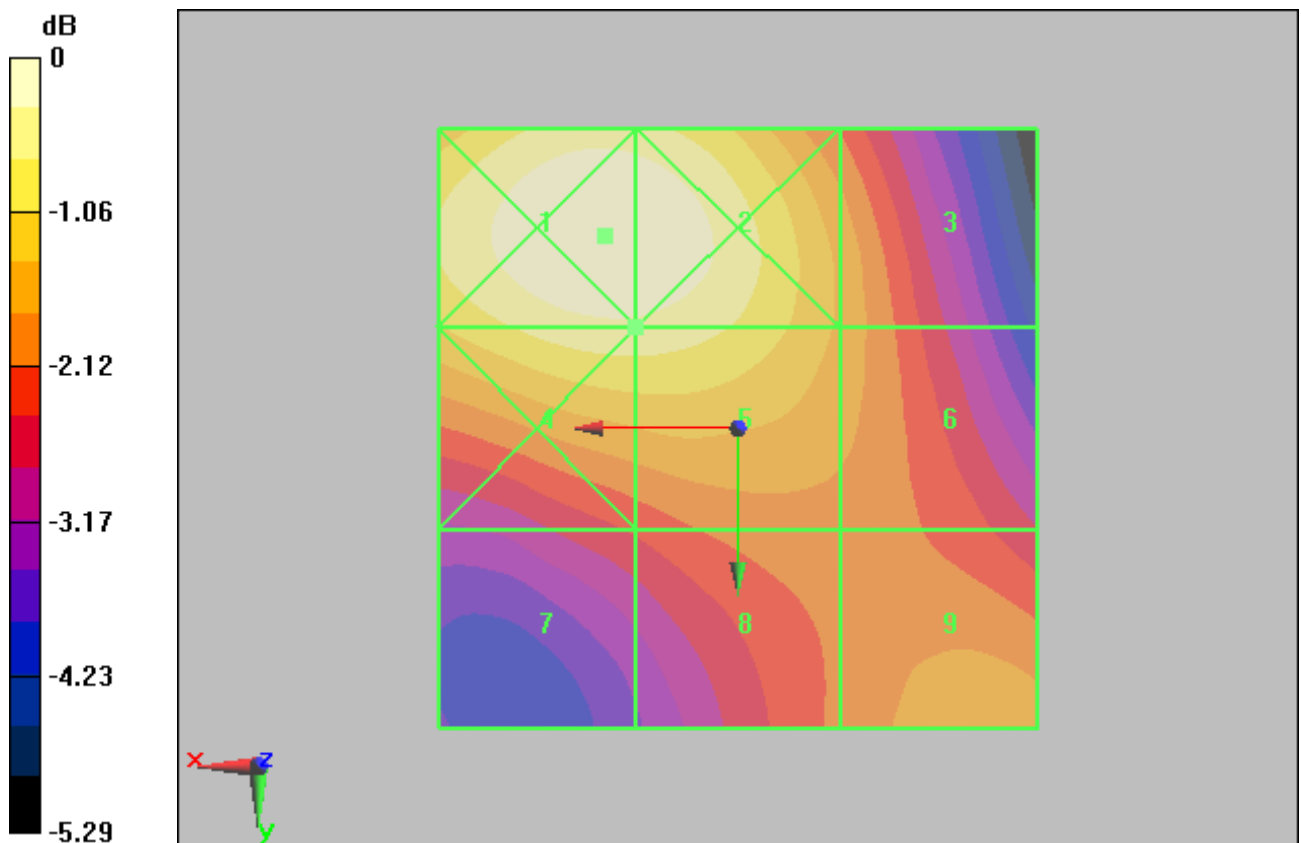
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.111 A/m; Power Drift = -0.038 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.123 M4	Grid 2 0.123 M4	Grid 3 0.104 M4
Grid 4 0.117 M4	Grid 5 0.117 M4	Grid 6 0.104 M4
Grid 7 0.093 M4	Grid 8 0.099 M4	Grid 9 0.103 M4



0 dB = 0.123A/m

Figure 45 HAC RF H-Field WCDMA Band II Channel 9538

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HAC RF H-Field WCDMA Band II Middle(Battery 2)

Date/Time: 8/21/2013 3:45:46 PM

Communication System: WCDMA ; Frequency: 1880 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.114 A/m

Probe Modulation Factor = 1.01

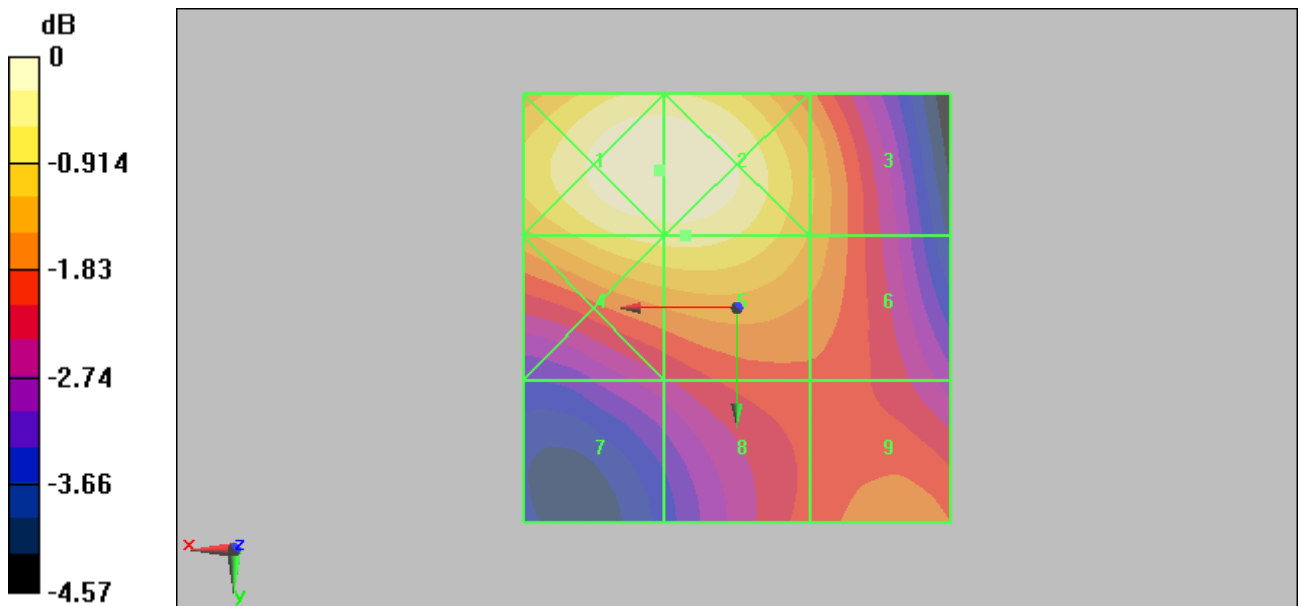
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.108 A/m; Power Drift = 0.019 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.120 M4	Grid 2 0.120 M4	Grid 3 0.105 M4
Grid 4 0.114 M4	Grid 5 0.114 M4	Grid 6 0.104 M4
Grid 7 0.090 M4	Grid 8 0.096 M4	Grid 9 0.099 M4



0 dB = 0.120A/m

Figure 46 HAC RF H-Field WCDMA Band II Channel 9400

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HAC RF H-Field WCDMA Band II Low(Battery 2)

Date/Time: 8/21/2013 3:59:33 PM

Communication System: WCDMA ; Frequency: 1852.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA II HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.115 A/m

Probe Modulation Factor = 1.01

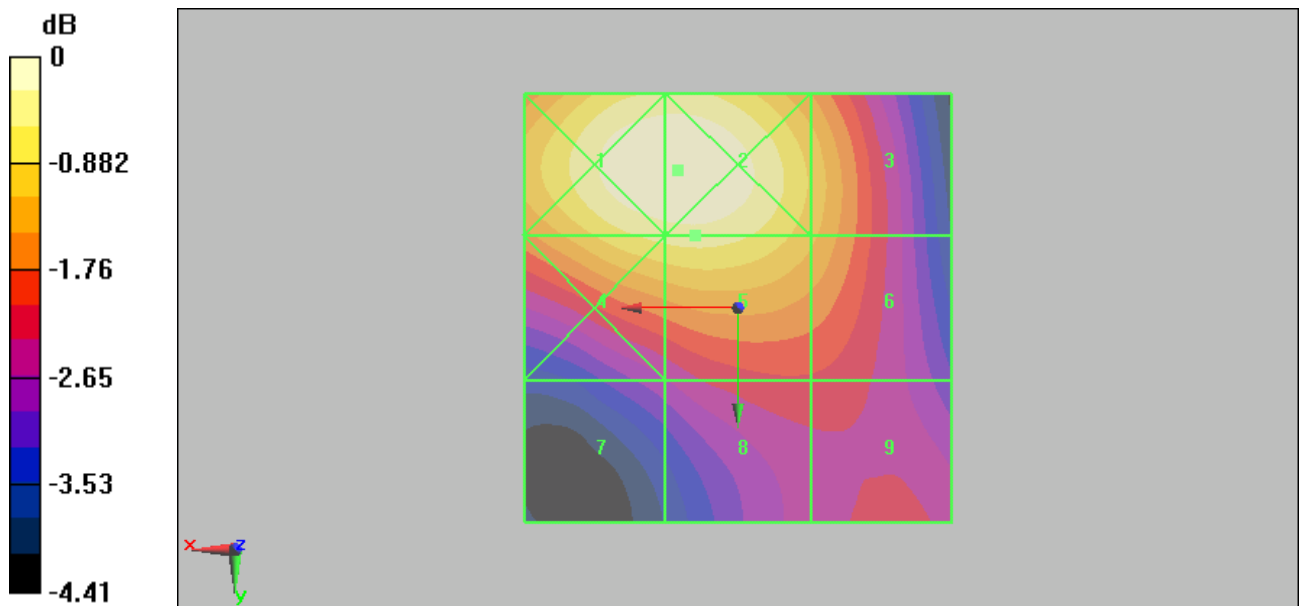
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.110 A/m; Power Drift = -0.030 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.121 M4	Grid 2 0.121 M4	Grid 3 0.109 M4
Grid 4 0.115 M4	Grid 5 0.115 M4	Grid 6 0.107 M4
Grid 7 0.089 M4	Grid 8 0.095 M4	Grid 9 0.095 M4



0 dB = 0.121A/m

Figure 47 HAC RF H-Field WCDMA Band II Channel 9262

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HAC RF E-Field WCDMA Band IV High(Battery 1)

Date/Time: 8/21/2013 7:38:14 AM

Communication System: WCDMA ; Frequency: 1752.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 31.9 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 25.8 V/m; Power Drift = -0.039 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
21.6 M4	37.5 M4	37.7 M4
Grid 4	Grid 5	Grid 6
22.7 M4	31.9 M4	32.9 M4
Grid 7	Grid 8	Grid 9
29.1 M4	25 M4	25.8 M4

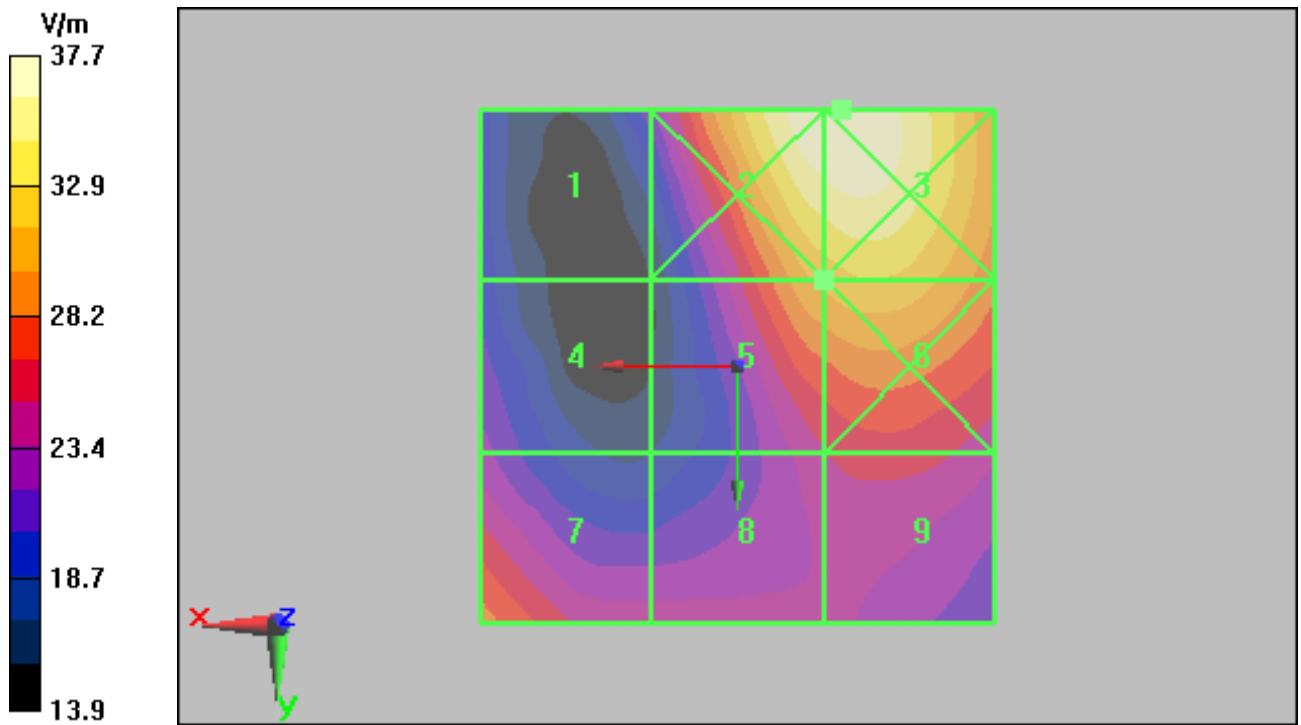


Figure 48 HAC RF E-Field WCDMA Band IV Channel 1513

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HAC RF E-Field WCDMA Band IV Middle(Battery 1)

Date/Time: 8/21/2013 7:55:42 AM

Communication System: WCDMA ; Frequency: 1732.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**WCDMA IV HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 35 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 27.4 V/m; Power Drift = -0.087 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
27.8 M4	43.2 M4	43.2 M4
Grid 4	Grid 5	Grid 6
23.8 M4	35 M4	35.8 M4
Grid 7	Grid 8	Grid 9
32.8 M4	27.9 M4	26 M4

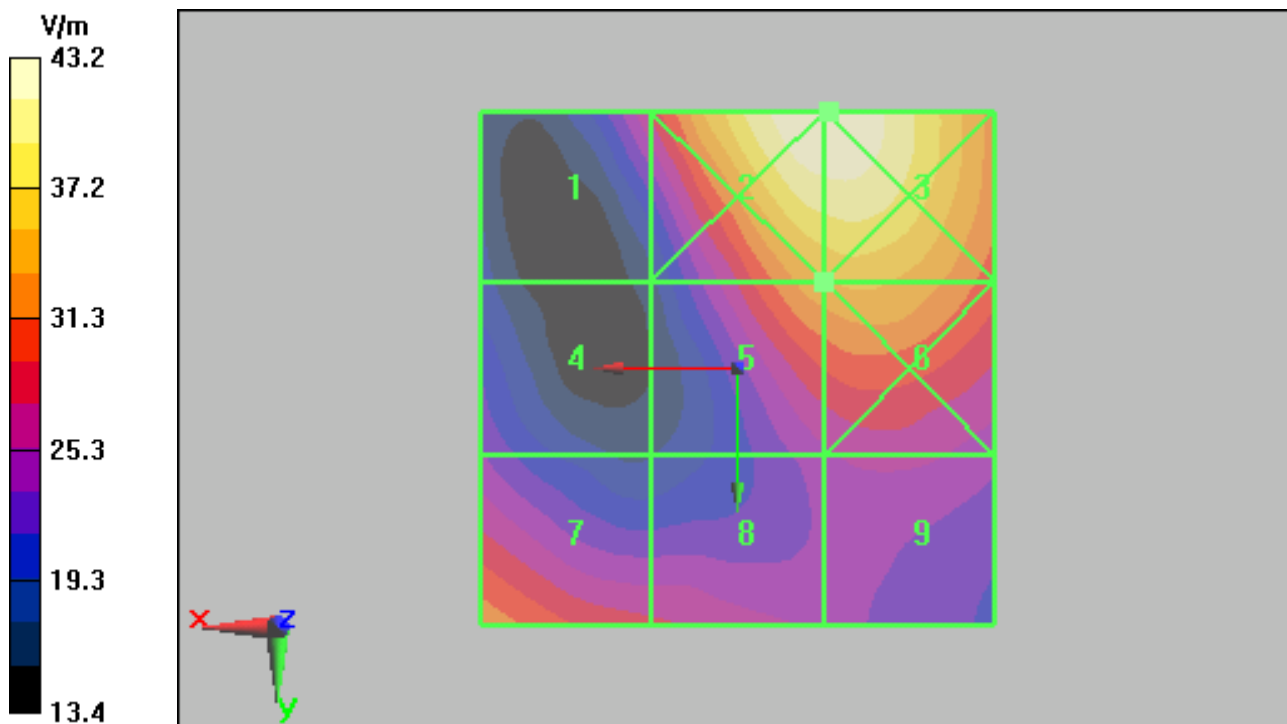


Figure 49 HAC RF E-Field WCDMA Band IV Channel 1413

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HAC RF E-Field WCDMA Band IV Low(Battery 1)

Date/Time: 8/21/2013 8:17:18 AM

Communication System: WCDMA ; Frequency: 1712.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low 2/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 38.2 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 29.8 V/m; Power Drift = -0.037 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
33.5 M4	47.4 M4	47.3 M4
Grid 4	Grid 5	Grid 6
22.2 M4	38.2 M4	38.7 M4
Grid 7	Grid 8	Grid 9
32.3 M4	25.9 M4	26.1 M4

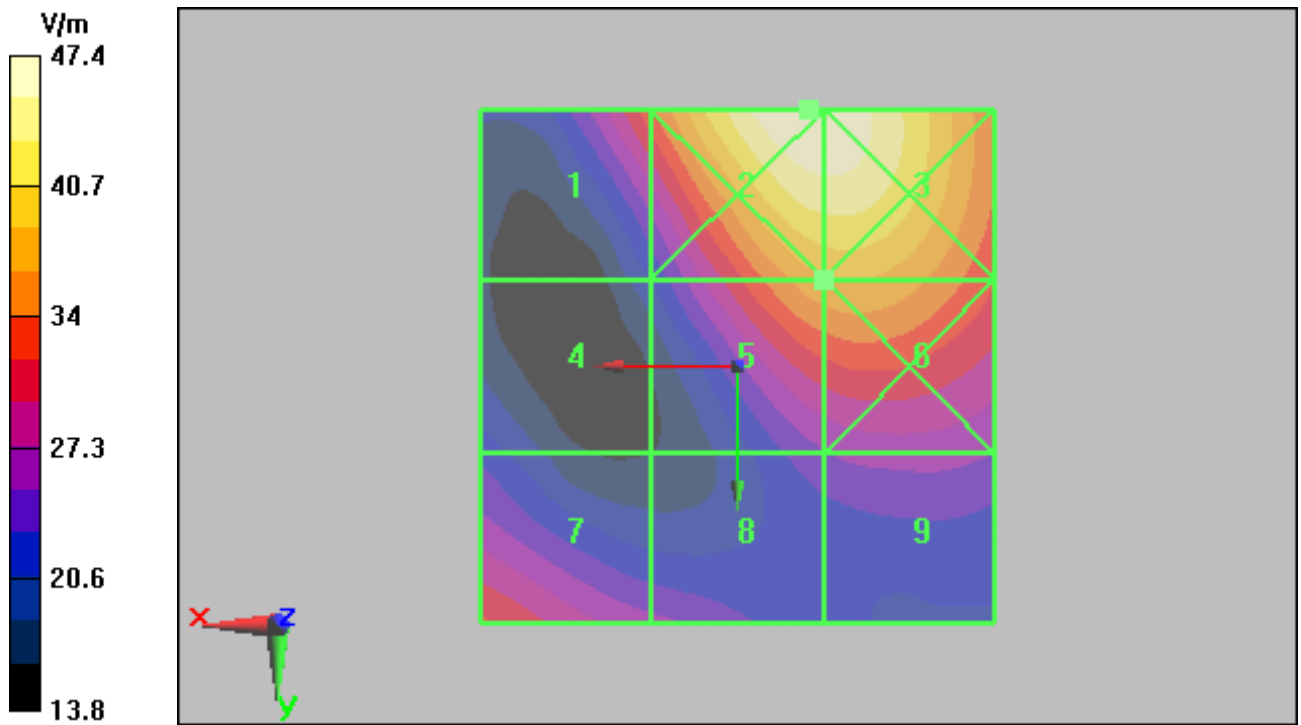


Figure 50 HAC RF E-Field WCDMA Band IV Channel 1312

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HAC RF H-Field WCDMA Band IV High(Battery 1)

Date/Time: 8/21/2013 4:16:54 PM

Communication System: WCDMA ; Frequency: 1752.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.106 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.091 A/m; Power Drift = -0.035 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.118 M4	Grid 2 0.107 M4	Grid 3 0.074 M4
Grid 4 0.094 M4	Grid 5 0.091 M4	Grid 6 0.084 M4
Grid 7 0.106 M4	Grid 8 0.101 M4	Grid 9 0.086 M4

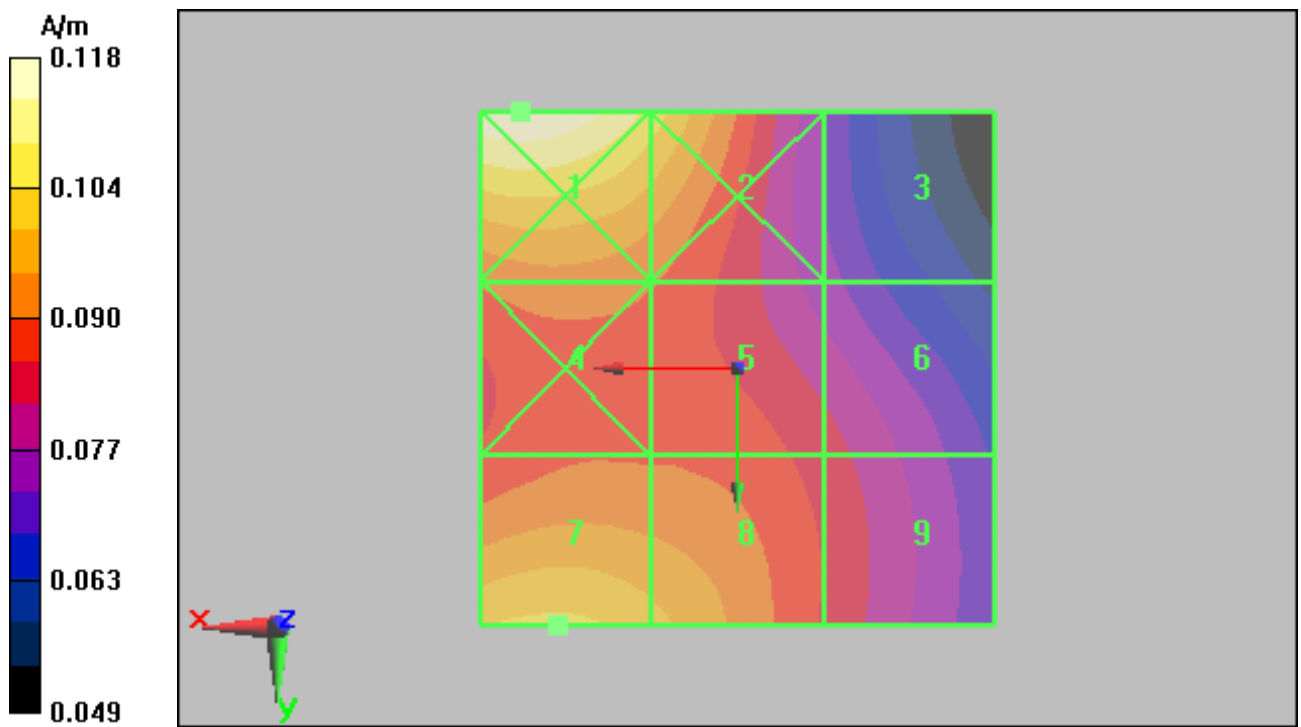


Figure 51 HAC RF H-Field WCDMA Band IV Channel 1513

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HAC RF H-Field WCDMA Band IV Middle(Battery 1)

Date/Time: 8/21/2013 4:40:31 PM

Communication System: WCDMA ; Frequency: 1732.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**WCDMA IV HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.108 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.103 A/m; Power Drift = -0.024 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.128 M4	Grid 2 0.113 M4	Grid 3 0.082 M4
Grid 4 0.100 M4	Grid 5 0.099 M4	Grid 6 0.094 M4
Grid 7 0.108 M4	Grid 8 0.105 M4	Grid 9 0.095 M4

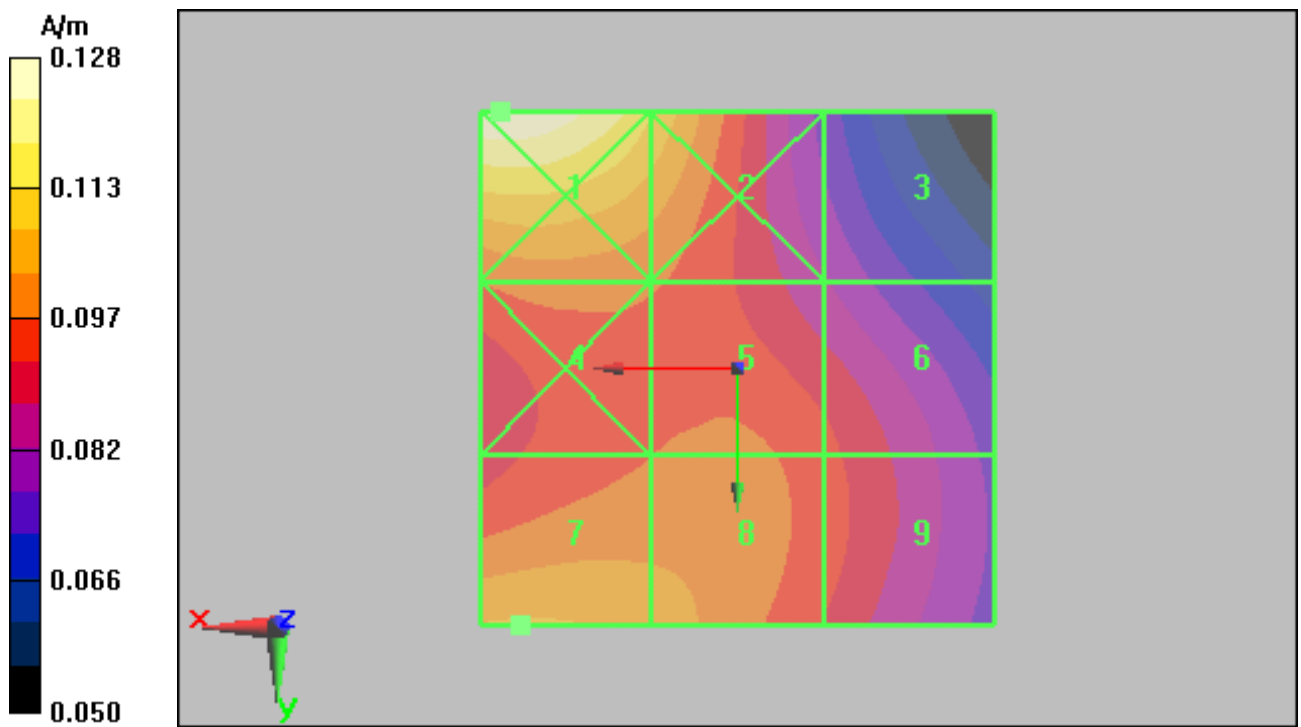


Figure 52 HAC RF H-Field WCDMA Band IV Channel 1413

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HAC RF H-Field WCDMA Band IV Low(Battery 1)

Date/Time: 8/21/2013 4:57:54 PM

Communication System: WCDMA ; Frequency: 1712.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.106 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.112 A/m; Power Drift = 0.021 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.136 M4	Grid 2 0.118 M4	Grid 3 0.088 M4
Grid 4 0.107 M4	Grid 5 0.106 M4	Grid 6 0.100 M4
Grid 7 0.104 M4	Grid 8 0.106 M4	Grid 9 0.101 M4

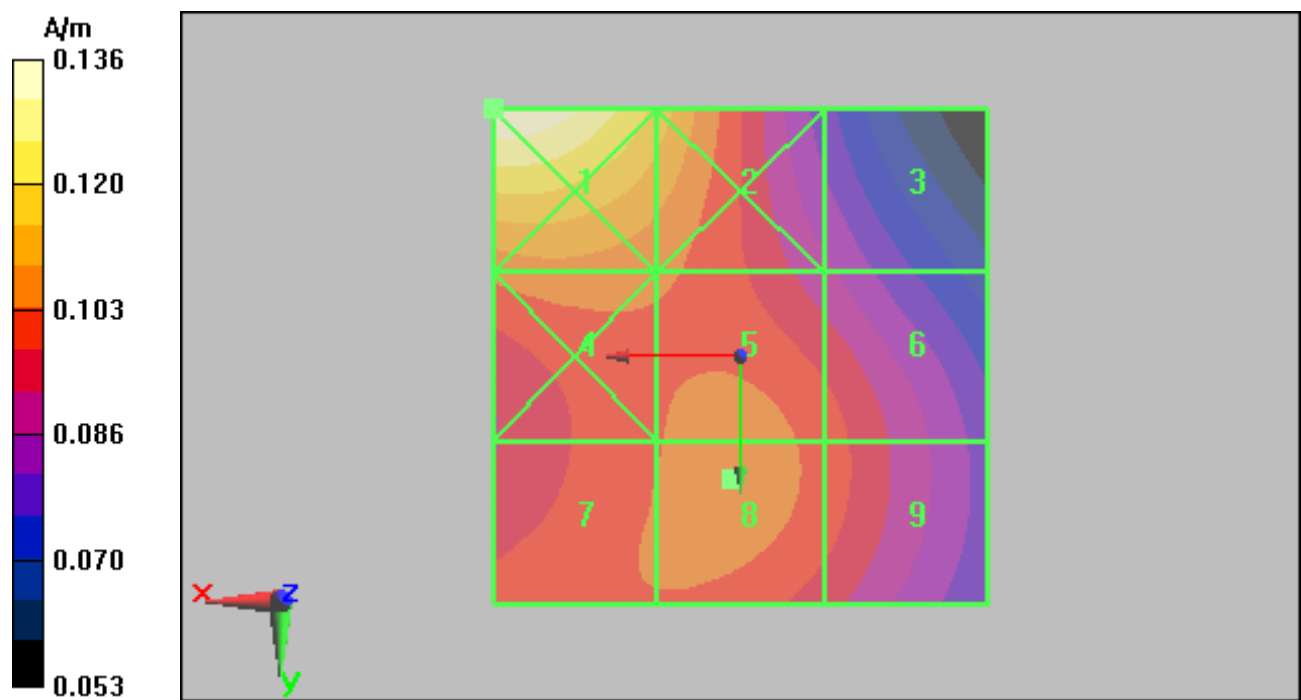


Figure 53 HAC RF H-Field WCDMA Band IV Channel 1312

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HAC RF E-Field WCDMA Band IV High(Battery 2)

Date/Time: 8/21/2013 8:36:03 AM

Communication System: WCDMA ; Frequency: 1752.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 44.5 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 38.1 V/m; Power Drift = -0.131 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
34.7 M4	50 M4	50 M4
Grid 4	Grid 5	Grid 6
24 M4	44.5 M4	45 M4
Grid 7	Grid 8	Grid 9
34.9 M4	33 M4	35.3 M4

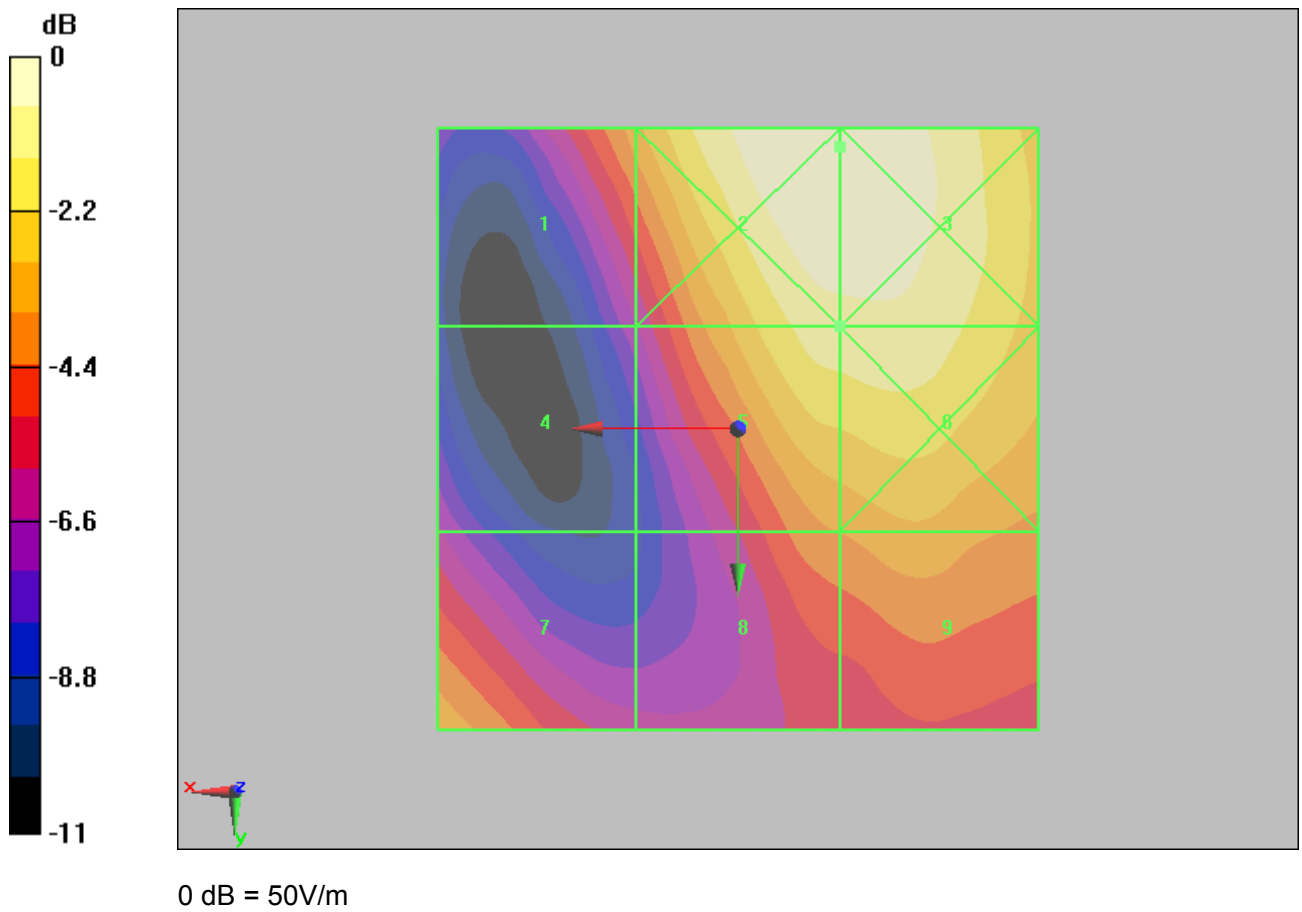


Figure 54 HAC RF E-Field WCDMA Band IV Channel 1513

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HAC RF E-Field WCDMA Band IV Middle(Battery 2)

Date/Time: 8/21/2013 8:48:31 AM

Communication System: WCDMA ; Frequency: 1732.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 44.8 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 38.2 V/m; Power Drift = -0.142 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
39.1 M4	52.5 M4	52.3 M4
Grid 4	Grid 5	Grid 6
24.8 M4	44.8 M4	45.1 M4
Grid 7	Grid 8	Grid 9
36.8 M4	31.6 M4	33.8 M4

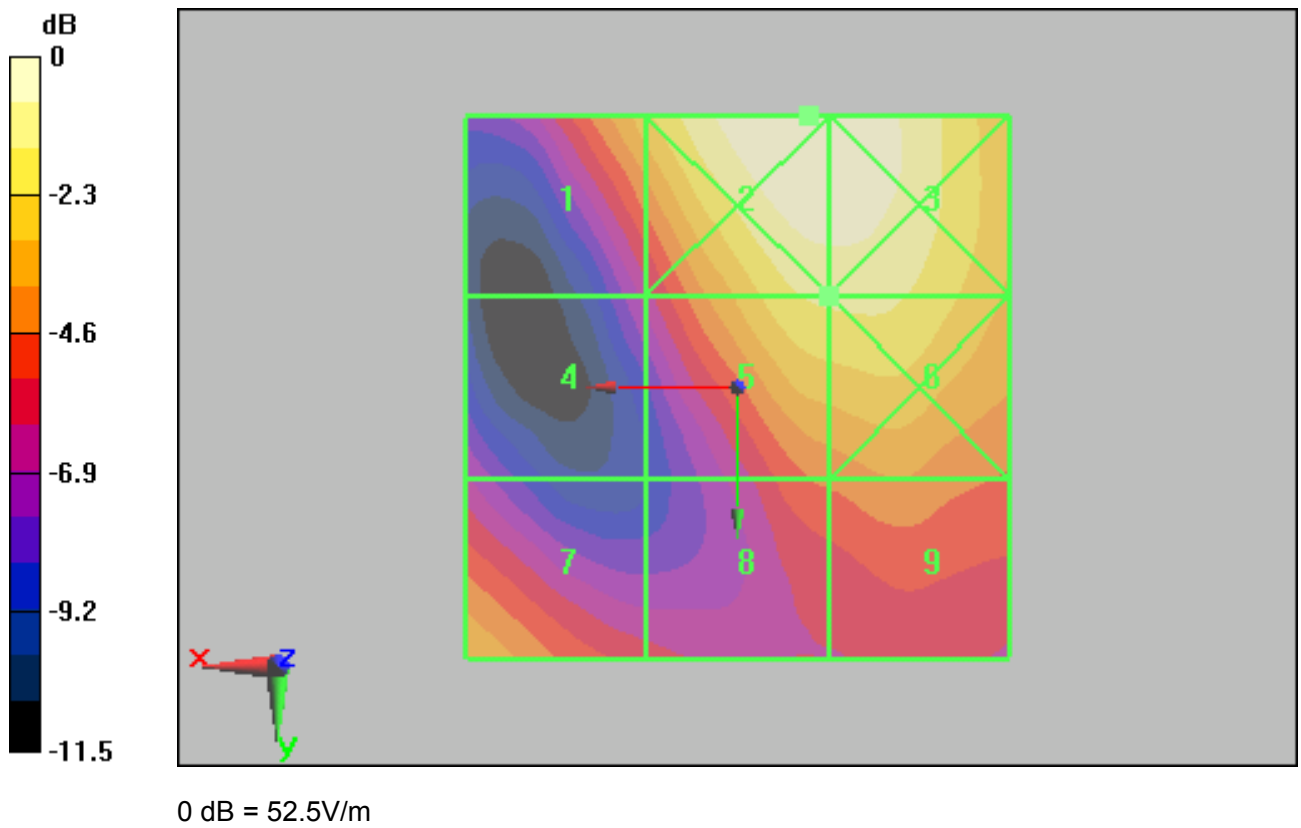


Figure 55 HAC RF E-Field WCDMA Band IV Channel 1413

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HAC RF E-Field WCDMA Band IV Low(Battery 2)

Date/Time: 8/21/2013 9:05:47 AM

Communication System: WCDMA ; Frequency: 1712.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low 2/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 45.4 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 39.6 V/m; Power Drift = -0.147 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 41.3 M4	Grid 2 53.4 M4	Grid 3 53 M4
Grid 4 26.9 M4	Grid 5 45.4 M4	Grid 6 45.4 M4
Grid 7 35.5 M4	Grid 8 31.4 M4	Grid 9 33.3 M4

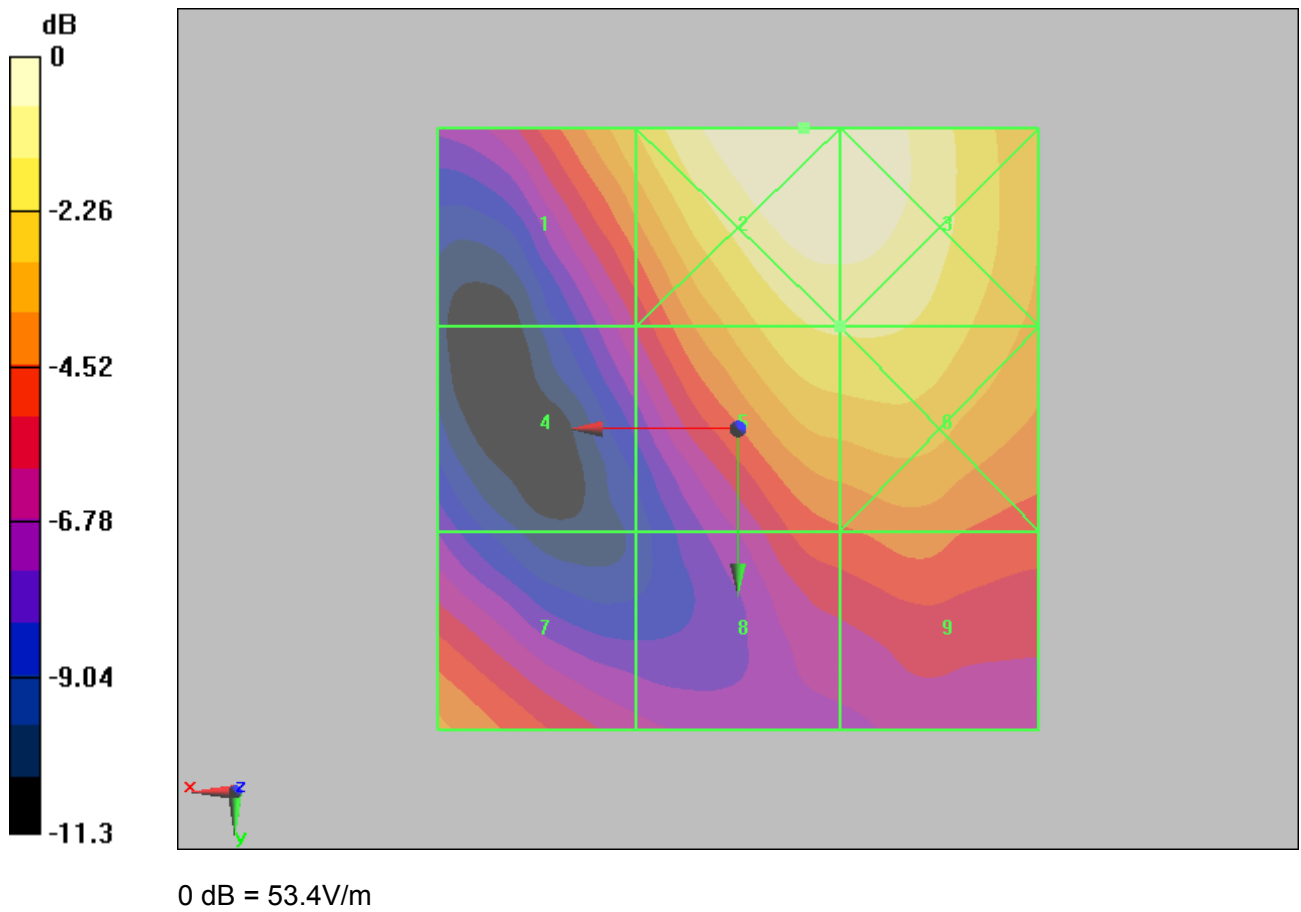


Figure 56 HAC RF E-Field WCDMA Band IV Channel 1312

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HAC RF H-Field WCDMA Band IV High(Battery 2)

Date/Time: 8/21/2013 5:19:07 PM

Communication System: WCDMA ; Frequency: 1752.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.137 A/m

Probe Modulation Factor = 1.01

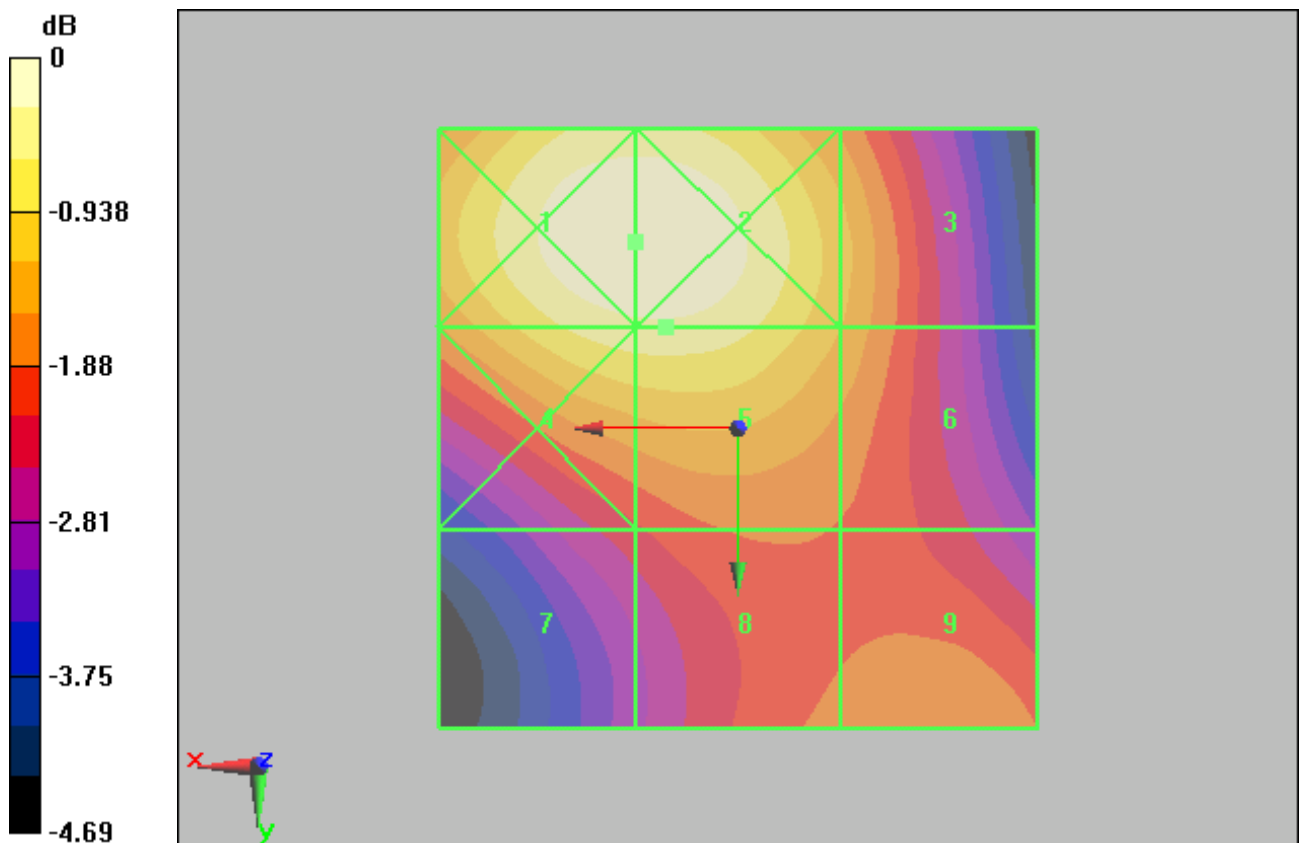
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.132 A/m; Power Drift = -0.054 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.143 M4	Grid 2 0.143 M4	Grid 3 0.126 M4
Grid 4 0.137 M4	Grid 5 0.137 M4	Grid 6 0.124 M4
Grid 7 0.111 M4	Grid 8 0.117 M4	Grid 9 0.120 M4



0 dB = 0.143A/m

Figure 57 HAC RF H-Field WCDMA Band IV Channel 1513

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HAC RF H-Field WCDMA Band IV Middle(Battery 2)

Date/Time: 8/21/2013 5:41:14 PM

Communication System: WCDMA ; Frequency: 1732.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.144 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.136 A/m; Power Drift = -0.049 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.152 M4	Grid 2 0.152 M4	Grid 3 0.130 M4
Grid 4 0.144 M4	Grid 5 0.144 M4	Grid 6 0.127 M4
Grid 7 0.114 M4	Grid 8 0.119 M4	Grid 9 0.123 M4

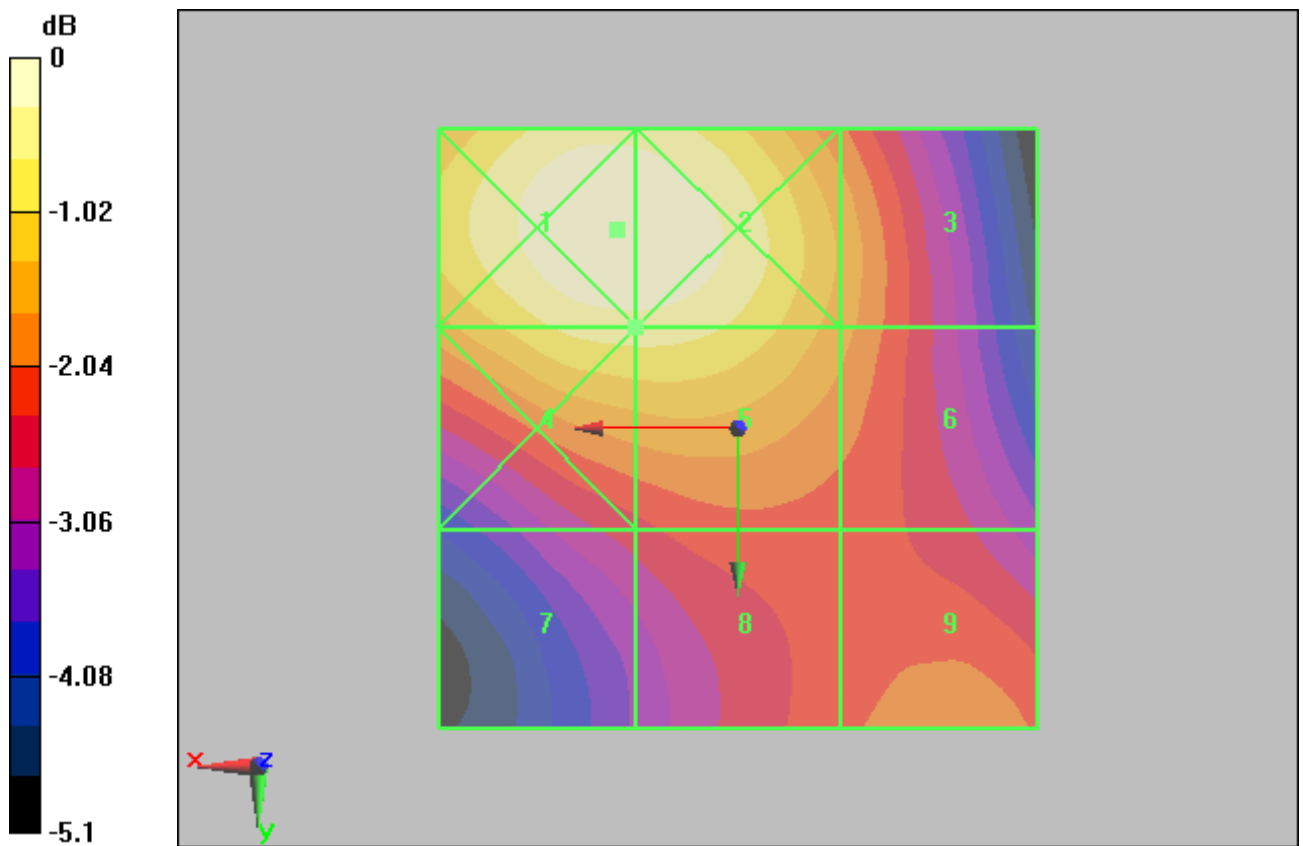


Figure 58 HAC RF H-Field WCDMA Band IV Channel 1413

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HAC RF H-Field WCDMA Band IV Low(Battery 2)

Date/Time: 8/21/2013 6:07:01 PM

Communication System: WCDMA ; Frequency: 1712.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA IV HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.148 A/m

Probe Modulation Factor = 1.01

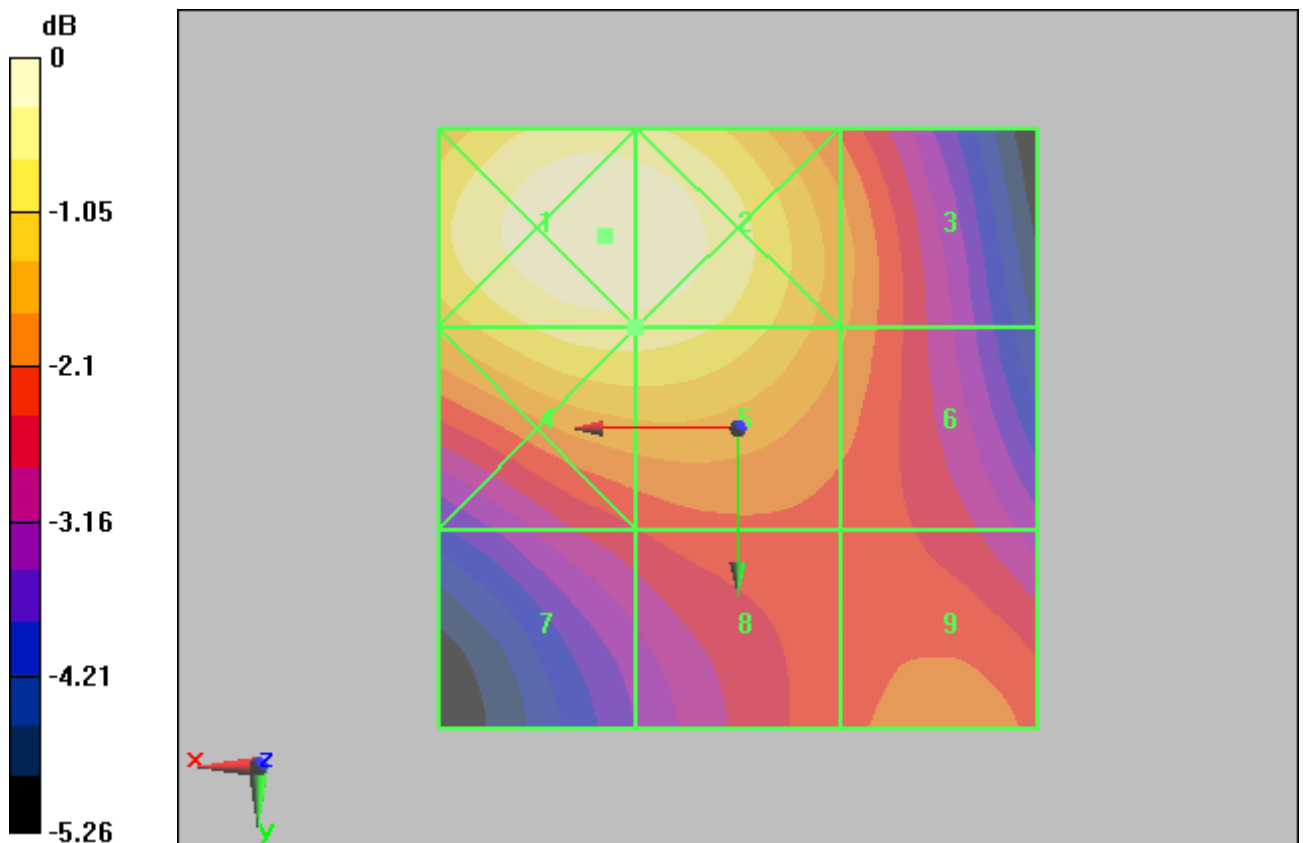
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.138 A/m; Power Drift = -0.030 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.156 M4	Grid 2 0.155 M4	Grid 3 0.130 M4
Grid 4 0.148 M4	Grid 5 0.148 M4	Grid 6 0.129 M4
Grid 7 0.117 M4	Grid 8 0.122 M4	Grid 9 0.125 M4



0 dB = 0.156A/m

Figure 59 HAC RF H-Field WCDMA Band IV Channel 1312

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HAC RF E-Field WCDMA Band V High(Battery 1)

Date/Time: 8/20/2013 2:15:33 PM

Communication System: WCDMA ; Frequency: 846.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 10.7 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 12.9 V/m; Power Drift = -0.028 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
9.96 M4	10.6 M4	9.86 M4
Grid 4	Grid 5	Grid 6
10.2 M4	10.7 M4	10.2 M4
Grid 7	Grid 8	Grid 9
9.7 M4	10.7 M4	10.1 M4

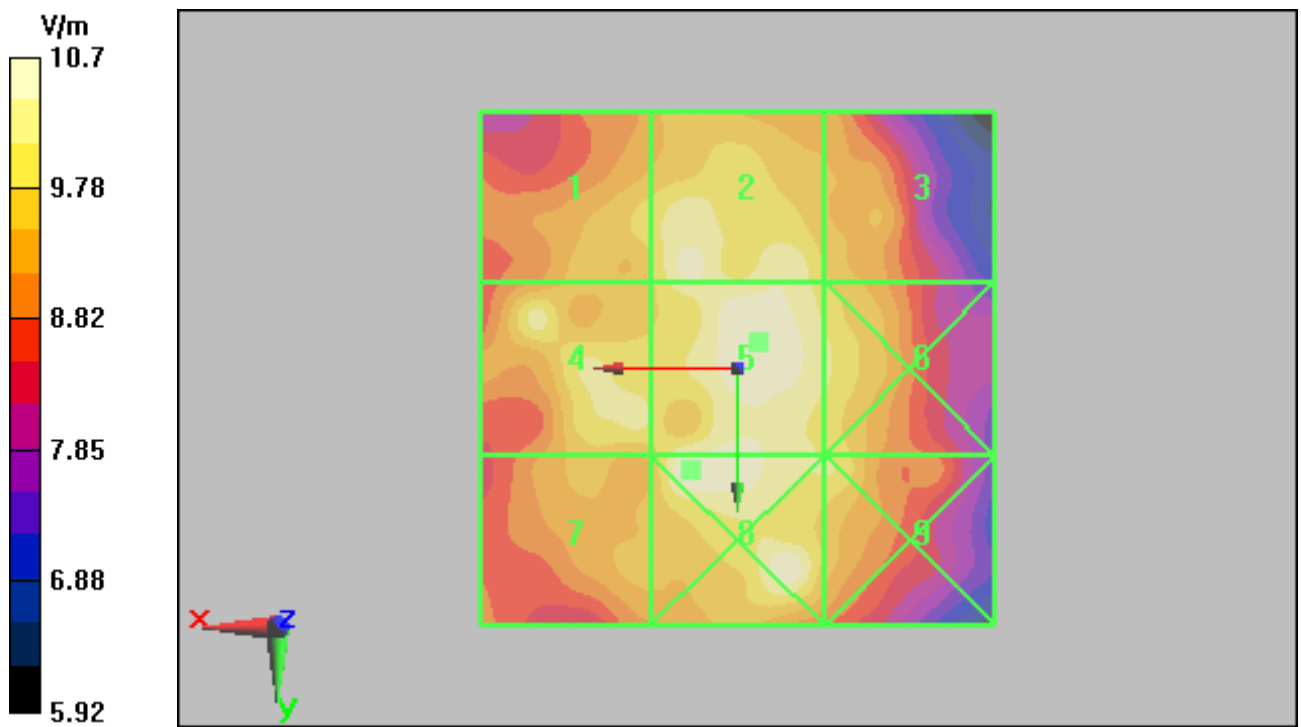


Figure 60 HAC RF E-Field WCDMA Band V Channel 4233

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HAC RF E-Field WCDMA Band V Middle(Battery 1)

Date/Time: 8/20/2013 2:04:32 PM

Communication System: WCDMA ; Frequency: 836.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**WCDMA V HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 9.13 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 10.3 V/m; Power Drift = 0.062 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 8.4 M4	Grid 2 8.73 M4	Grid 3 8.05 M4
Grid 4 8.75 M4	Grid 5 9.13 M4	Grid 6 8.12 M4
Grid 7 8.54 M4	Grid 8 8.94 M4	Grid 9 7.96 M4

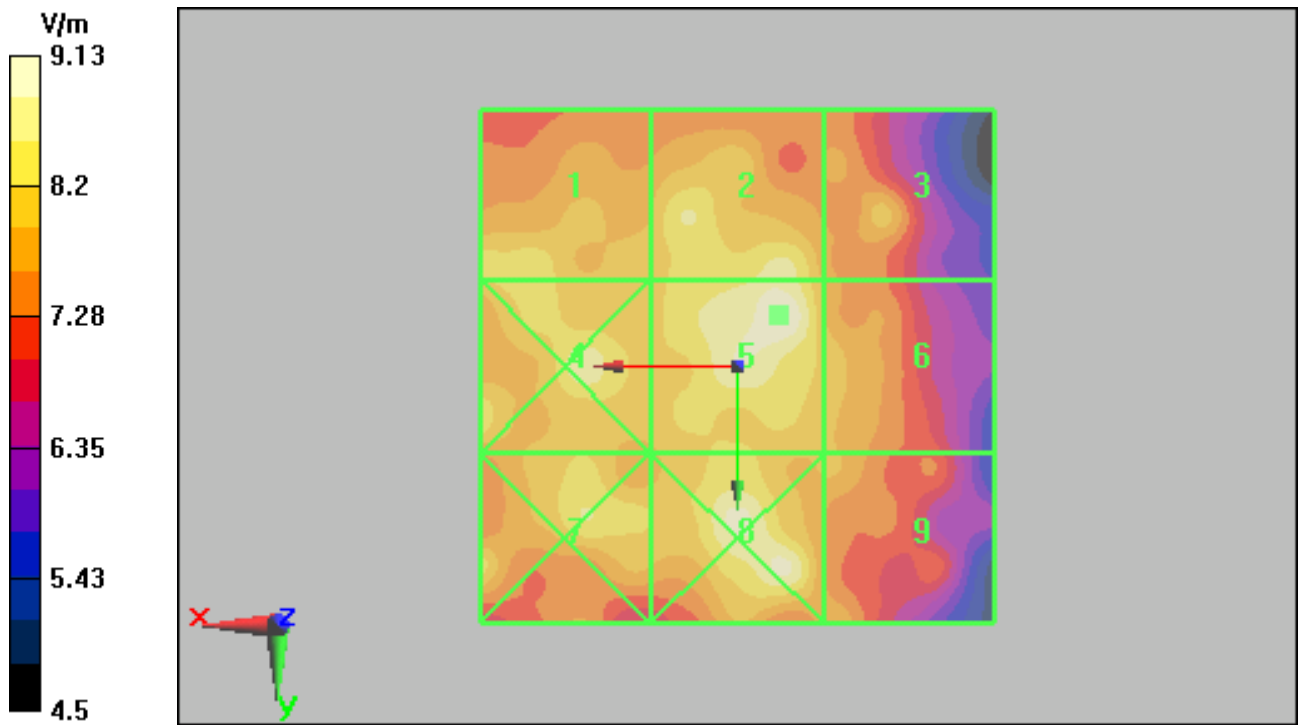


Figure 61 HAC RF E-Field WCDMA Band V Channel 4183

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HAC RF E-Field WCDMA Band V Low(Battery 1)

Date/Time: 8/20/2013 2:22:59 PM

Communication System: WCDMA ; Frequency: 826.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low 2/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 9.39 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 10.9 V/m; Power Drift = -0.034 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 8.62 M4	Grid 2 9.12 M4	Grid 3 8.31 M4
Grid 4 9.08 M4	Grid 5 9.39 M4	Grid 6 8.5 M4
Grid 7 9.12 M4	Grid 8 8.96 M4	Grid 9 8.32 M4

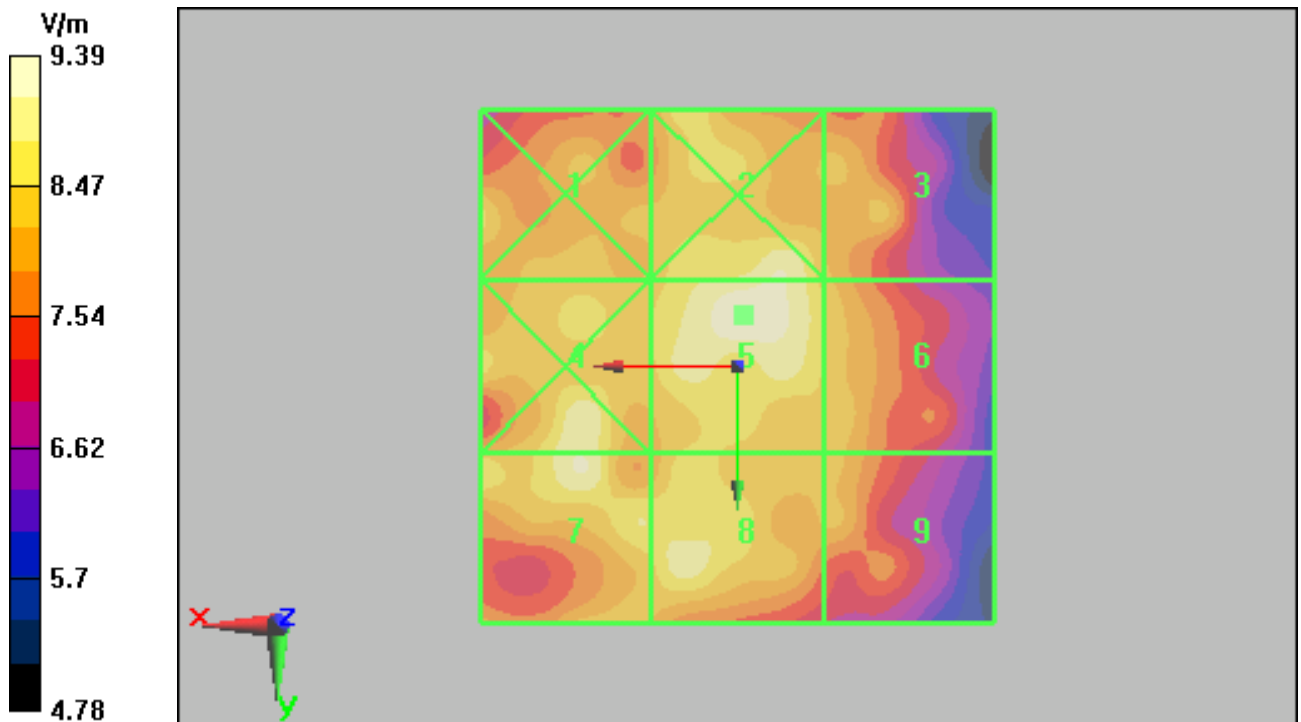


Figure 62 HAC RF E-Field WCDMA Band V Channel 4132

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HAC RF H-Field WCDMA Band V High(Battery 1)

Date/Time: 8/20/2013 8:28:19 PM

Communication System: WCDMA ; Frequency: 846.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.016 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.011 A/m; Power Drift = 0.004 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.021 M4	Grid 2 0.014 M4	Grid 3 0.014 M4
Grid 4 0.020 M4	Grid 5 0.014 M4	Grid 6 0.011 M4
Grid 7 0.021 M4	Grid 8 0.016 M4	Grid 9 0.012 M4

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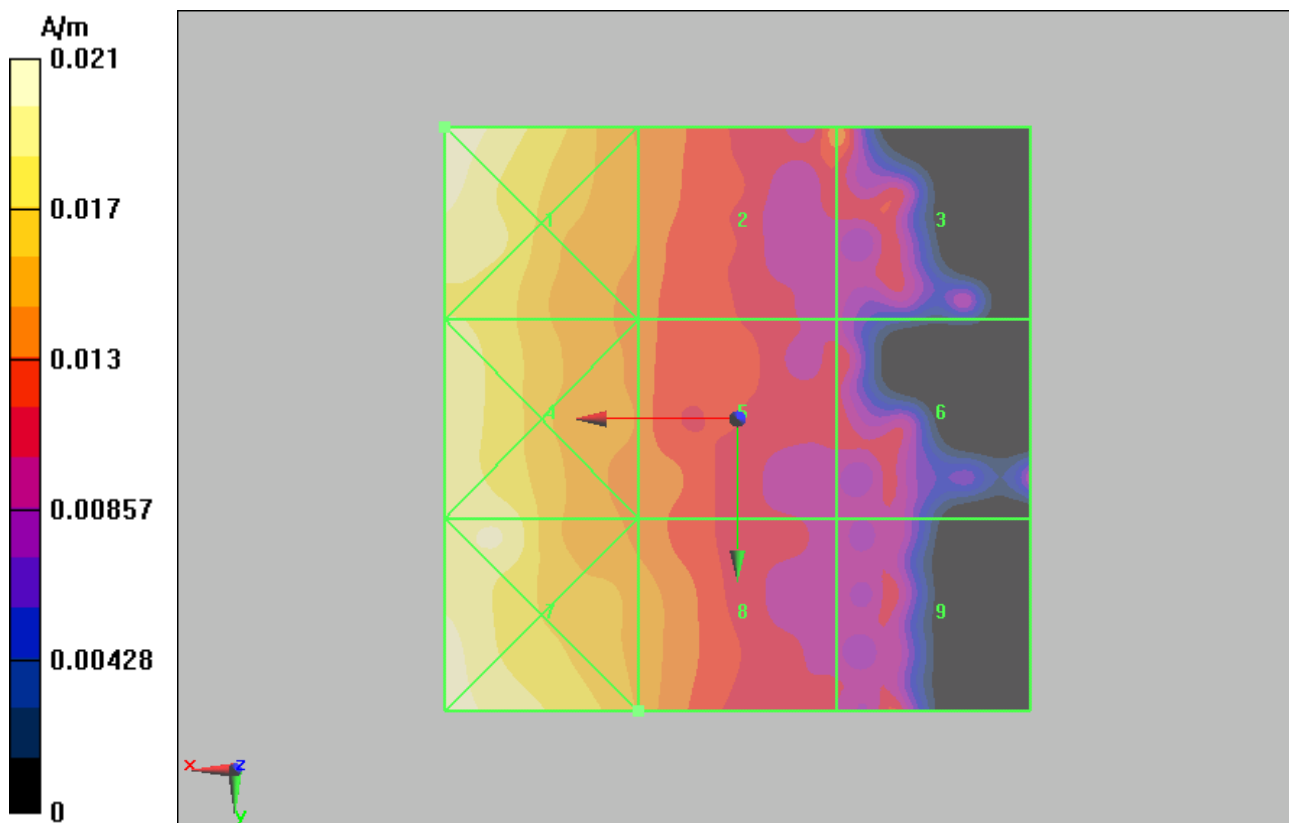


Figure 63 HAC RF H-Field WCDMA Band V Channel 4233

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HAC RF H-Field WCDMA Band V Middle(Battery 1)

Date/Time: 8/20/2013 8:41:45 PM

Communication System: WCDMA ; Frequency: 836.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**WCDMA V HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.018 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.00716 A/m; Power Drift = 0.034 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.018 M4	Grid 2 0.018 M4	Grid 3 3.79e-005 M4
Grid 4 0.019 M4	Grid 5 0.011 M4	Grid 6 0.00579 M4
Grid 7 0.018 M4	Grid 8 0.024 M4	Grid 9 0.011 M4

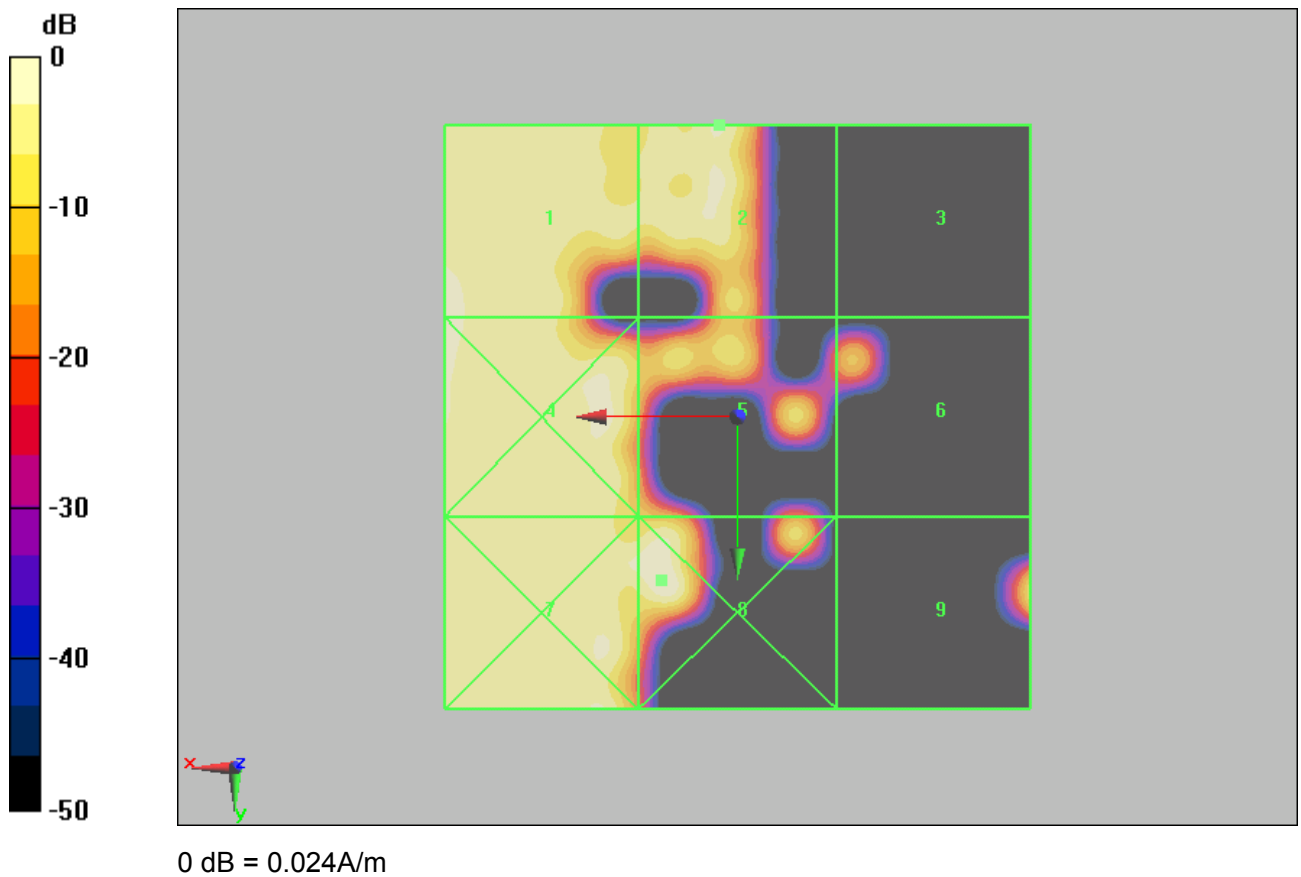


Figure 64 HAC RF H-Field WCDMA Band V Channel 4183

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HAC RF H-Field WCDMA Band V Low(Battery 1)

Date/Time: 8/20/2013 8:54:19 PM

Communication System: WCDMA ; Frequency: 826.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260;Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.015 A/m

Probe Modulation Factor = 1.01

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.00786 A/m; Power Drift = 0.099 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.016 M4	Grid 2 0.015 M4	Grid 3 0.010 M4
Grid 4 0.015 M4	Grid 5 0.011 M4	Grid 6 0.011 M4
Grid 7 0.017 M4	Grid 8 0.015 M4	Grid 9 0.010 M4

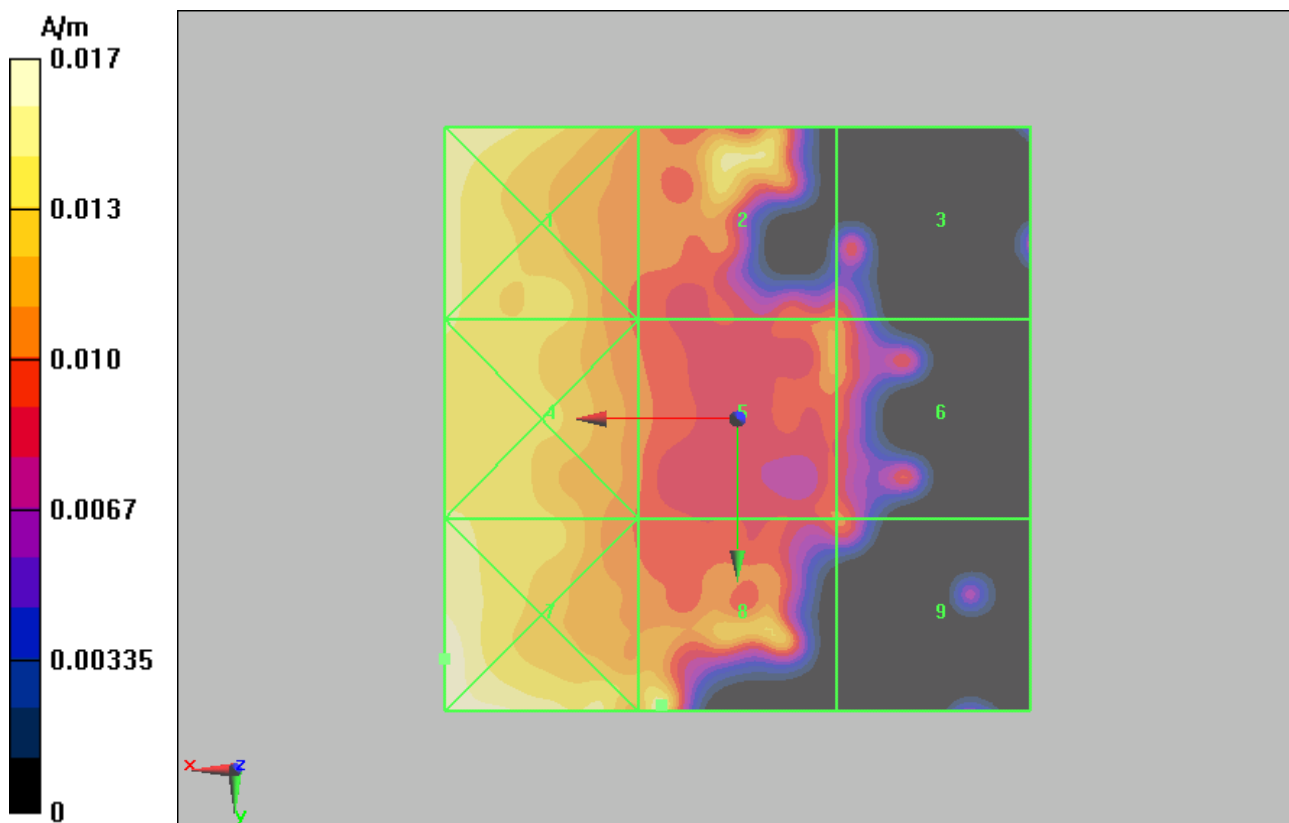


Figure 65 HAC RF H-Field WCDMA Band V Channel 4132

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HAC RF E-Field WCDMA Band V High(Battery 2)

Date/Time: 8/20/2013 3:02:47 PM

Communication System: WCDMA ; Frequency: 846.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device

High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 7.55 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 8.47 V/m; Power Drift = 0.010 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
6.74 M4	7.17 M4	7.45 M4
Grid 4	Grid 5	Grid 6
6.68 M4	7.55 M4	7.99 M4
Grid 7	Grid 8	Grid 9
6.77 M4	7.88 M4	7.15 M4

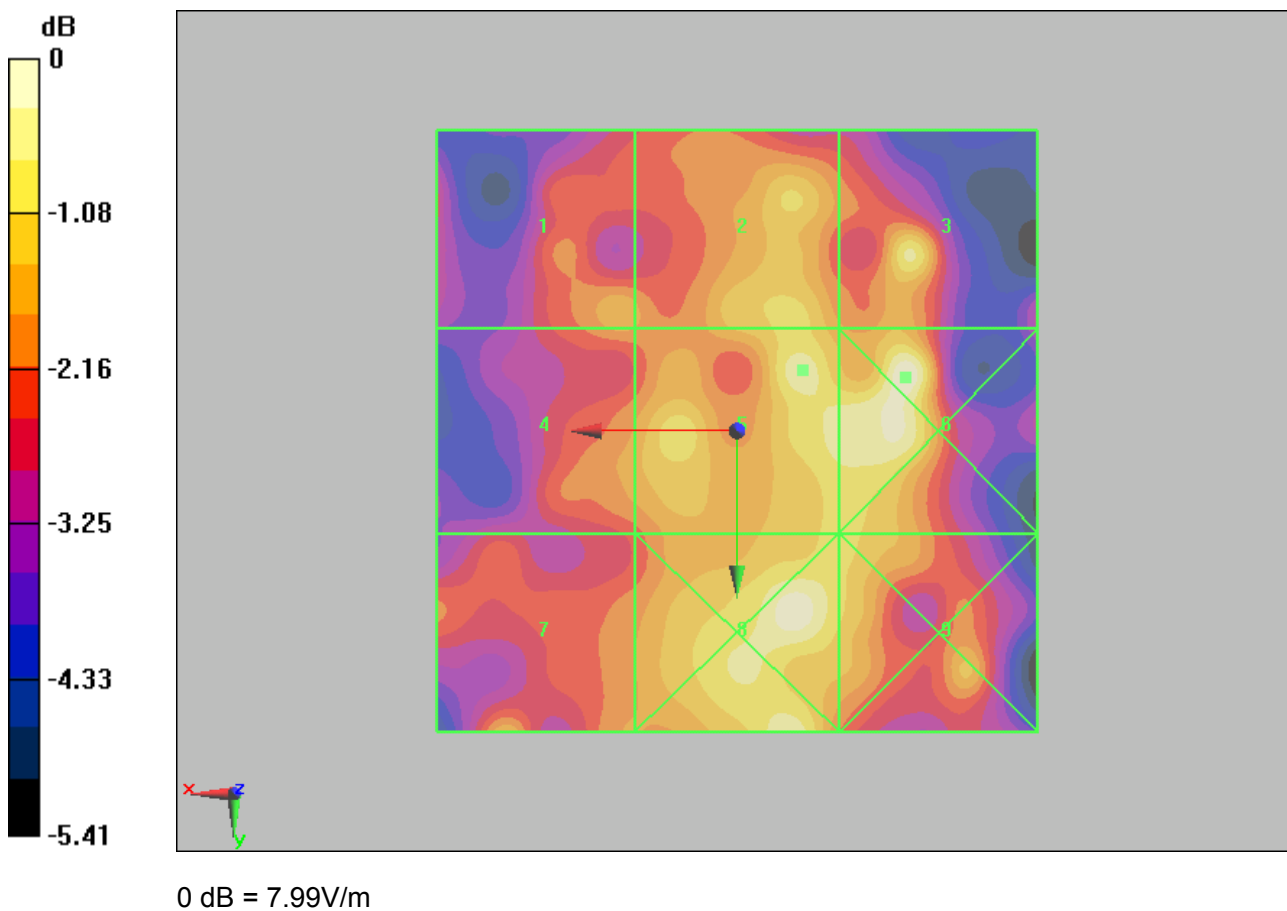


Figure 66 HAC RF E-Field WCDMA Band V Channel 4233

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HAC RF E-Field WCDMA Band V Middle(Battery 2)

Date/Time: 8/20/2013 3:52:39 PM

Communication System: WCDMA ; Frequency: 836.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device

Middle/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 7.78 V/m

Probe Modulation Factor = 1.03

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 10.8 V/m; Power Drift = -0.066 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1 9.04 M4	Grid 2 7.44 M4	Grid 3 7.03 M4
Grid 4 8.23 M4	Grid 5 7.78 M4	Grid 6 7.6 M4
Grid 7 7.85 M4	Grid 8 7.73 M4	Grid 9 7.34 M4

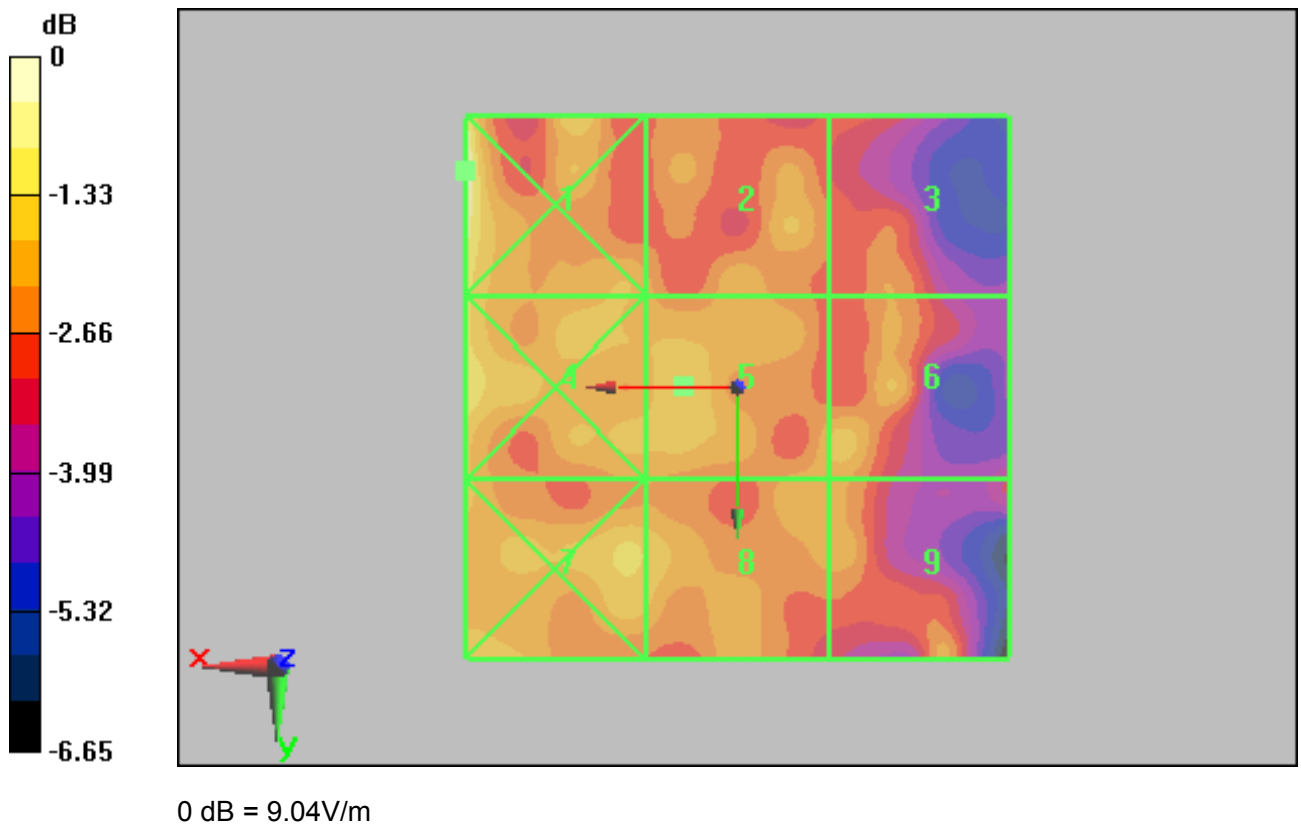


Figure 67 HAC RF E-Field WCDMA Band V Channel 4183

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HAC RF E-Field WCDMA Band V Low(Battery 2)

Date/Time: 8/20/2013 3:13:20 PM

Communication System: WCDMA ; Frequency: 826.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: ER3DV6 - SN2428; ConvF(1, 1, 1); Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF E-Field/E Scan - ER3D - 2007: 15 mm from Probe Center to the Device Low 2/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 7.85 V/m

Probe Modulation Factor = 1.03

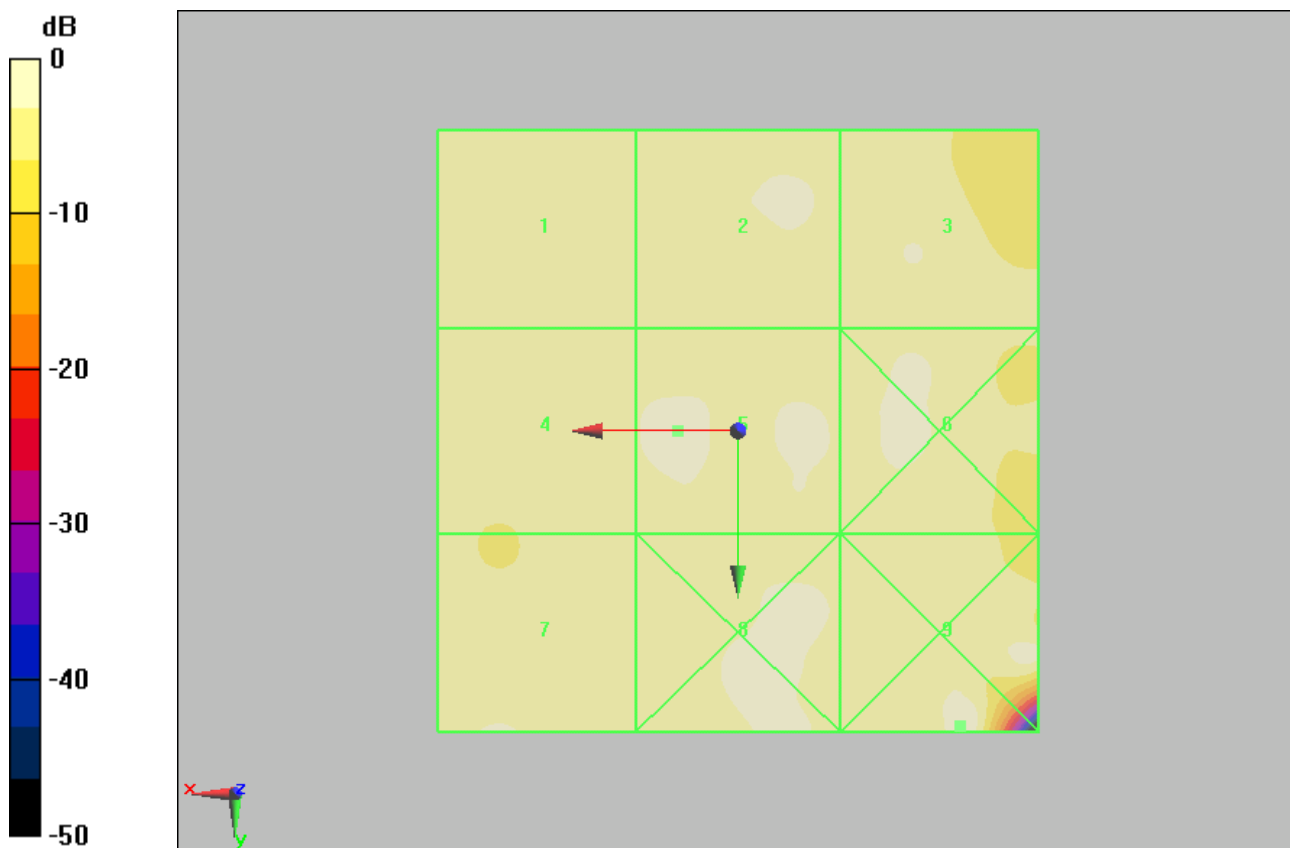
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 8.81 V/m; Power Drift = 0.021 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-field in V/m

Grid 1	Grid 2	Grid 3
6.38 M4	7.32 M4	7.15 M4
Grid 4	Grid 5	Grid 6
6.92 M4	7.85 M4	7.47 M4
Grid 7	Grid 8	Grid 9
7.39 M4	7.42 M4	10.3 M4



0 dB = 10.3V/m

Figure 68 HAC RF E-Field WCDMA Band V Channel 4132

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HAC RF H-Field WCDMA Band V High(Battery 2)

Date/Time: 8/20/2013 9:16:23 PM

Communication System: WCDMA ; Frequency: 846.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
High/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.046 A/m

Probe Modulation Factor = 1.01

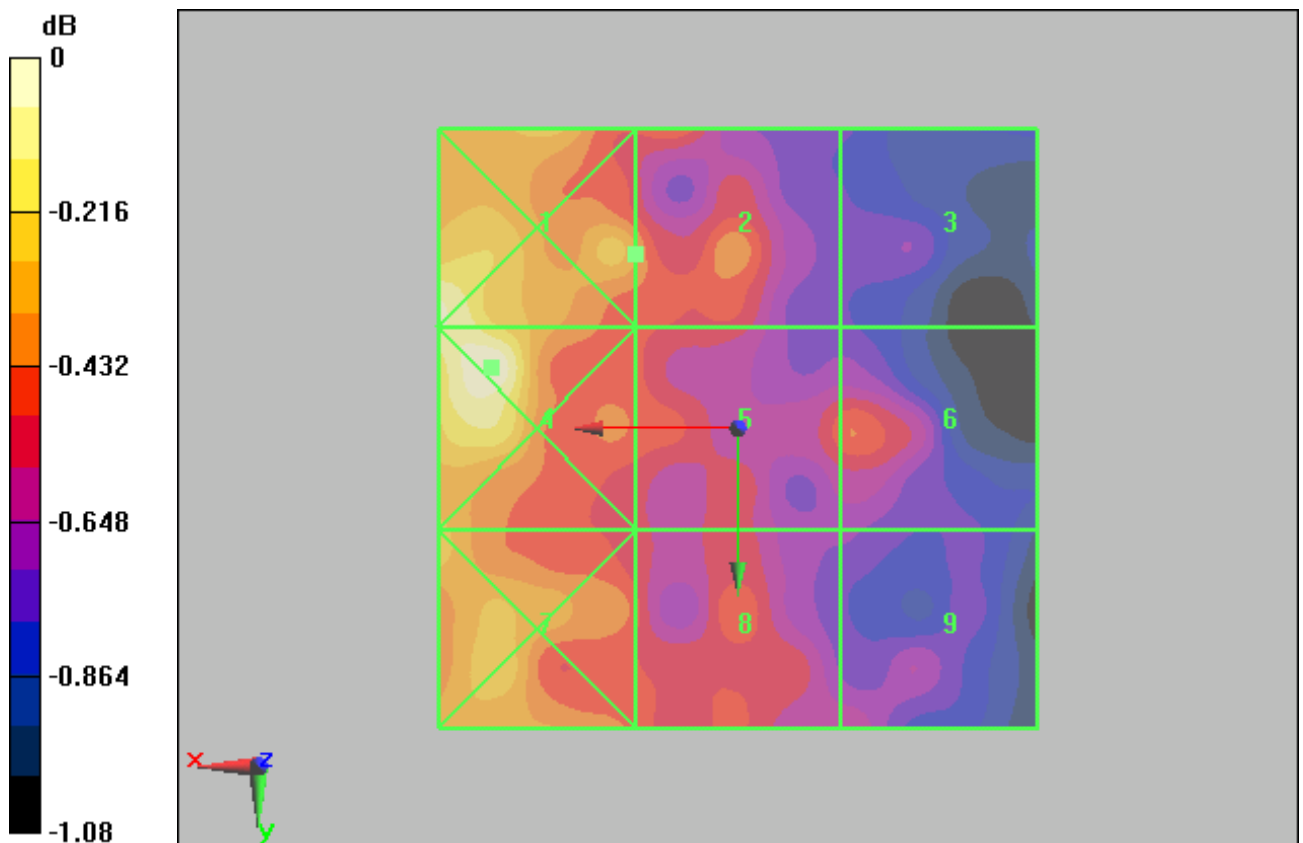
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.045 A/m; Power Drift = -0.088 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.048 M4	Grid 2 0.046 M4	Grid 3 0.044 M4
Grid 4 0.048 M4	Grid 5 0.046 M4	Grid 6 0.046 M4
Grid 7 0.047 M4	Grid 8 0.046 M4	Grid 9 0.045 M4



0 dB = 0.048A/m

Figure 69 HAC RF H-Field WCDMA Band V Channel 4233

TA Technology (Shanghai) Co., Ltd.
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HAC RF H-Field WCDMA Band V Middle(Battery 2)

Date/Time: 8/20/2013 9:39:11 PM

Communication System: WCDMA ; Frequency: 836.6 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

**WCDMA V HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device
Middle 2/Hearing Aid Compatibility Test (101x101x1):** Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.044 A/m

Probe Modulation Factor = 1.01

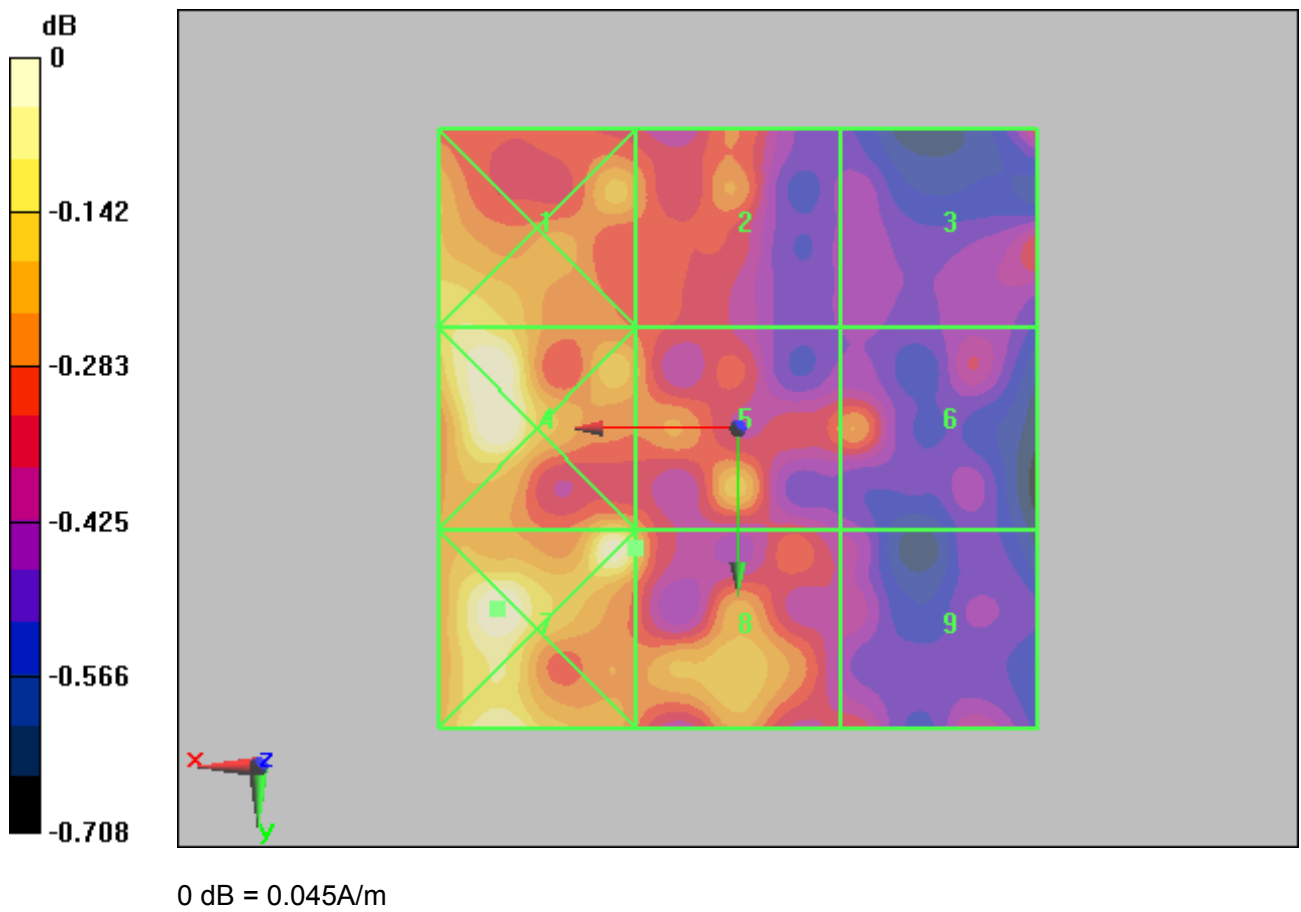
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.043 A/m; Power Drift = -0.093 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.045 M4	Grid 2 0.044 M4	Grid 3 0.044 M4
Grid 4 0.045 M4	Grid 5 0.044 M4	Grid 6 0.044 M4
Grid 7 0.045 M4	Grid 8 0.044 M4	Grid 9 0.043 M4



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HAC RF H-Field WCDMA Band V Low(Battery 2)

Date/Time: 8/20/2013 9:52:24 PM

Communication System: WCDMA ; Frequency: 826.4 MHz;Duty Cycle: 1:1

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Ambient Temperature:22.3 °C

Phantom section: RF Section

DASY5 Configuration:

Sensor-Surface: 4mm (Mechanical Surface Detection)

Probe: H3DV6 - SN6260; Calibrated: 8/30/2012

Electronics: DAE4 Sn1317; Calibrated: 1/25/2013

Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;

Measurement SW: DASY5, V5.2 Build 162; SEMCAD X Version 14.0 Build 59

WCDMA V HAC RF H-Field/H Scan - H3DV6 - 2007: 15 mm from Probe Center to the Device

Low/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.046 A/m

Probe Modulation Factor = 1.01

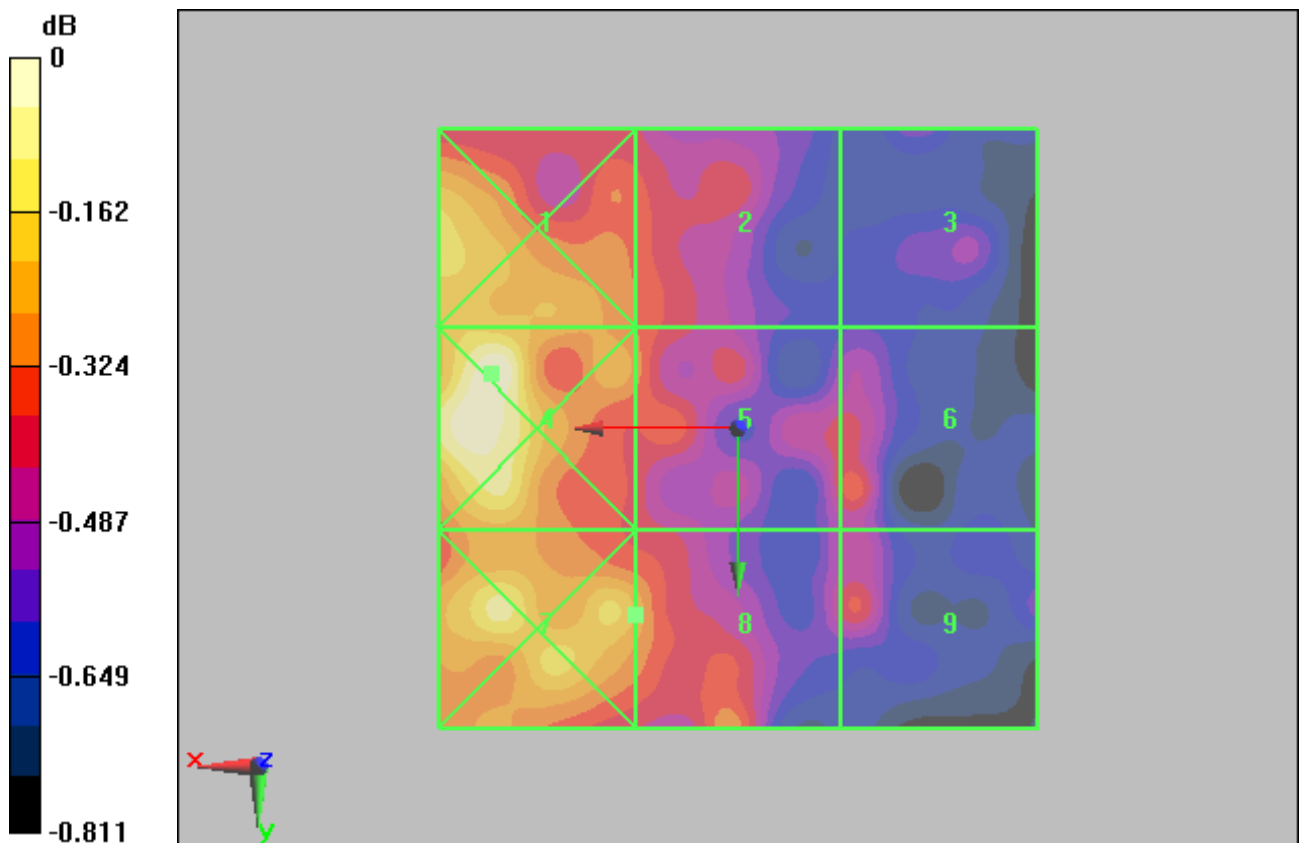
Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.044 A/m; Power Drift = -0.090 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m

Grid 1 0.046 M4	Grid 2 0.045 M4	Grid 3 0.044 M4
Grid 4 0.047 M4	Grid 5 0.045 M4	Grid 6 0.045 M4
Grid 7 0.047 M4	Grid 8 0.046 M4	Grid 9 0.045 M4



0 dB = 0.047A/m

Figure 71 HAC RF H-Field WCDMA Band V Channel 4132

TA Technology (Shanghai) Co., Ltd.

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ANNEX C: E-Probe Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
S Service suisse d'étalonnage
C Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client: **TMC Beijing (Auden)**

Certificate No: **ER3-2428_Aug12**

CALIBRATION CERTIFICATE

Object: **ER3DV6 - SN:2428**

Calibration procedure(s): **QA CAL-02.v6, QA CAL-25.v4**
Calibration procedure for E-field probes optimized for close near field evaluations in air

Calibration date: **August 30, 2012**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&E critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13
Reference Probe ER3DV6	SN: 2328	11-Oct-11 (No. ER3-2328_Oct11)	Oct-12
D4E4	SN: 789	30-Jan-12 (No. D4E4-789_Jan12)	Jan-13
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

Calibrated by: **Jeton Kastrati** **Laboratory Technician** 

Approved by: **Katja Pckovic** **Technical Manager** 

Issued: August 30, 2012

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: ER3-2428_Aug12

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TA Technology (Shanghai) Co., Ltd.

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization ϕ	ϕ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\theta = 0$ for XY sensors and $\theta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart).
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; VR_{x,y,z}**: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy)**: in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

ER3DV6 – SN:2428

August 30, 2012

Probe ER3DV6

SN:2428

Manufactured: September 11, 2007
Calibrated: August 30, 2012

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.
Test Report

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ER3DV6-- SN:2428

August 30, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2428

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$)	1.50	1.57	1.84	$\pm 10.1 \%$
DCP (mV) ^b	100.9	100.7	99.6	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^c (k=2)
0	CW	0.00	X	0.00	0.00	1.00	206.3	$\pm 3.3 \%$
			Y	0.00	0.00	1.00	201.2	
			Z	0.00	0.00	1.00	209.4	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^a Numerical linearization parameter; uncertainty not required.

^c Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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Test Report

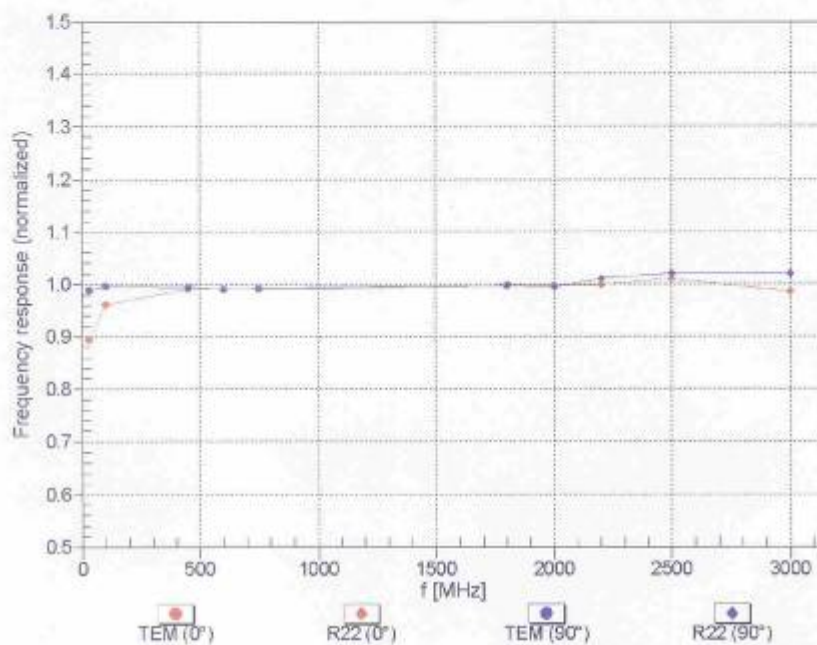
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ER3DV6-SN:2428

August 30, 2012

Frequency Response of E-Field
(TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

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Test Report

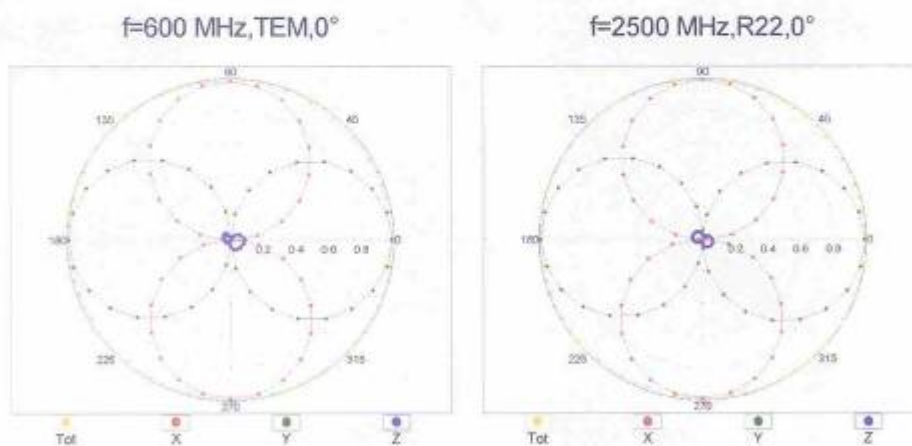
Report No. RXA1307-0086HAC01

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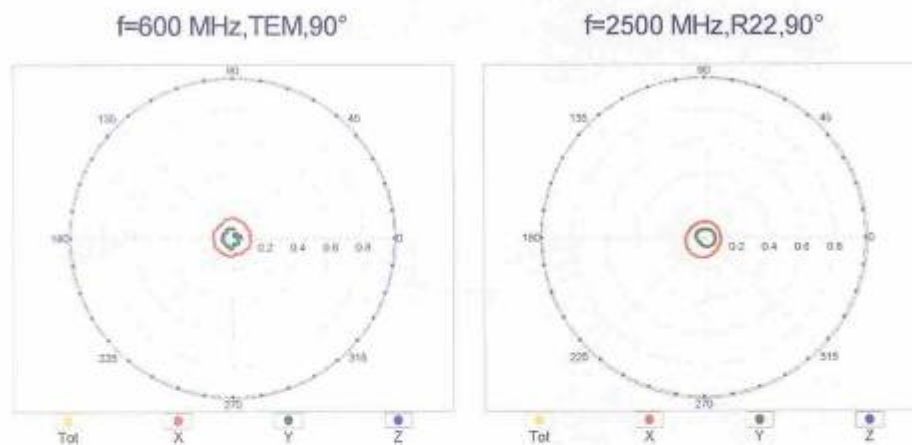
ER3DV6- SN:2428

August 30, 2012

Receiving Pattern (ϕ), $\theta = 0^\circ$



Receiving Pattern (ϕ), $\theta = 90^\circ$



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Test Report

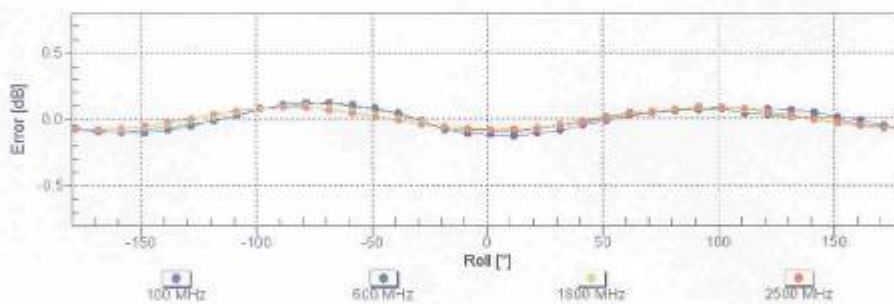
Report No. RXA1307-0086HAC01

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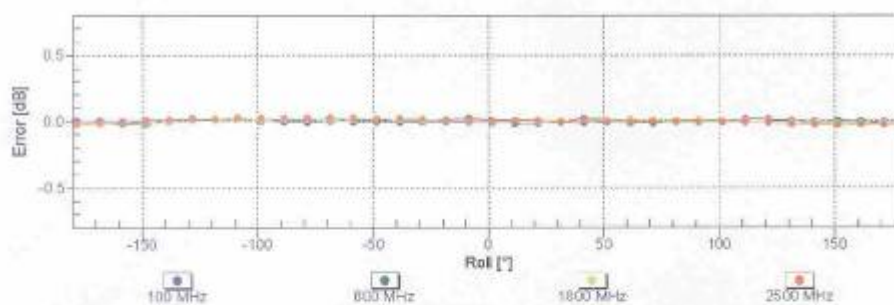
August 30, 2012

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
Test Report

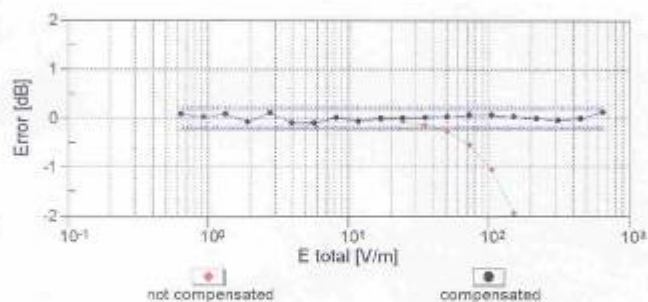
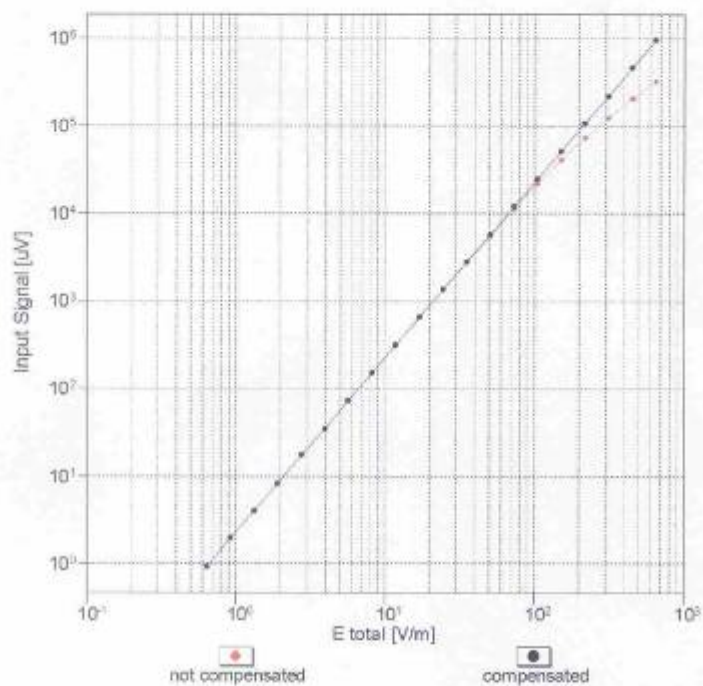
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ER3DV6-SN:2428

August 30, 2012

Dynamic Range f(E-field)
(TEM cell , f = 900 MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)

TA Technology (Shanghai) Co., Ltd.
Test Report

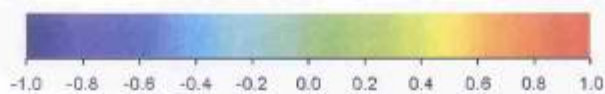
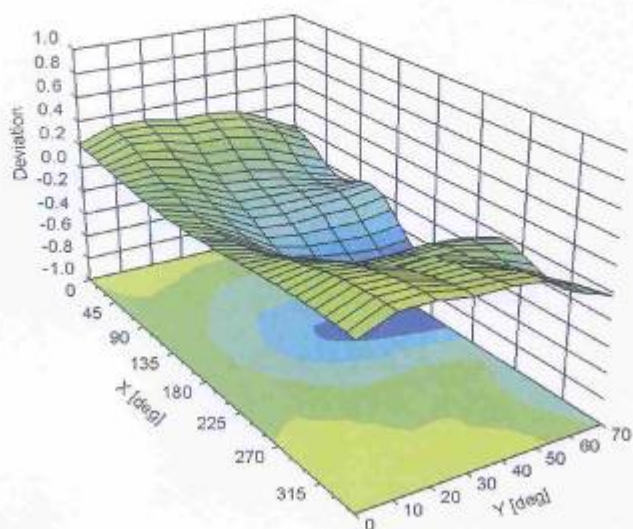
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ER3DV8-SN:2428

August 30, 2012

Deviation from Isotropy in Air
Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
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ER3DV6-- SN:2428

August 30, 2012

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2428

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	141.5
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

TA Technology (Shanghai) Co., Ltd.

Test Report

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ANNEX D: H-Probe Calibration Certificate

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland	 	S Schweizerischer Kalibrierdienst S Service suisse d'étalonnage C Servizio svizzero di taratura S Swiss Calibration Service
Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates		Accreditation No.: SCS 108
Client: TMC Beijing (Auden)	Certificate No: H3-6260_Aug12	

CALIBRATION CERTIFICATE			
Object	H3DV6 - SN:6260		
Calibration procedure(s)	QA CAL-03.v6, QA CAL-25.v4 Calibration procedure for H-field probes optimized for close near field evaluations in air		
Calibration date:	August 30, 2012		
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.			
All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.			
Calibration Equipment used (M&TE critical for calibration)			

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13
Reference Probe H3DV6	SN: 6182	11-Oct-11 (No. H3-6182_Oct11)	Oct-12
DAE4	SN: 789	30-Jan-12 (No. DAE4-789_Jan12)	Jan-13
Secondary Standards	ID	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12

Calibrated by:	Name Jeton Kastrati	Function Laboratory Technician	Signature 
Approved by:	Name Katja Pokovic	Function Technical Manager	Signature 

Issued: August 30, 2012

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: H3-6260_Aug12

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TA Technology (Shanghai) Co., Ltd.

Test Report

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary:

NORM _{x,y,z}	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.
- CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}: Assessed for E-field polarization $\vartheta = 0$ for XY sensors and $\vartheta = 90$ for Z sensor ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide).
- $X, Y, Z(f)_{a0a1a2} = X, Y, Z_{a0a1a2} \cdot \text{frequency_response}$ (see Frequency Response Chart).
- DCP_{x,y,z}: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- $A_{x,y,z}, B_{x,y,z}, C_{x,y,z}, VR_{x,y,z}$: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X_{a0a1a2} (no uncertainty required).

TA Technology (Shanghai) Co., Ltd.
Test Report

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H3DV6 – SN:6260

August 30, 2012

Probe H3DV6

SN:6260

Manufactured: September 7, 2007
Calibrated: August 30, 2012

Calibrated for DASY/EASY Systems
(Note: non-compatible with DASY2 system!)

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1307-0086HAC01

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H3DV6-SN:6260

August 30, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6260

Basic Calibration Parameters

		Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (A/m / $\sqrt{V}$ (mV))	a0	2.48E-003	2.50E-003	2.92E-003	$\pm 5.1 \%$
Norm (A/m / $\sqrt{V}$ (mV))	a1	-2.59E-005	-5.62E-006	-1.13E-005	$\pm 5.1 \%$
Norm (A/m / $\sqrt{V}$ (mV))	a2	4.45E-005	3.83E-005	5.02E-005	$\pm 5.1 \%$
DCP (mV) ^B		92.3	93.0	92.1	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dB	C dB	VR mV	Unc ^C (k=2)
0	CW	0.00	X	0.00	0.00	1.00	139.0	$\pm 2.7 \%$
			Y	0.00	0.00	1.00	136.0	
			Z	0.00	0.00	1.00	136.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^B Numerical linearization parameter; uncertainty not required.

^C Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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Test Report

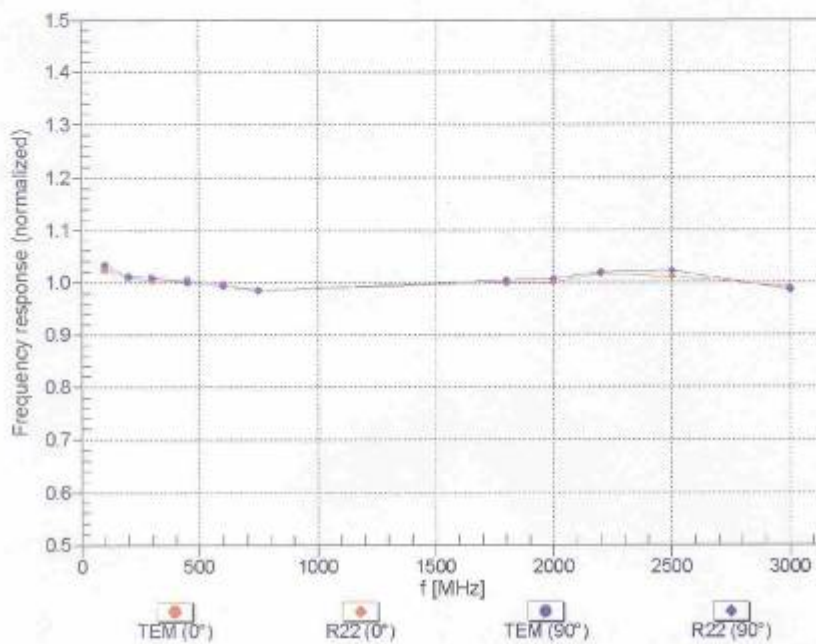
Report No. RXA1307-0086HAC01

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H3DV6- SN:6260

August 30, 2012

Frequency Response of H-Field
(TEM-Cell:ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of H-field: $\pm 6.3\%$ ($k=2$)

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Test Report

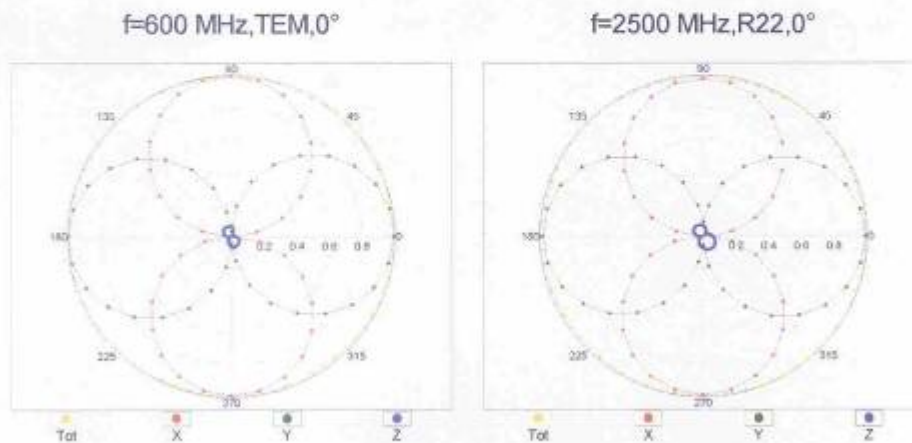
Report No. RXA1307-0086HAC01

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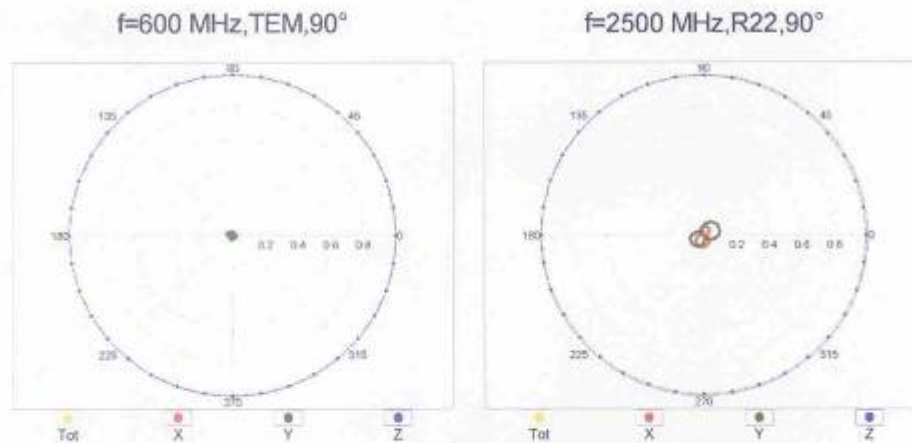
H3DV6-SN:6260

August 30, 2012

Receiving Pattern (ϕ), $\theta = 0^\circ$



Receiving Pattern (ϕ), $\theta = 90^\circ$



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Test Report

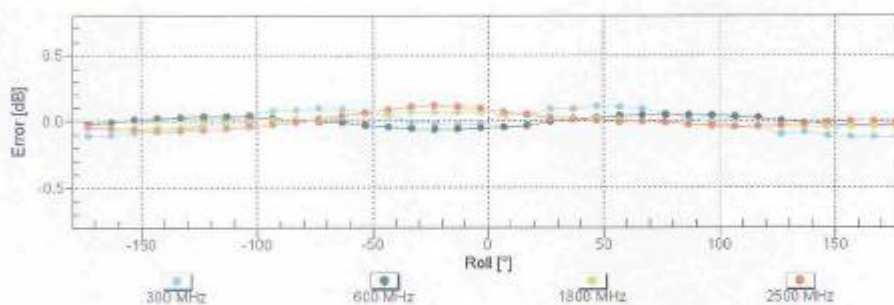
Report No. RXA1307-0086HAC01

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H3DV6-SN:6260

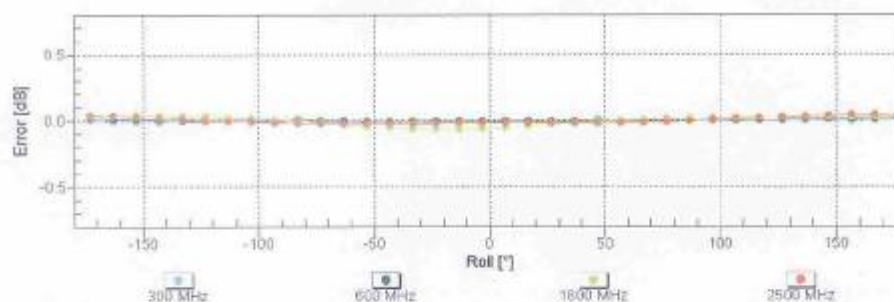
August 30, 2012

Receiving Pattern (ϕ), $\vartheta = 0^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 90^\circ$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
Test Report

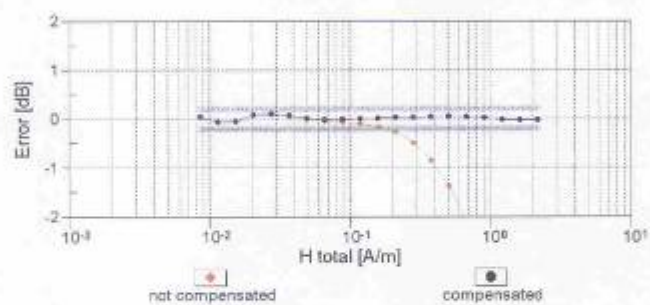
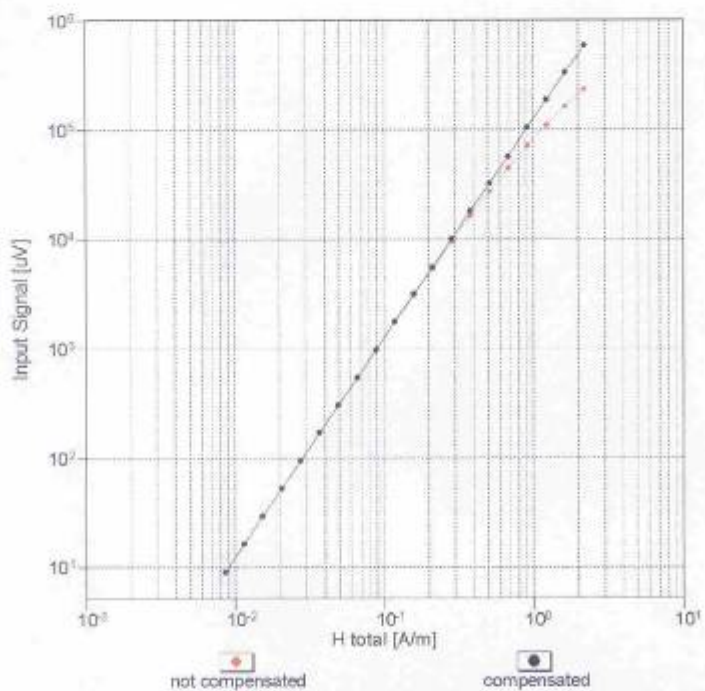
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H3DV6-SN:6260

August 30, 2012

Dynamic Range f(H-field)
(TEM cell, $f = 900$ MHz)



Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
Test Report

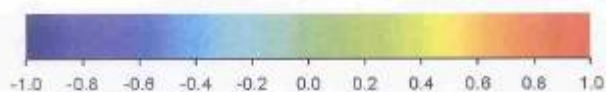
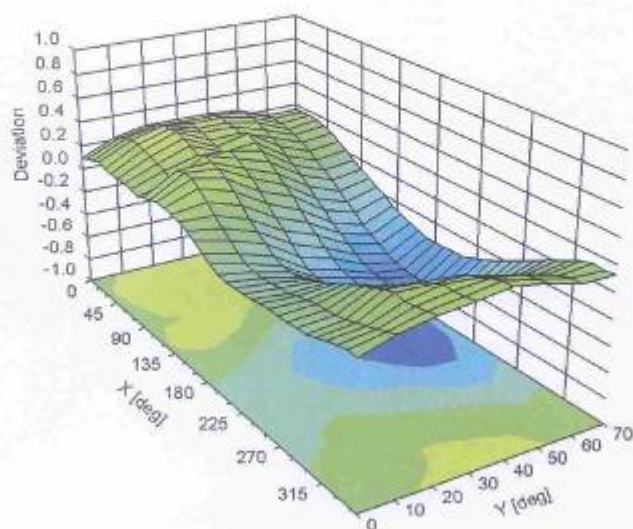
Report No. RXA1307-0086HAC01

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H3DV6-SN:6260

August 30, 2012

Deviation from Isotropy in Air
Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

TA Technology (Shanghai) Co., Ltd.
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H3DV6- SN:6260

August 30, 2012

DASY/EASY - Parameters of Probe: H3DV6 - SN:6260

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	26.8
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	20 mm
Tip Diameter	6 mm
Probe Tip to Sensor X Calibration Point	3 mm
Probe Tip to Sensor Y Calibration Point	3 mm
Probe Tip to Sensor Z Calibration Point	3 mm

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ANNEX E: CD835V3 Dipole Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client: TMC Beijing (Auden)

Certificate No: CD835V3-1023_Aug12

CALIBRATION CERTIFICATE

Object: CD835V3 - SN: 1023

Calibration procedure(s): QA CAL-20.v6
Calibration procedure for dipoles in air

Calibration date: August 30, 2012

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	05-Oct-11 (No. 217-01451)	Oct-12
Power sensor HP 8481A	US37292783	05-Oct-11 (No. 217-01451)	Oct-12
Probe ER3DV6	SN: 2336	29-Dec-11 (No. ER3-2336_Dec11)	Dec-12
Probe H3DV8	SN: 6065	29-Dec-11 (No. H3-6065_Dec11)	Dec-12
DAE4	SN: 781	29-May-12 (No. DAE4-781_May12)	May-13
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-11)	In house check: Oct-12
Power sensor HP 8482H	SN: 3318A09450	09-Oct-09 (in house check Oct-11)	In house check: Oct-12
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-11)	In house check: Oct-12
Network Analyzer HP 8753E	US37390685	18-Oct-01 (in house check Oct-11)	In house check: Oct-12
RF generator E4433B	MY 41000675	03-Nov-04 (in house check Oct-11)	In house check: Oct-13

Calibrated by:	Name Fin Bornholt	Function R&D Director	Signature
Approved by:	Katja Pokovic	Laboratory Director	

Issued: September 4, 2012

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD835V3-1023_Aug12

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Test Report

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**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
S Service suisse d'étalonnage
C Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

References

- [1] ANSI-C63.19-2007
American National Standard for Methods of Measurement of Compatibility between Wireless Communications
Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

TA Technology (Shanghai) Co., Ltd.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.2
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz $\pm$ 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.461 A / m $\pm$ 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	161.8 V / m
Maximum measured above low end	100 mW input power	159.0 V / m
Averaged maximum above arm	100 mW input power	160.4 V / m $\pm$ 12.8 % (k=2)

Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	16.2 dB	45.1 Ω - 14.1 j Ω
835 MHz	29.5 dB	49.6 Ω + 3.3 j Ω
900 MHz	16.7 dB	59.4 Ω - 13.1 j Ω
950 MHz	26.0 dB	46.0 Ω + 2.7 j Ω
960 MHz	19.3 dB	51.1 Ω + 10.9 j Ω

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

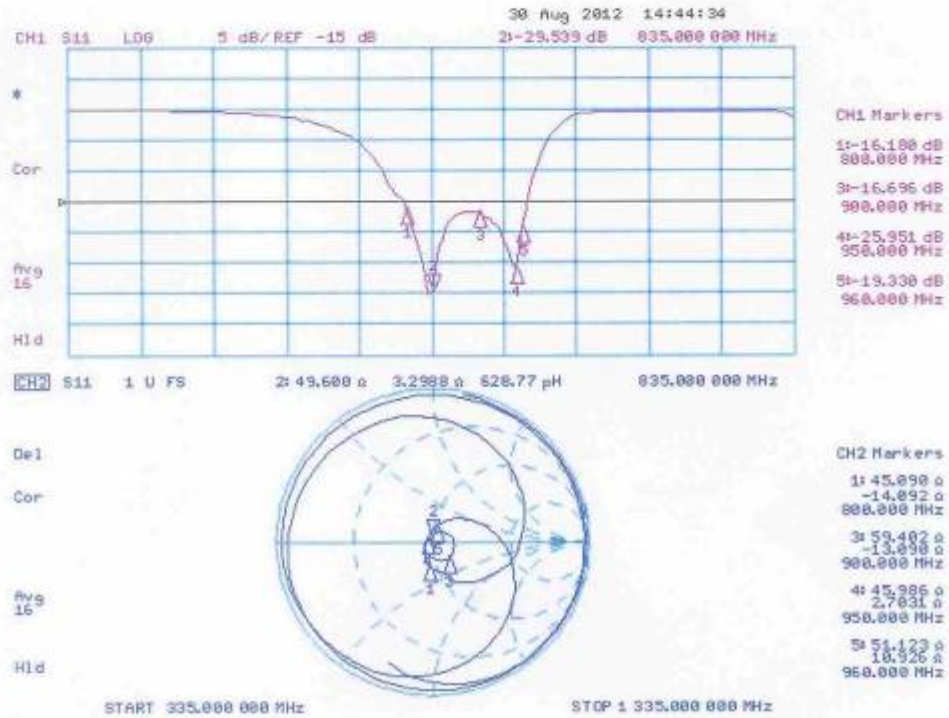
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Impedance Measurement Plot



TA Technology (Shanghai) Co., Ltd.

Test Report

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DASY5 H-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: CW; Frequency: 835 MHz

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 5n781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.49 V/m; Power Drift = 0.01 dB

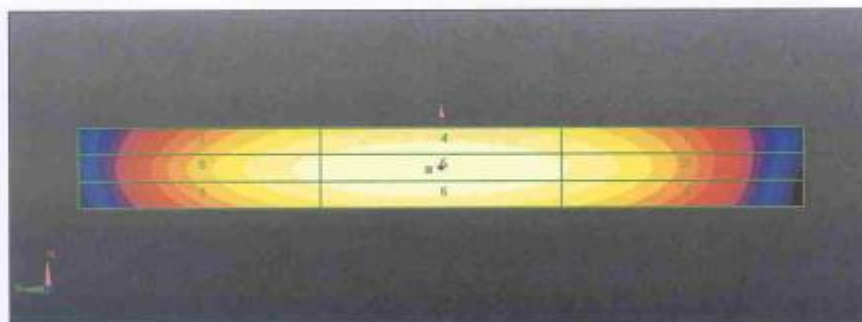
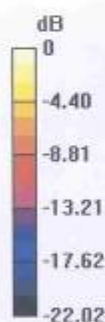
PMR not calibrated. PMF = 1.000 is applied.

H-field emissions = 0.46 A/m

Near-field category: M4 (AWF 0 dB)

PMF scaled H-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
0.38 A/m	0.40 A/m	0.38 A/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
0.43 A/m	0.46 A/m	0.44 A/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
0.39 A/m	0.42 A/m	0.40 A/m



0 dB = 0.461A/m = -6.74 dB A/m

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1307-0086HAC01

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DASY5 E-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1023

Communication System: CW; Frequency: 835 MHz

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ER30V6 - SN2336; ConvF[1, 1, 1]; Calibrated: 29.12.2011
- Sensor-Surface: {Fix Surface}
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1):

Measurement grid: dx=5mm, dy=5mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 104.0 V/m; Power Drift = -0.04 dB

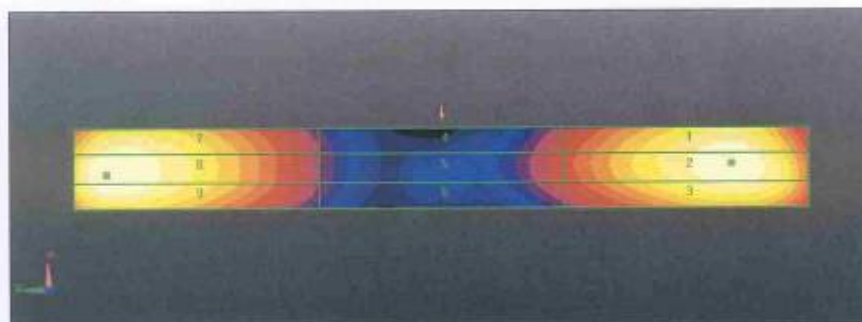
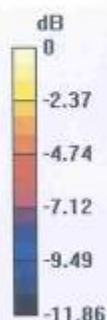
PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 161.8 V/m

Near-field category: M4 (AWF 0 dB)

PMF scaled E-field

Grid 1 M4	Grid 2 M4	Grid 3 M4
156.0 V/m	159.0 V/m	151.3 V/m
Grid 4 M4	Grid 5 M4	Grid 6 M4
87.06 V/m	88.87 V/m	85.39 V/m
Grid 7 M4	Grid 8 M4	Grid 9 M4
154.8 V/m	161.8 V/m	159.2 V/m



0 dB = 161.8V/m = 44.18 dB V/m

TA Technology (Shanghai) Co., Ltd.
Test Report

Report No. RXA1307-0086HAC01

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ANNEX F: CD1880V3 Dipole Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client TMC Beijing (Auden)

Certificate No: CD1880V3-1018_Aug12

CALIBRATION CERTIFICATE

Object CD1880V3 - SN: 1018

Calibration procedure(s) QA CAL-20.v6
Calibration procedure for dipoles in air

Calibration date: August 30, 2012

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	05-Oct-11 (No. 217-01451)	Oct-12
Power sensor HP 8481A	US37292783	05-Oct-11 (No. 217-01451)	Oct-12
Probe ER3DV6	SN: 2336	29-Dec-11 (No. ER3-2336_Dec11)	Dec-12
Probe H3DV6	SN: 6065	29-Dec-11 (No. H3-6065_Dec11)	Dec-12
DAE4	SN: 781	29-May-12 (No. DAE4-781_May12)	May-13
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-11)	In house check: Oct-12
Power sensor HP 8482H	SN: 3316A09450	09-Oct-09 (in house check Oct-11)	In house check: Oct-12
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-11)	In house check: Oct-12
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-11)	In house check: Oct-12
RF generator E4433B	MY 4100675	03-Nov-04 (in house check Oct-11)	In house check: Oct-13

	Name	Function	Signature
Calibrated by:	Fin Bornholt	R&D Director	
Approved by:	Katja Pokovic	Laboratory Director	

Issued: September 4, 2012

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: CD1880V3-1018_Aug12

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

References

- [1] ANSI-C63.19-2007
American National Standard for Methods of Measurement of Compatibility between Wireless Communications
Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- **Coordinate System:** y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- **Measurement Conditions:** Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- **Antenna Positioning:** The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- **Feed Point Impedance and Return Loss:** These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- **E-field distribution:** E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- **H-field distribution:** H-field is measured with an isotropic H-field probe with 100mW forward power to the antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the feed point.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1307-0086HAC01

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.2
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880 MHz $\pm$ 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1880 MHz

H-field 10 mm above dipole surface	condition	interpolated maximum
Maximum measured	100 mW input power	0.463 A / m $\pm$ 8.2 % (k=2)

E-field 10 mm above dipole surface	condition	Interpolated maximum
Maximum measured above high end	100 mW input power	139.0 V / m
Maximum measured above low end	100 mW input power	138.8 V / m
Averaged maximum above arm	100 mW input power	138.9 V / m $\pm$ 12.8 % (k=2)

Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
1730 MHz	27.8 dB	52.8 Ω + 3.1 j Ω
1880 MHz	21.7 dB	49.4 Ω + 8.2 j Ω
1900 MHz	22.2 dB	51.6 Ω + 7.7 j Ω
1950 MHz	30.1 dB	52.3 Ω + 2.3 j Ω
2000 MHz	20.7 dB	42.8 Ω + 4.7 j Ω

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth. The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals. Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

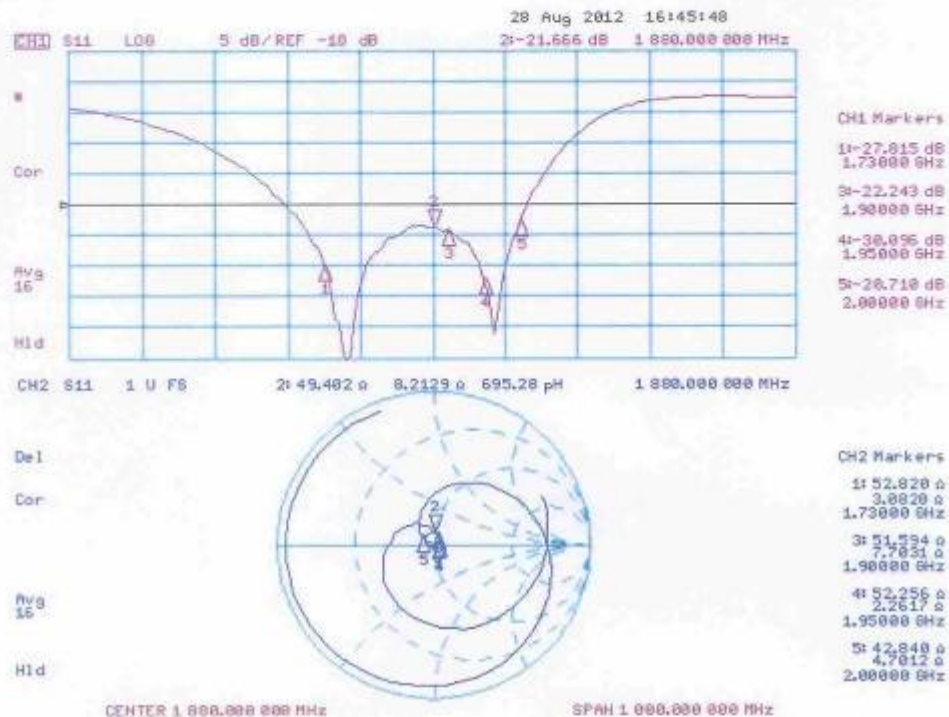
After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

TA Technology (Shanghai) Co., Ltd. Test Report

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Impedance Measurement Plot



TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1307-0086HAC01

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DASY5 H-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: CW; Frequency: 1880 MHz

Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³

Phantom section: RF Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 - SN6065; ; Calibrated: 29.12.2011
- Sensor-Surface: {Fix Surface}
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dipole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 0.49 V/m; Power Drift = 0.03 dB

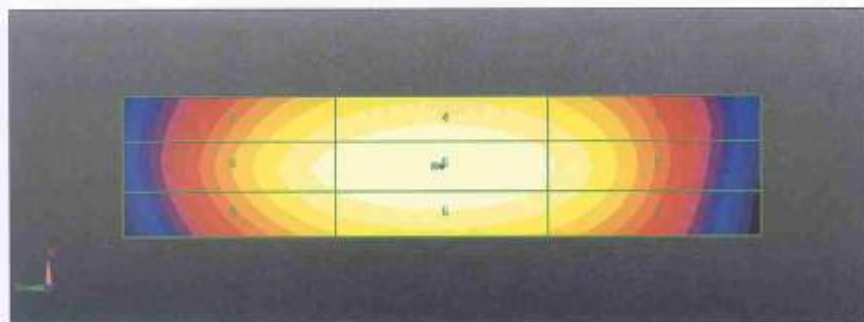
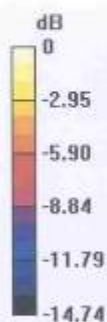
PMR not calibrated, PMF = 1.000 is applied.

H-field emissions = 0.46 A/m

Near-field category: M2 (AWF 0 dB)

PMF scaled H-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
0.40 A/m	0.42 A/m	0.40 A/m
Grid 4 M2	Grid 5 M2	Grid 6 M2
0.44 A/m	0.46 A/m	0.44 A/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
0.40 A/m	0.43 A/m	0.41 A/m



0 dB = 0.463A/m = -6.74 dB A/m

TA Technology (Shanghai) Co., Ltd.

Test Report

Report No. RXA1307-0086HAC01

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DASY5 E-field Result

Date: 30.08.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1018

Communication System: CW; Frequency: 1880 MHz
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ER3DV6 - SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 29.05.2012
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.2(969); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1):

Measurement grid: dx=5mm, dy=5mm

Device Reference Point: 0, 0, -6.3 mm

Reference Value = 156.8 V/m; Power Drift = 0.01 dB

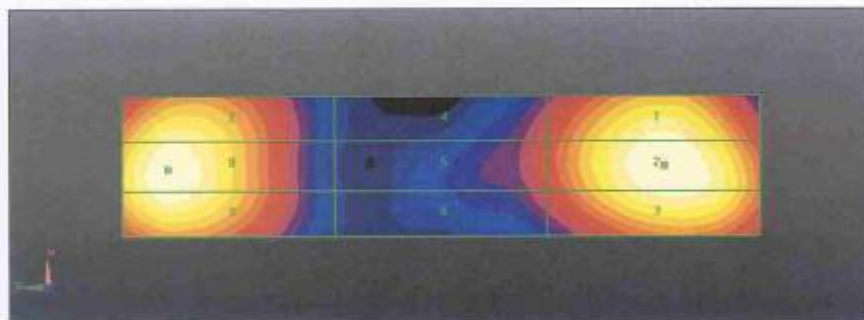
PMR not calibrated. PMF = 1.000 is applied.

E-field emissions = 139.0 V/m

Near-field category: M2 (AWF 0 dB)

PMF scaled E-field

Grid 1 M2	Grid 2 M2	Grid 3 M2
135.0 V/m	138.8 V/m	134.4 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
91.42 V/m	93.60 V/m	89.22 V/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
130.8 V/m	139.0 V/m	136.3 V/m



0 dB = 139.0V/m = 42.86 dB V/m

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ANNEX G: DAE4 Calibration Certificate

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

Accreditation No.: **SCS 108**

The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Client **TA Shanghai (Auden)**

Certificate No: **DAE4-1317_Jan13**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BJ - SN: 1317**

Calibration procedure(s) **QA CAL-06.v25**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **January 25, 2013**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	02-Oct-12 (No:12728)	Oct-13
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	07-Jan-13 (in house check)	In house check: Jan-14
Calibrator Box V2.1	SE UMS 006 AA 1002	07-Jan-13 (in house check)	In house check: Jan-14

Calibrated by:	Name R. Mayoraz	Function Technician	Signature
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Approved by:	Name Fin Bornholt	Function Deputy Technical Manager	Signature
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Issued: January 25, 2013

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- **DC Voltage Measurement:** Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- **Connector angle:** The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - **DC Voltage Measurement Linearity:** Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - **Common mode sensitivity:** Influence of a positive or negative common mode voltage on the differential measurement.
 - **Channel separation:** Influence of a voltage on the neighbor channels not subject to an input voltage.
 - **AD Converter Values with inputs shorted:** Values on the internal AD converter corresponding to zero input voltage
 - **Input Offset Measurement:** Output voltage and statistical results over a large number of zero voltage measurements.
 - **Input Offset Current:** Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - **Input resistance:** Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - **Low Battery Alarm Voltage:** Typical value for information. Below this voltage, a battery alarm signal is generated.
 - **Power consumption:** Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV
Low Range: 1LSB = 61nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.011 $\pm$ 0.02% (k=2)	404.006 $\pm$ 0.02% (k=2)	403.901 $\pm$ 0.02% (k=2)
Low Range	3.98819 $\pm$ 1.55% (k=2)	3.99805 $\pm$ 1.55% (k=2)	3.98192 $\pm$ 1.55% (k=2)

Connector Angle

Connector Angle to be used in DASY system	117 ° $\pm$ 1 °
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Appendix

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	199994.16	-0.78	-0.00
Channel X	+ Input	20000.75	0.37	0.00
Channel X	- Input	-19997.98	2.89	-0.01
Channel Y	+ Input	199995.20	0.02	0.00
Channel Y	+ Input	19999.08	-1.15	-0.01
Channel Y	- Input	-20002.66	-1.66	0.01
Channel Z	+ Input	199994.67	-0.43	-0.00
Channel Z	+ Input	19997.92	-2.31	-0.01
Channel Z	- Input	-20000.66	0.26	-0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2001.23	0.59	0.03
Channel X	+ Input	201.53	0.55	0.28
Channel X	- Input	-198.20	0.62	-0.31
Channel Y	+ Input	2000.33	-0.29	-0.01
Channel Y	+ Input	200.43	-0.68	-0.34
Channel Y	- Input	-199.64	-0.69	0.35
Channel Z	+ Input	2000.78	0.22	0.01
Channel Z	+ Input	200.32	-0.69	-0.34
Channel Z	- Input	-199.27	-0.35	0.18

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-23.69	-25.75
	- 200	28.59	26.45
Channel Y	200	-1.44	-1.70
	- 200	-0.06	-0.16
Channel Z	200	-10.76	-11.18
	- 200	9.82	9.91

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.52	-4.72
Channel Y	200	8.54	-	4.31
Channel Z	200	10.79	5.34	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16104	15986
Channel Y	16111	15993
Channel Z	16217	16069

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	1.28	0.53	2.45	0.33
Channel Y	-1.29	-2.89	0.51	0.58
Channel Z	-0.39	-1.47	1.06	0.37

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

ANNEX H: The EUT Appearances and Test Configuration



a: EUT



b-1: Battery 1



b-2: Battery 2

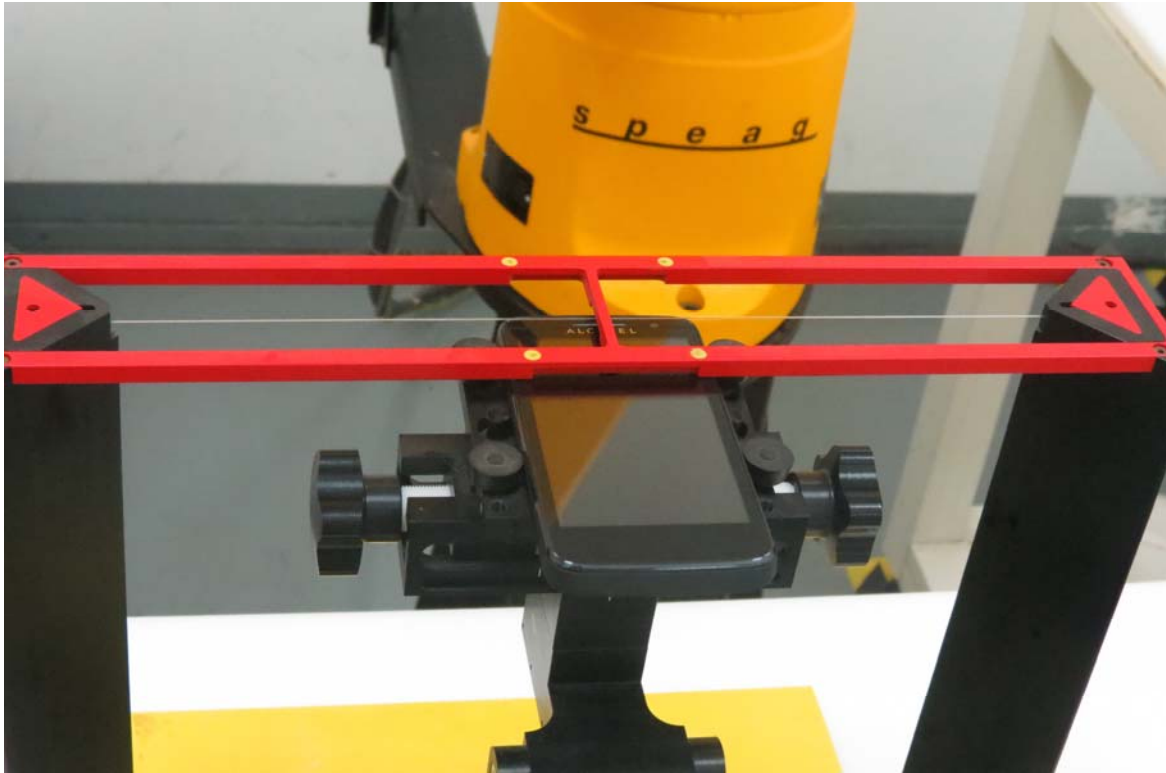
b: Battery

Picture 1: Constituents of EUT

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Picture 2: Test Setup